

Arm® Musca-B1 Test Chip and Board

Technical Reference Manual



Arm® Musca-B1 Test Chip and Board

Technical Reference Manual

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Release Information

Document History

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This device is test equipment and consequently is exempt from part 15 of the FCC Rules under section 15.103 (c).

CE Declaration of Conformity



The system should be powered down when not in use.

It is recommended that ESD precautions be taken when handling development boards.

The board generates, uses, and can radiate radio frequency energy and may cause harmful interference to radio communications. There is no guarantee that interference will not occur in a particular installation. If this equipment causes harmful interference to radio or television reception, which can be determined by turning the equipment off or on, you are encouraged to try to correct the interference by one or more of the following measures:

- Ensure attached cables do not lie across the target board.
- Reorient the receiving antenna.
- Increase the distance between the equipment and the receiver.
- Connect the equipment into an outlet on a different circuit from the receiver.
- Consult the dealer or an experienced radio/TV technician for help.

Note

It is recommended that, wherever possible, shielded interface cables be used.

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Preface

This preface introduces the *Arm® Musca-B1 Test Chip and Board Technical Reference Manual*.

It contains the following:

- *About this book* on page 7.
- *Feedback* on page 10.

About this book

This book describes the Arm® Musca-B1 test chip and board.

Intended audience

This book is written for experienced hardware and software developers to enable low-power, secure *Internet of Things* (IoT) endpoint development using the Musca-B1 test chip and board.

Using this book

This book is organized into the following chapters:

Chapter 1 Introduction

This chapter introduces the Musca-B1 test chip and Musca-B1 board.

Chapter 2 Hardware description

This chapter describes the Musca-B1 board and Musca-B1 test chip.

Chapter 3 Programmers model

This chapter describes the programmers model of the Musca-B1 test chip and board.

Appendix A Signal descriptions

This appendix describes the signals that are present at the board interface connectors.

Appendix B Specifications

This appendix contains electrical specifications of the Musca-B1 board.

Appendix C Revisions

This appendix describes the technical changes between released issues of this book.

Glossary

The Arm® Glossary is a list of terms used in Arm documentation, together with definitions for those terms. The Arm Glossary does not contain terms that are industry standard unless the Arm meaning differs from the generally accepted meaning.

See the [Arm® Glossary](#) for more information.

Typographic conventions

italic

Introduces special terminology, denotes cross-references, and citations.

bold

Highlights interface elements, such as menu names. Denotes signal names. Also used for terms in descriptive lists, where appropriate.

`monospace`

Denotes text that you can enter at the keyboard, such as commands, file and program names, and source code.

monospace

Denotes a permitted abbreviation for a command or option. You can enter the underlined text instead of the full command or option name.

`monospace italic`

Denotes arguments to monospace text where the argument is to be replaced by a specific value.

`monospace bold`

Denotes language keywords when used outside example code.

<and>

Encloses replaceable terms for assembler syntax where they appear in code or code fragments.
For example:

```
MRC p15, 0, <Rd>, <CRn>, <CRm>, <Opcode_2>
```

SMALL CAPITALS

Used in body text for a few terms that have specific technical meanings, that are defined in the *Arm® Glossary*. For example, IMPLEMENTATION DEFINED, IMPLEMENTATION SPECIFIC, UNKNOWN, and UNPREDICTABLE.

Timing diagrams

The following figure explains the components used in timing diagrams. Variations, when they occur, have clear labels. You must not assume any timing information that is not explicit in the diagrams.

Shaded bus and signal areas are undefined, so the bus or signal can assume any value within the shaded area at that time. The actual level is unimportant and does not affect normal operation.

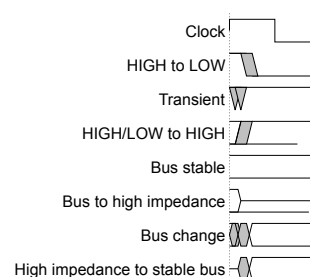


Figure 1 Key to timing diagram conventions

Signals

The signal conventions are:

Signal level

The level of an asserted signal depends on whether the signal is active-HIGH or active-LOW.
Asserted means:

- HIGH for active-HIGH signals.
- LOW for active-LOW signals.

Lowercase n

At the start or end of a signal name, n denotes an active-LOW signal.

Additional reading

This book contains information that is specific to this product. See the following documents for other relevant information:

Arm publications

- *Arm® Musca-B1 Test Chip and Board Technical Overview* (101311).
- *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Overview* (101123).
- *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual* (101104).
- *Arm® CoreLink™ SIE-200 System IP for Embedded Technical Reference Manual* (DDI 0571).
- *Arm® Cortex®-M System Design Kit Technical Reference Manual* (DDI 0479).
- *Arm® Cortex®-M33 Processor Technical Reference Manual* (100230).
- *PrimeCell UART (PL011) Technical Reference Manual* (DDI 0183).
- *Arm® PrimeCell Real Time Clock (PL031) Technical Reference Manual* (DDI 0224).
- *CoreSight™ Components Technical Reference Manual* (DDI 0314).
- *Arm® DS-5 Arm DSTREAM User Guide* (DUI 0481).
- *Arm® DS-5 Using the Debug Hardware Configuration Utilities* (DUI 0498).

The following confidential books are only available to licensees or require registration with Arm:

- *Arm® CryptoCell-312 Technical Reference Manual* (100774).
- *Arm® CryptoIsland-300 Technical Reference Manual* (101119).
- *Arm® v7-M Architecture Reference Manual* (DDI 0403).
- *Arm® AMBA® 5 AHB Protocol Specification* (IHI 0033).
- *Arm® AMBA® APB Protocol Specification Version 2.0* (IHI 0024).

Feedback

Feedback on this product

If you have any comments or suggestions about this product, contact your supplier and give:

- The product name.
- The product revision or version.
- An explanation with as much information as you can provide. Include symptoms and diagnostic procedures if appropriate.

Feedback on content

If you have comments on content then send an e-mail to errata@arm.com. Give:

- The title *Arm Musca-B1 Test Chip and Board Technical Reference Manual*.
- The number 101312_0000_01_en.
- If applicable, the page number(s) to which your comments refer.
- A concise explanation of your comments.

Arm also welcomes general suggestions for additions and improvements.

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Chapter 1

Introduction

This chapter introduces the Musca-B1 test chip and Musca-B1 board.

It contains the following sections:

- [*1.1 Precautions*](#) on page 1-12.
- [*1.2 About the Musca-B1 test chip and board*](#) on page 1-13.
- [*1.3 Location of components*](#) on page 1-14.

1.1 Precautions

This section describes precautions that ensure safety and prevent damage to your Musca-B1 board.

This section contains the following subsections:

- [1.1.1 Ensuring safety on page 1-12.](#)
- [1.1.2 Operating temperature on page 1-12.](#)
- [1.1.3 Preventing damage on page 1-12.](#)

1.1.1 Ensuring safety

The Musca-B1 board operates at 5V supplied through the DAPLink 5V USB connector.

———— **Warning** ————

Do not use the Musca-B1 board near equipment that is sensitive to electromagnetic emissions, for example, medical equipment.

—————

1.1.2 Operating temperature

The Musca-B1 board has been tested in the temperature range 15°C-30°C.

1.1.3 Preventing damage

The Musca-B1 board is intended for use within a laboratory or engineering development environment.

———— **Caution** ————

To avoid damage to the Musca-B1 board, observe the following precautions:

- Never subject the board to high electrostatic potentials. Observe *ElectroStatic Discharge* (ESD) precautions when handling any board.
 - Always wear a grounding strap when handling the board.
 - Only hold the board by the edges.
 - Avoid touching the component pins or any other metallic element.
 - Do not fit an Arduino Expansion Shield while the Musca-B1 board is powered up.
-

1.2 About the Musca-B1 test chip and board

The Musca-B1 board is a development system that demonstrates the foundation of single-chip secure *Internet of Things* (IoT) endpoints.

Purposes of the Musca-B1 test chip and board

The Arm Musca-B1 board provides access to the Arm Musca-B1 test chip that implements the Arm CoreLink SSE-200 Subsystem for Embedded product.

Major components and systems

The system enables development and evaluation of custom software on the Musca-B1 test chip. The board and Musca-B1 test chip provide the following main features:

- Musca-B1 test chip that includes, but is not limited to, the following:
 - CoreLink SSE-200 subsystem that contains two Arm Cortex-M33 processors.
 - Peripheral and Arduino Expansion Shield interfaces.
- On-board DAPLink that provides the following access:
 - *Serial Wire Debug* (SWD).
 - *USB Mass Storage Device* (USBMSD) for uploading new firmware.
 - USB serial port. The UART on the Musca-B1 test chip does not support hardware flow control.
 - Remote reset.
- On-board:
 - 3-axis orientation and motion sensor (gyro sensor).
 - Temperature sensor/ADC/DAC.
 - *Quad Serial Peripheral Interface* (QSPI) 8MB boot flash.
 - *Secure Digital I/O* (SDIO) microSD card.
- P-JTAG processor debug, 4-bit trace, and SWD header.
- User RGB LED, status LEDs, user reset, and ON/OFF push buttons.
- The board is powered from USB 5V power or Li-ion rechargeable battery backup, battery not supplied, selectable by a slider switch.
- Headers for Arduino Expansion Shield to support development of custom designs:
 - 16 3V3 GPIO.
 - UART. No hardware flow control.
 - SPI, master only.
 - I²C, master only.
 - I²S three-channel, master only.
 - 3-channel *Pulse Width Modulation* (PWM).
 - 6-channel analog interface from the on-board combined ADC, DAC, and GPIO.

1.3 Location of components

The following figure shows the physical layout of the upper face of the Musca-B1 board.

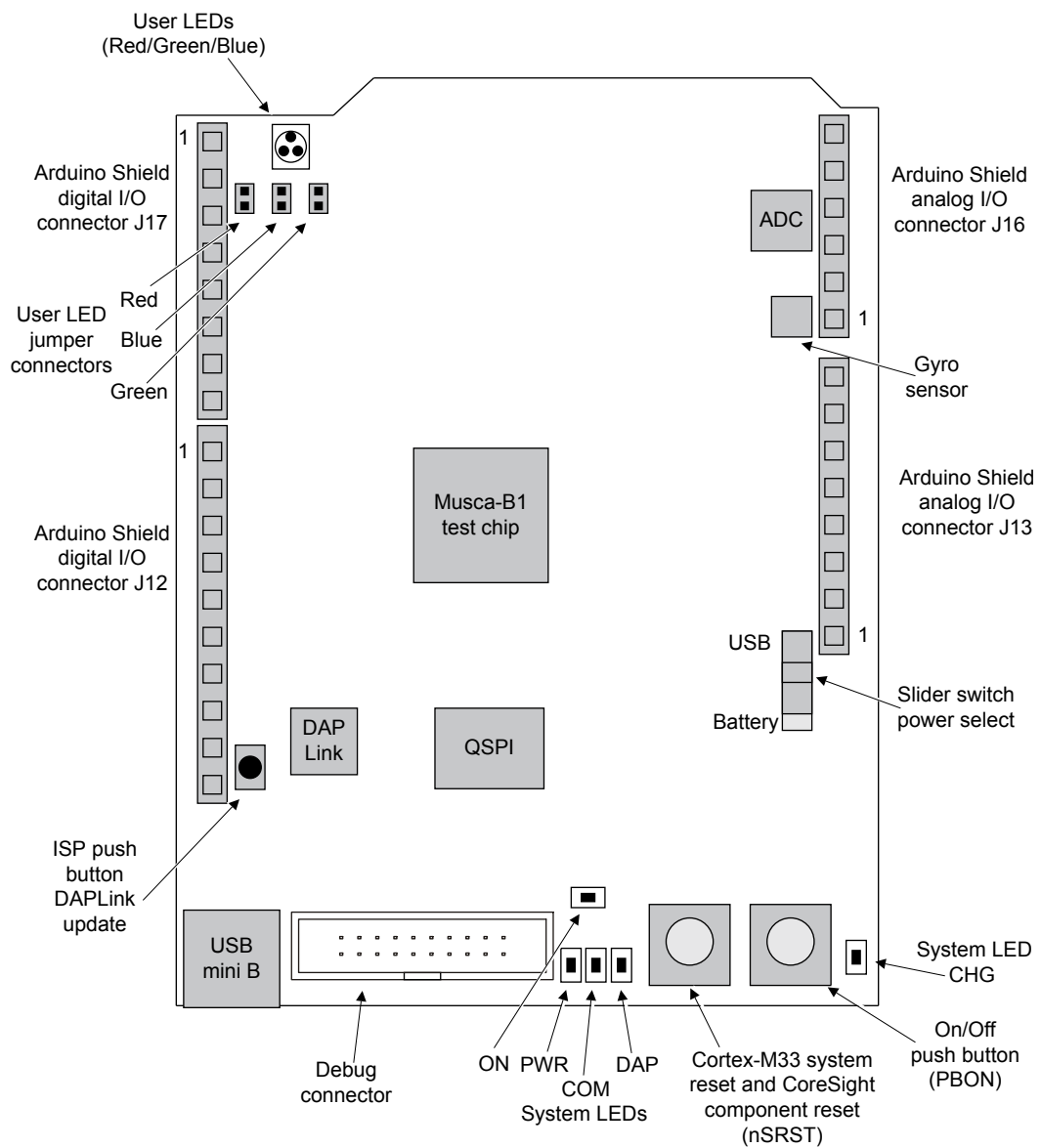


Figure 1-1 Layout of the upper face of the Musca-B1 board

The following figure shows the physical layout of the lower face of the Musca-B1 board.

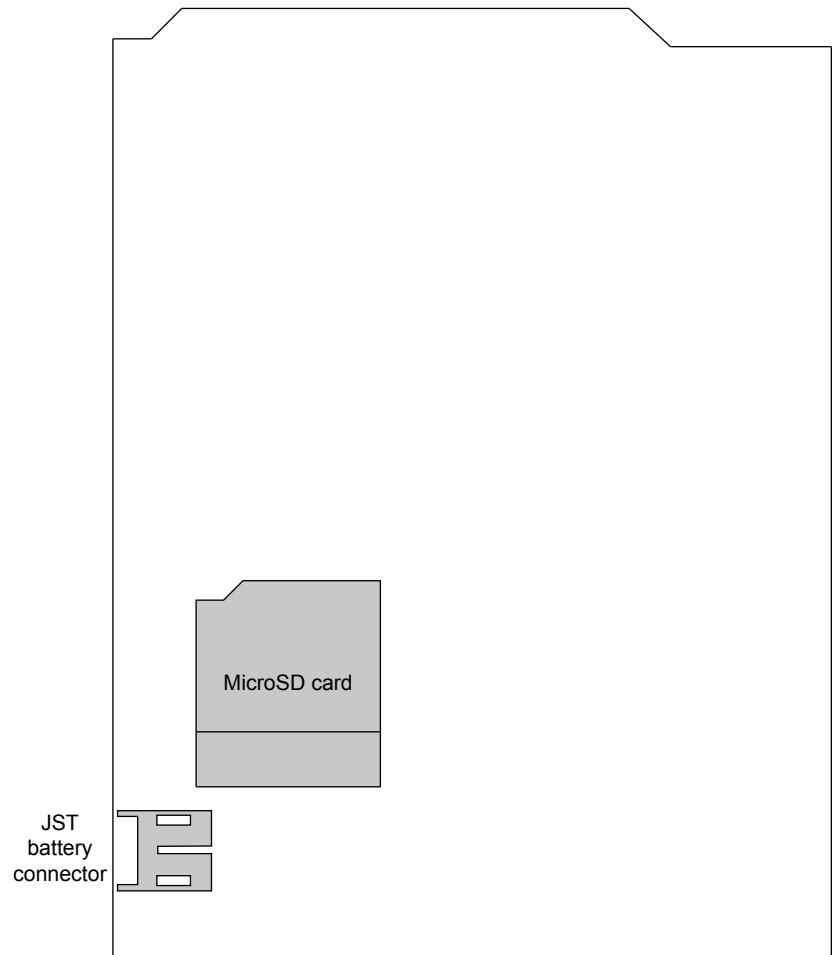


Figure 1-2 Layout of the lower face of the Musca-B1 board

Chapter 2

Hardware description

This chapter describes the Musca-B1 board and Musca-B1 test chip.

It contains the following sections:

- [2.1 Board hardware on page 2-17.](#)
- [2.2 Musca-B1 test chip on page 2-20.](#)
- [2.3 Software, firmware, board, and tools setup on page 2-27.](#)
- [2.4 PVT sensors on page 2-29.](#)
- [2.5 User components and status LEDs on page 2-31.](#)
- [2.6 Clocks on page 2-32.](#)
- [2.7 CryptoCell-312 and CryptoIsland-300 subsystems on page 2-36.](#)
- [2.8 Resets and powerup on page 2-37.](#)
- [2.9 Power on page 2-38.](#)
- [2.10 I²C interfaces and sensors on page 2-40.](#)
- [2.11 microSD and debug interfaces on page 2-41.](#)
- [2.12 Arduino Expansion Shield interface on page 2-42.](#)
- [2.13 Boot memory on page 2-44.](#)
- [2.14 DAPLink controller on page 2-45.](#)
- [2.15 Debug on page 2-46.](#)

2.1 Board hardware

The hardware infrastructure of the Musca-B1 board provides access to the Musca-B1 test chip and supports Arduino Shield expansion.

Overview of the Musca-B1 board hardware

The Musca-B1 test chip interfaces directly to the peripheral devices on the board, and the Shield header.

The following figure shows the hardware infrastructure of the Musca-B1 board.

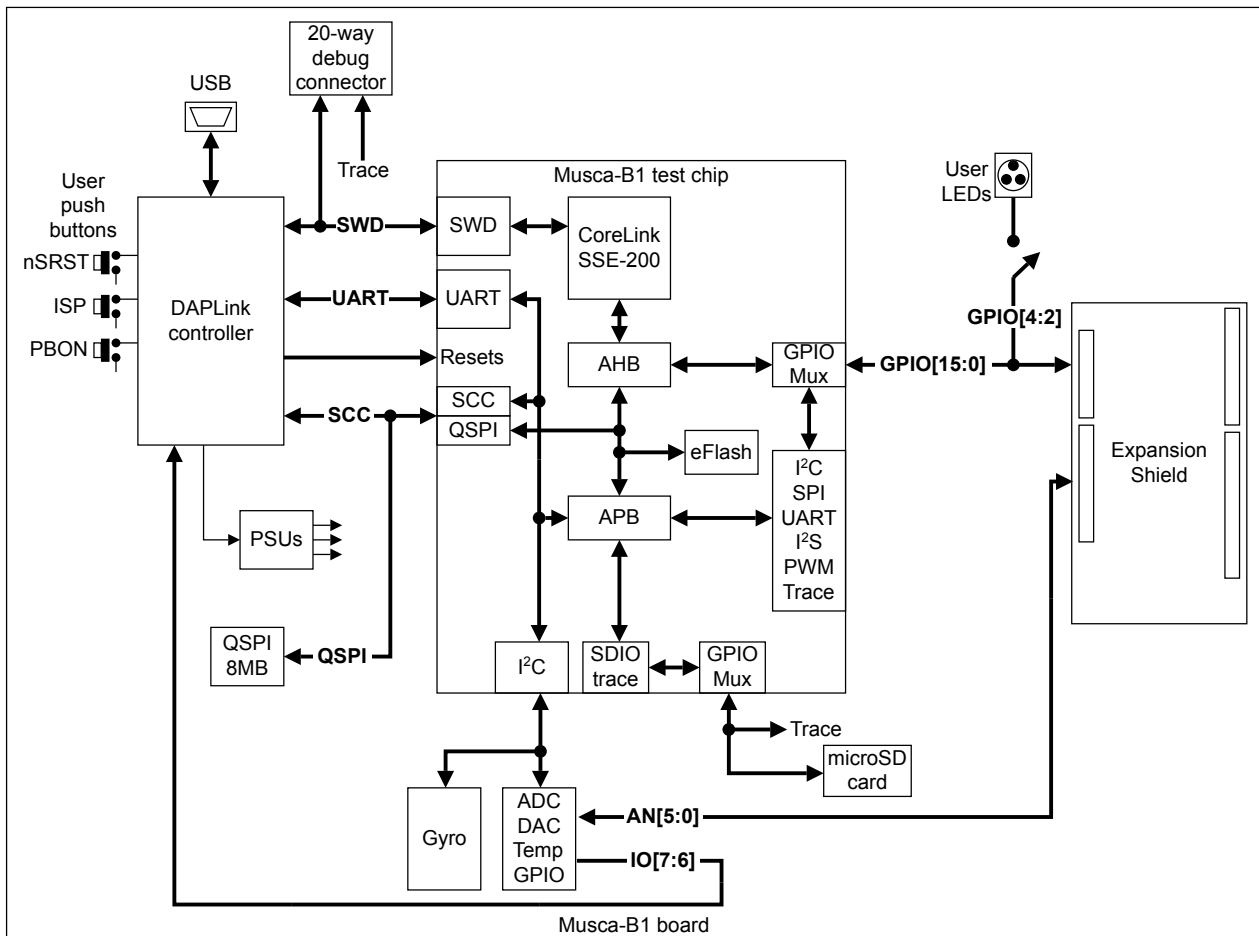


Figure 2-1 Hardware infrastructure of the Musca-B1 board

Musca-B1 board components and systems

The Musca-B1 board contains the following components and systems:

- One Musca-B1 test chip that contains a CoreLink SSE-200 Subsystem for Embedded. The SSE-200 subsystem includes, but is not limited to, the following:
 - CPU0: One Cortex-M33 processor. *Floating Point Unit* (FPU), DSP, no coprocessor.
 - CPU1: One Cortex-M33 processor. FPU, DSP, no coprocessor.
 - Two 2KB instruction caches, one for each processor.
 - 4 × 128KB SRAM. One bank of SRAM functions as *Tightly-Coupled Memory* (TCM), Tightly-Coupled to CPU1.
 - Arm CryptoCell-312.
 - Timer, Watchdog peripherals, and system control.
- Arduino Shield Expansion to enable custom designs by providing the following interfaces:

- UART. The UART on the Musca-B1 test chip does not support hardware flow control.
- I²S, three-channel, master only.
- SPI, master only.
- I²C, master only.
- PWM.
- 6-channel analog interface from the on-board combined ADC, DAC, and GPIO.
- 16 3V3 GPIO.
- On-board DAPLink that enables the following functionality over USB:
 - *Serial Wire Debug* (SWD).
 - *USB Mass Storage Device* (USBMSD) for uploading new firmware.
 - USB serial port. The UART on the Musca-B1 test chip does not support hardware flow control.
 - Remote reset.
- On-board gyro sensor:
 - MMA7660FC 3-axis orientation and motion detection sensor.
 - I²C interface to Musca-B1 test chip.
- On-board combined ADC/DAC/temperature sensor:
 - AD5593.
 - 6-channel 3V3 ADC/DAC/GPIO interface to Arduino Shield.
 - Temperature indicator.
- Programmable boot select:
 - 512KB on-chip system memory SRAM.
 - 8MB On-board QSPI boot flash.
 - Two 2MB on-chip boot eFlash.
 - Both Secure and Non-secure access.
- Debug connector that provides access to:
 - P-JTAG processor debug.
 - *Serial Wire Debug* (SWD).
 - 4-bit trace.
- User push-button:
 - PBON On/Off push-button.
 - nSRST: Cortex-M33 system reset and CoreSight component reset.
 - ISP: Updates DAPLink firmware.
- RGB LED. Jumper connectors provide optional connections between the Arduino Expansion header and the Musca-B1 test chip:
 - Red LED connected to GPIO[2] pin, optional PWM0.
 - Green LED connected to GPIO[3] pin, optional PWM1.
 - Blue LED connected to GPIO[4] pin, optional PWM2.
- Status LEDs.
- 5V USB or battery power, selectable by slider switch:
 - DAPLink 5V USB connector.
 - CLN 523450, Lithium Ion, 3.7V, 950mAh, not supplied.

Multiplexed Musca-B1 test chip I/O

The following Musca-B1 test chip signals are multiplexed I/O:

- All connections to the Arduino Expansion Shield.
- microSD card and trace signals.
- UART to the DAPLink controller. The UART on the Musca-B1 test chip does not support hardware flow control.
- QSPI.
- I²C to the ADC/DAC temperature sensor.

The IOMUX registers control the multiplexed I/O. Some pairs of functions are not simultaneously available and the IOMUX registers must select one function from each of the following:

- microSD or trace.
- I²S or PWM to the Arduino Expansion Shield.
- SPI, available as master only, or UART to the Arduino Expansion Shield.

See the following for information on how to select the required functions at the Musca-B1 test chip I/O pins.

- [2.2.2 Test chip multiplexed I/O on page 2-23.](#)
- [3.12.1 IOMUX registers on page 3-126.](#)

Related information

[1.3 Location of components on page 1-14](#)

2.2 Musca-B1 test chip

The Musca-B1 test chip is based on the SSE-200 subsystem which features two Cortex-M33 processors.

See the following documentation for more information on the SSE-200 subsystem:

- *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Overview.*
- *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual.*

This section contains the following subsections:

- [2.2.1 Overview of the Musca-B1 test chip on page 2-20.](#)
- [2.2.2 Test chip multiplexed I/O on page 2-23.](#)

2.2.1 Overview of the Musca-B1 test chip

The Musca-B1 test chip features a memory system, integrated connectivity, sensor interfaces, a clock generator, and *Serial Configuration Control* (SCC) registers for setting default powerup values.

High-level view of the Musca-B1 test chip

The following figure shows a high-level view of the architecture of the Musca-B1 test chip.

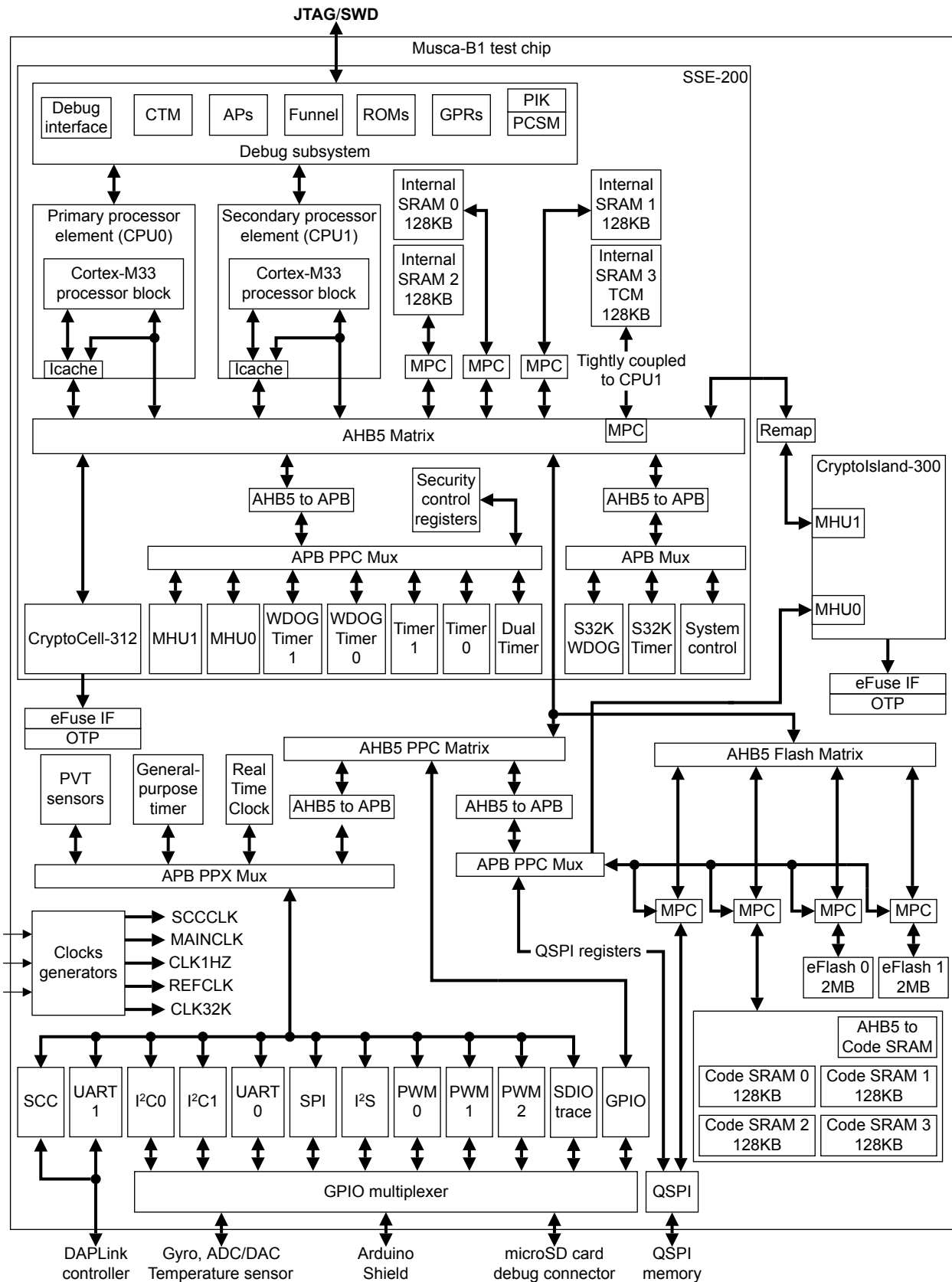


Figure 2-2 Musca-B1 test chip

Major components and systems of the Musca-B1 test chip

SSE-200 subsystem

- Two Cortex-M33 processors with FPU and DSP, and with no coprocessor:
 - CPU0: 40.96MHz maximum. Used as main processor.
 - CPU1: 163.84MHz maximum.
- Memory system:
 - Two 2KB instruction caches, one for each processor.
 - $4 \times 128\text{KB}$ SRAM. One bank of SRAM functions as *Tightly-Coupled Memory* (TCM), Tightly-Coupled to CPU1.
- CoreSight components, 4-bit trace, *Cross Trigger Interface* (CTI), and *Serial Wire Debug* (SWD).
- Secure AMBA interconnect:
 - AHB5 Bus matrix.
 - AHB5 *Exclusive Access Monitors* (EAMs).
 - AHB5 *Access Control Gates* (ACGs).
 - AHB5 to APB bridges.
 - Expansion AHB5 master and slave buses, two of each.
- Security components:
 - AHB5 TrustZone® *Memory Protection Controllers* (MPCs).
 - AHB5 TrustZone *Peripheral Protection Controllers* (PPCs).
 - CryptoCell-312.
 - *Implementation Defined Attribution Unit* (IDAU).
 - Secure and Non-secure configurable peripherals and memory access.
- Secure APB peripherals:
 - One general-purpose timer with configurable security in the **S32KCLK** domain.
 - Two general-purpose timers, Timer0 and Timer1 with configurable security, in the **SYSCLK** domain.
 - One Cortex-M System Design Kit (CMSDK) dual timer with configurable security.
 - One Secure watchdog in the **S32KCLK** domain.
 - One Secure watchdog in the **SYSCLK** domain.
 - One Non-secure watchdog in the **SYSCLK** domain.

Musca-B1 test chip outside the SSE-200 subsystem

- One CryptoIsland-300 subsystem, a security enclave module used for Secure access control.
 - 64KB RAM.
- Two 2MB *Embedded Flash* (eFlash) memories.
- 512KB Code SRAM: $4 \times 128\text{KB}$ independently power-enabled.
- Two 8KB true *One-Time Programmable* (OTP) memories:
 - One used for CryptoCell-312.
 - One used for CryptoIsland-300 secure enclave.
- One *Real Time Clock* (RTC) in the Always ON domain.
- One 32-bit general-purpose timer running at 32.768kHz with programmable interrupts.
- 16 external GPIO interrupts.
- 16 GPIO.
- Nine *Process, Voltage, and Temperature* (PVT) sensors:
 - 501-stage ring oscillators that perform boot time process measurements. Software can read data from the sensors in the sensor peripheral and group registers.
- Three-channel I²S:
 - Two master transmitters.
 - One master receiver.
- Three independent *Pulse Width Modulation* (PWM) outputs.
- Two UARTs, UART0 user, UART1 debug. The UART on the Musca-B1 test chip does not support hardware flow control.
- Two I²C:
 - I²C0. Master only.
 - I²C1. Master only to on-board interfaces.
- One SPI master interface.
- One microSD card I/O (SDIO 3.0):
 - Interface width of 4.
 - Up to SDR50.
 - No DMA support.
- One alternate function I/O multiplexer.
- One QSPI for external flash control with *Execute in Place* (XIP) capability.
- Programmable boot select:
 - eFlash 0 or eFlash 1.
 - Code SRAM.
 - External QSPI Flash.
- External powerup reset.
- Three system clock sources:
 - External **REFCLK**, 32.768kHz.
 - External **FASTCLK**, 24MHz.
 - On-chip PLL. Input 32.768kHz. Output up to 40.96MHz to primary processor, CPU0, and 163.84MHz to secondary processor, CPU1.
 - One JTAG/SWD debug port.
- One *Serial Configuration Controller* (SCC) with dual access port:
 - SCC serial during reset.
 - APB after reset.

2.2.2 Test chip multiplexed I/O

The Musca-B1 test chip contains interfaces that are multiplexed onto the Musca-B1 test chip I/O. The IOMUX registers control the GPIO multiplexer that selects the functions that appear at the Musca-B1 test chip I/O.

The IOMUX registers are part of the *Serial Configuration Control* (SCC) registers that select the ALTF1 or ALTF2 alternative I/O functions.

See [3.12.1 IOMUX registers](#) on page 3-126 for information on the Musca-B1 test chip I/O multiplexer and the IOMUX registers.

Note

The IOMUX registers select each Musca-B1 test chip I/O individually.

The following table shows the multiplexed Musca-B1 test chip I/O.

Table 2-1 Multiplexed Musca-B1 test chip I/O

Test chip pin	Primary reset or powerup	ALTF1	ALTF2	ALTF3	Destination interface	
PA0	GPIO[0]	UART0 Rx/D	Reserved	Reserved	Arduino Shield	
PA1	GPIO[1]	UART0 Tx/D				
PA2	GPIO[2]	MR_I ² S_SD				PWM0
PA3	GPIO[3]	MR_I ² S_WS	PWM1			
PA4	GPIO[4]	MR_I ² S_SCK	PWM2			
PA5	GPIO[5]	MT_I ² S_SD0	Reserved			
PA6	GPIO[6]	MT_I ² S_WSO				
PA7	GPIO[7]	MT_I ² S_SD1				
PA8	GPIO[8]	MT_I ² S1_WS1				
PA9	GPIO[9]	MT_I ² S_SCK				
PA10	GPIO[10]	SPIO nSS0				
PA11	GPIO[11]	SPIO MOSI				
PA12	GPIO[12]	SPIO MISO				
PA13	GPIO[13]	SPIO SCK	TEST_CLK			
PA14	GPIO[14]	I ² C0 Data	Reserved			
PA15	GPIO[15]	I ² C0 Clock				
PA16	UART RX	Reserved			DAPLink	
PA17	UART TX				DAPLink	
PA18	I ² C1 Data				Board I ² C	
PA19	I ² C1 Clock				Board I ² C	
PA20	QSPI_CS1				QSPI	
PA21	QSPI_D0				QSPI	
PA22	QSPI_D1				QSPI	
PA23	QSPI_D2				QSPI	
PA24	QSPI_D3				QSPI	
PA25	QSPI_SCLK				QSPI	
PA26	SD_CMD				microSD	
PA27	SD_D0				TRACE_DATA0	microSD
PA28	SD_D1				TRACE_DATA1	microSD
PA29	SD_D2				TRACE_DATA2	microSD
PA30	SD_D3	TRACE_DATA3			microSD	

Table 2-1 Multiplexed Musca-B1 test chip I/O (continued)

Test chip pin	Primary reset or powerup	ALTF1	ALTF2	ALTF3	Destination interface
PA31	SD_CLK	TRACE_CLK	Reserved	Reserved	microSD
PA32	Reserved	Reserved			Reserved
PA33					
PA34					
PA35					
PA36					
PA37					

Note

MT stands for *Master Transmitter*. MR stands for *Master Receiver*.

Related information

[3.12.1 IOMUX registers on page 3-126](#)

2.3 Software, firmware, board, and tools setup

Arm supplies software and firmware for the Musca-B1 board.

You can access software and firmware at the Arm Community pages which are accessible from <https://www.arm.com/musca>.

Setting up a project

To power the board, connect the USB port to your computer and press the PBON user push button. The DAPLink interface appears in the Windows device manager as an Mbed™ composite device, part of which is the Mbed serial port, UART. The following figure shows an example configuration that contains the Mbed composite device and the Mbed serial port.

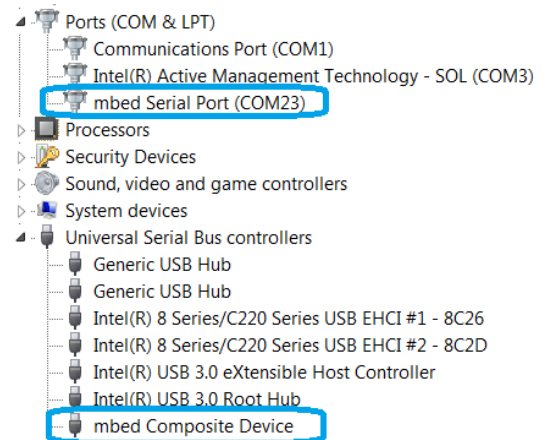


Figure 2-3 DAPLink interface

Note

Other components of the Mbed composite device are not visible in the Windows device manager. See [2.1 Board hardware on page 2-17](#) for the other components of the Mbed composite device.

The UART on the Musca-B1 test chip does not support hardware flow control.

Updating DAPLink firmware

You can update the DAPLink firmware for either QSPI or eFlash. To update the DAPLink firmware, you can use the DAPLink drag and drop update method:

1. Press and hold the ISP button while powering up the board using the USB lead.
2. Delete the `firmware.bin` file that appears in the CRP DISABLD USB drive.
3. Copy `DAPLink_QSPI_XTAL_vxx.bin` or `DAPLink_eFLASH_XTAL_vxx.bin` to the CRP DISABLD drive.

- From a Windows system, you can simply Drag and Drop the file.
- On Linux/Mac OS, use the following command:

```
dd if={new_firmware.bin} of=/Volumes/CRP\ DISABLD/firmware.bin conv=notrunc
```

4. Power cycle the board using the USB lead. Do not press the ISP button during the power cycle.

Updating the application software image

To update the application image, perform the following steps:

1. Power up the board by connecting the USB lead and pressing the PBON button.
2. Drop a .bin format software image onto the MBED drive, for example `blinky.bin`.
3. Power cycle the board or press the nSRST button to reset the system and boot from the new QSPI or eFlash software image.

Note

The file `blinky.bin` is available at the Arm Community pages which are accessible from <https://www.arm.com/musca>.

DAPLink UART setting

The default DAPLink UART setting is 115,200 baud (8N1).

Related information

[1.3 Location of components](#) on page 1-14

2.4 PVT sensors

The Musca-B1 test chip implements nine *Process, Voltage, and Temperature* (PVT) sensors to enable power and performance characterization of the SSE-200 subsystem and other integrated systems.

Main features of the PVT sensors

The PVT sensors consist of a series of 501-stage ring oscillators and associated blocks that are mapped to APB. The following figure shows a high-level view of the PVT system.

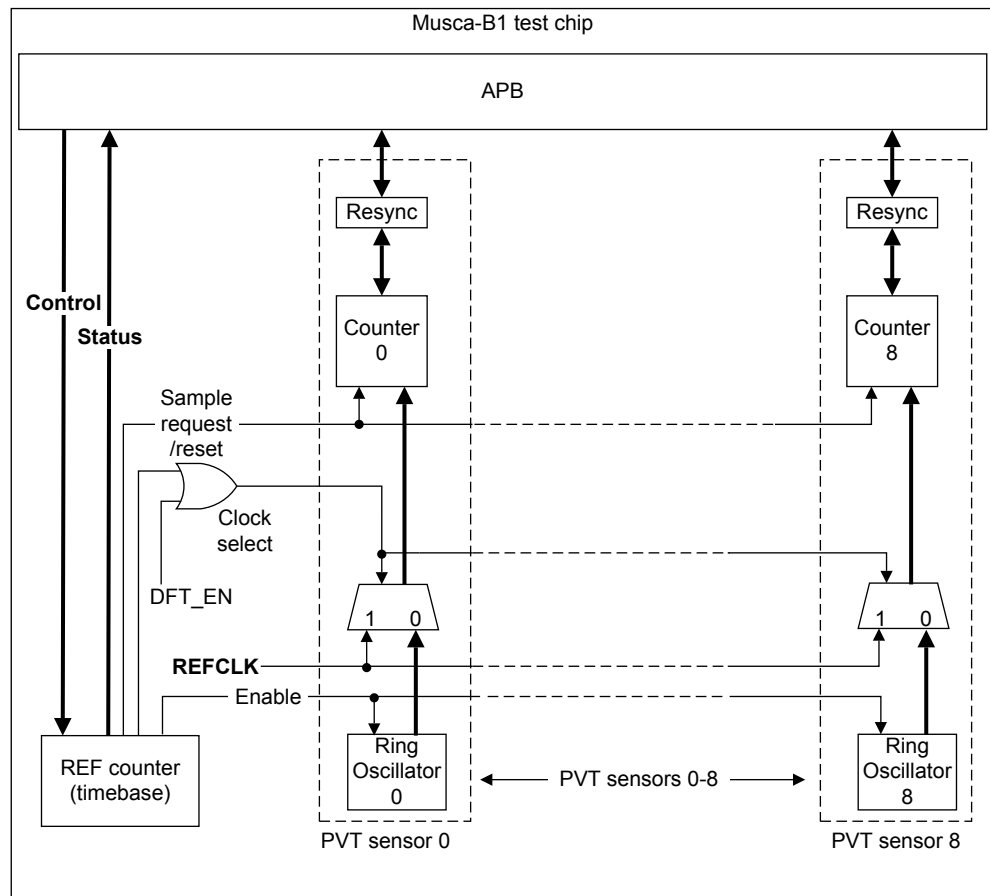


Figure 2-4 PVT sensors and system

The PVT sensor system has the following main features:

- Polling of the sensor outputs by regularly checking the status flags.
- Event mode where the REF counter interrupt signal indicates that PVT measurements are ready.
- Synchronized start and enable.
- One-shot mode, or repeat mode.
- Each sensor is controllable independently of the others.
- Built-in test infrastructure.
- DFT bypass mode.
- Overflow indicator that enables timebase tuning.

Reference counter, timebase

The reference counter initiates and controls the PVT measurements. It stores the programmed measurement time window and when the reference counter reaches the programmed value it:

- Generates an interrupt if the interrupt is enabled.
- Requests that each enabled sensor stores the number of ring oscillator pulses that it receives during the measurement window.
- Restarts the PVT counters after the sensors have stored the measurements.

The reference counter has the following operating modes:

- One-shot mode: Performs a single measurement only and then waits.
- Repeat mode: Repeats the measurements until controls signals stop them or the system is powered down.

Counter

The counters count and store the number of ring oscillator output pulses that they receive during the measurement window:

- The CTRL_ENABLE Register generates an enable signal for each sensor.
- The reference counter synchronizes the sensor counter measurement process.
- Each sensor counter has its own flags:
 - Sample flags to indicate that a new measurement value is ready.
 - Overflow to indicate that the sensor counter has reached 0xFFFF_FFFF. The overflow flag stays HIGH until the reference counter initiates a new measurement.

Ring oscillators

The ring oscillators consist of 501 inverting stages and the PVT sensor control registers can enable or disable them. The ring oscillators are built from different inverting cells, NOT, NAND, and NOR gates to represent the main cells that are available. The following table shows the ring oscillators with their sensor ID, voltage domain, and location on the die.

Table 2-2 PVT ring oscillators

Sensor ID	Cell	Voltage domain	Location X	Location Y
0	inv_svt_c50	1V1	4690.116	4661.105
1	inv_lvt_c40		4792.716	4661.105
2	inv_svt_c40		4895.316	4661.105
3	nand_svt_c50		4690.116	4714.907
4	nand_lvt_c40		4792.716	4714.907
5	nand_svt_c40		4895.316	4714.907
6	nor_svt_c50		4690.116	4768.709
7	nor_lvt_c40		4792.716	4768.709
8	nor_svt_c40		4895.316	4768.709

Controlling and reading data from the PVT sensors

Only one PVT sensor is active at any time. The PVT_CTRL Register selects the active sensor. See the following for information on how to select the active sensor:

- [3.12 Serial Configuration Control registers on page 3-126.](#)
- [PVT_CTRL Register on page 3-178.](#)

The PVT sensor control registers control and read data from the active PVT sensor. See [3.9 PVT sensor control registers on page 3-112.](#)

2.5 User components and status LEDs

The Musca-B1 board provides three user LEDs, reset and on/off push buttons, a DAPLink reset push button, a power-selector slider switch, and system status LEDs.

User LEDs

One RGB LED, which can be connected to Musca-B1 test chip GPIO[4:2] outputs by completing the user jumper connections:

- Red: Jumper J4 connects this LED to GPIO[2].
- Green: Jumper J3 connects this LED to GPIO[3].
- Blue: Jumper J2 connects this LED to GPIO[4].

Note

GPIO[4:2] are on multiplexed Musca-B1 test chip I/O pins. The I/O multiplexer selects the signals that appear on these pins. See the following for information on how to select the required functions at the Musca-B1 test chip I/O pins:

- [2.2.2 Test chip multiplexed I/O on page 2-23](#).
 - [3.12.1 IOMUX registers on page 3-126](#).
-

Power-select slider switch

Selects either USB 5V power or Li-ion 3.7V battery power:

- DAPLink 5V USB connector.
- CLN 523450, Lithium Ion, 3.7V, 950mAh, not supplied.

Status LEDs

The Musca-B1 board provides the following system status LEDs:

- PWR: Orange LED. Indicates that power is connected.
- COM: Green LED. Indicates that USB UART is active.
- DAP: Blue LED. Indicates DAP activity.
- CHRG: Orange LED. Indicates that Li-ion battery charging is in progress.
- ON: Green LED. Indicates that board power supplies are active.

User push buttons

The Musca-B1 board provides the following user push buttons:

- PBON power on/off.
- nSRST: Cortex-M33 system reset and CoreSight debug reset.
- ISP: Updates DAPLink firmware.

See [2.8 Resets and powerup on page 2-37](#) for more information on the user push buttons.

Related information

[1.3 Location of components on page 1-14](#)

[2.2.2 Test chip multiplexed I/O on page 2-23](#)

[3.12 Serial Configuration Control registers on page 3-126](#)

[2.8 Resets and powerup on page 2-37](#)

2.6 Clocks

The Musca-B1 board provides on-board clocks that drive the systems in the Musca-B1 test chip.

Overview of clock system

The on-board clocks are:

FASTCLK

24MHz on-board oscillator clock.

32K

32.768kHz from on-board crystal oscillator, the default system clock. The clock goes to a PLL in the Musca-B1 test chip and is multiplied up to drive the Cortex-M33 processors and SSE-200 subsystem.

Caution

The default processor operating frequencies are 40.96MHz for the primary processor, CPU0, and 163.84MHz for the secondary processor, CPU1. These values are the maximum operating frequencies of the processors. You must not use the SCC registers and system control registers FCLK_DIV and SYSCLK_DIV to increase the operating frequencies above these maximum values.

SCCCLK

Serial Configuration Controller (SCC) interface clock from the DAPLink.

JTAG TCK

Input clock from the debug connector to the CoreSight components on the chip.

The SCC registers select either **32K** or **FASTCLK** clocks to drive the Musca-B1 test chip. The default chip driver clock is **32K**.

The driver clock goes to an on-chip PLL and divider system. The on-chip system multiplies the clock frequency to drive the Cortex-M33 processors, the SSE-200 subsystem, and other blocks.

The following figure shows the Musca-B1 test chip and board clock system.

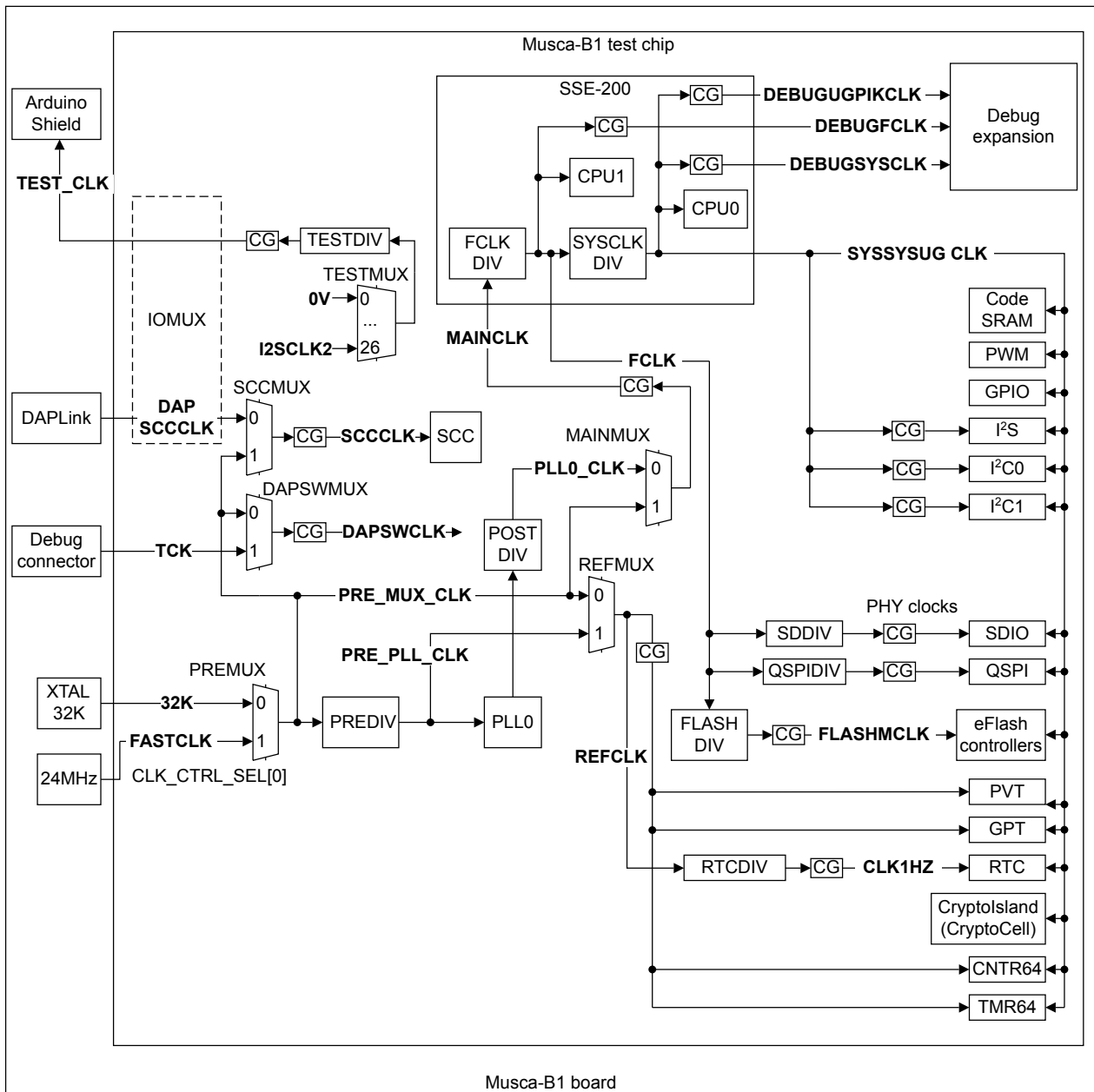


Figure 2-5 Musca-B1 clock system

See the *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual* for information on the clock system in the SSE-200 subsystem.

Controlling clock frequencies

The SCC registers control the clock system. See [3.12 Serial Configuration Control registers](#) on page 3-126. The following table shows the SCC clock control registers.

Table 2-3 Clock control SCC registers

Register	Register function	Register description
CLK_CTRL_SEL	Controls the following blocks: <ul style="list-style-type: none"> • PREMUX. • DAPSWMUX. • MAINMUX. • REFMUX. • SCCMUX. • TESTMUX. 	CLK_CTRL_SEL Register on page 3-135.
CLK_PLL_PREDIV_CTRL	Controls PREDIV.	CLK_PLL_PREDIV_CTRL Register on page 3-137.
CLK_POSTDIV_CTRL_FLASH	Controls FLASHDIV	CLK_POSTDIV_CTRL_FLASH Register on page 3-138.
CLK_POSTDIV_CTRL_QSPI	Controls QSPIDIV.	CLK_POSTDIV_CTRL_QSPI Register on page 3-138.
CLK_POSTDIV_CTRL_RTC	Controls RTCDIV.	CLK_POSTDIV_CTRL_RTC Register on page 3-139.
CLK_POSTDIV_CTRL_SD	Controls SDDIV.	CLK_POSTDIV_CTRL_SD Register on page 3-139.
CLK_POSTDIV_CTRL_TEST	Controls TESTDIV.	CLK_POSTDIV_CTRL_TEST Register on page 3-140.
CTRL_BYPASS_DIV	Controls the clock divider bypass functions.	CTRL_BYPASS_DIV Register on page 3-140.
PLL_POSTDIV_CTRL_PLL0_CLK	Controls POSTDIV.	PLL_POSTDIV_CTRL_PLL0_CLK Register on page 3-142.
PLL_CTRL_MULT_PLL0_CLK	Controls the PLL multiplication factor by controlling the PLL feedback division value.	PLL_CTRL_MULT_PLL0_CLK Register on page 3-143.
CLK_CTRL_ENABLE	Enables <i>Clock Gates</i> (CGs).	CLK_CTRL_ENABLE Register on page 3-143.

The FCLK_DIV and SYSCLK_DIV system control registers control the FCLKDIV and SYSCLKDIV dividers in the SSE-200 subsystem. FCLKDIV derives clock **FCLK** for secondary processor CPU1 and SYSCLKDIV derives **SYCLK** for primary processor CPU0.

The following table shows system control registers FCLK_DIV and SYSCLK_DIV.

Table 2-4 System control registers FCLK_DIV and SYSCLK_DIV

Register	Register function	Register description
FCLK_DIV	Controls divider block FCLKDIV in SSE-200 subsystem to derive clock FCLK for secondary processor CPU1.	FCLK_DIV Register on page 3-99.
SYSCLK_DIV	Controls divider block SYSCLKDIV in SSE-200 subsystem to derive clock SYCLK for primary processor CPU0.	SYSCLK_DIV Register on page 3-100.

Multiplexed I/O

The **DAPSCCCLK** signal is present on Musca-B1 test chip I/O PA24 which is part of the multiplexed Musca-B1 test chip I/O. The IOMUX registers control the multiplexed Musca-B1 test chip I/O.

Note

The **DAPSCCCLK** input is reserved. In normal operation, software must not change **PRE_MUX_CLK** as the input to multiplexer SCCMUX. See [CLK_CTRL_SEL Register on page 3-135.](#)

TEST_CLK is present on Musca-B1 test chip I/O PA13 which is also part of the multiplexed Musca-B1 test chip I/O. The IOMUX registers select **TEST_CLK** by selecting alternative function ALTF2 for Musca-B1 test chip I/O PA13.

See the following for information on the multiplexed Musca-B1 test chip I/O and how to select wanted signals at the Musca-B1 test chip I/O pins:

- [2.2.2 Test chip multiplexed I/O on page 2-23](#)
- [3.12.1 IOMUX registers on page 3-126](#).

Related information

[3.12.2 SCC registers summary on page 3-130](#)

[2.2.2 Test chip multiplexed I/O on page 2-23](#)

[3.12.1 IOMUX registers on page 3-126](#)

2.7 CryptoCell-312 and CryptoIsland-300 subsystems

The Musca-B1 test chip implements Arm CryptoCell-312 and Arm CryptoIsland-300 security subsystems.

CryptoCell-312 is a cryptographic engine that provides fundamental security services to the Cortex-M33 processors and protects them against unauthorized access.

CryptoIsland-300 is a security enclave that protects and provides security services to the test chip. CryptoIsland-300 contains a CryptoCell-312 security enclave and an Arm Cortex-M0+ processor.

The Musca-B1 test chip implements CryptoIsland-300 with 64KB of RAM.

Remapping of the CryptoIsland memory access is necessary on the Musca-B1 test chip. See [3.11 CryptoIsland-300 remap at Musca-B1 test chip level on page 3-124](#).

The following figure shows the CryptoCell-312 and CryptoIsland-300 security subsystems on the Musca-B1 test chip.

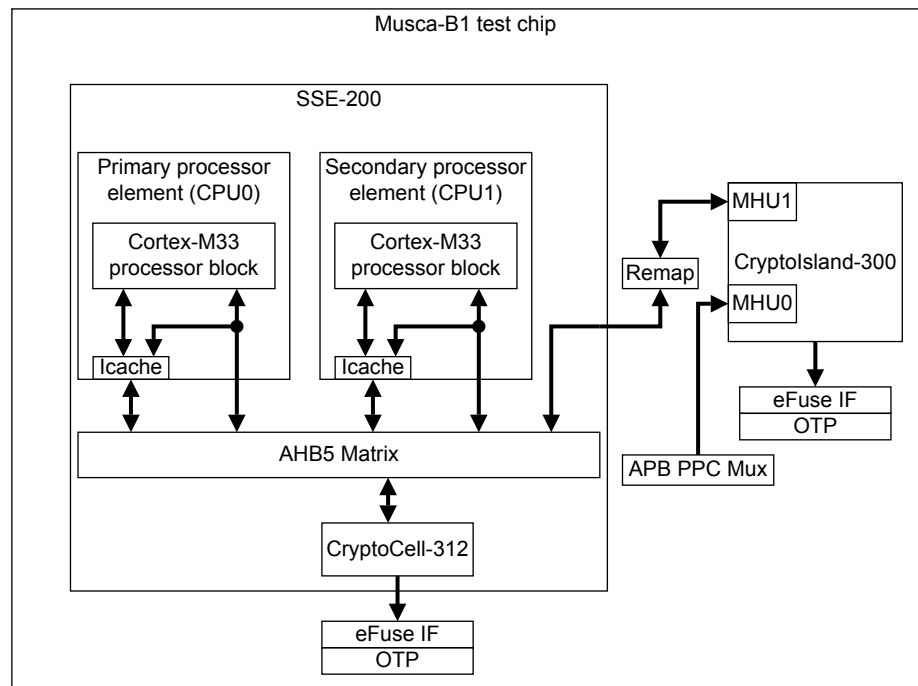


Figure 2-6 CryptoCell-312 and CryptoIsland-300 subsystems on the Musca-B1 test chip

Contact Arm for more information about the CryptoCell-312 and CryptoIsland-300 subsystems.

Related information

[3.11 CryptoIsland-300 remap at Musca-B1 test chip level on page 3-124](#)

2.8 Resets and powerup

The Musca-B1 board provides standard resets that the DAPLink controller drives.

Resets

The Musca-B1 board provides the following resets:

- **CFG_nRST**, the *Serial Configuration Controller* (SCC) interface reset.
- **CB_nRST**, the logic reset.
- **CS_nSRST**, the system reset to the Cortex-M33 processors and the CoreSight components.

User push buttons

The Musca-B1 board supplies the following user push buttons:

- **PBON**, the on/off push-button. This button powers up, or powers down, the board.
- **nSRST**. Generates the reset signal **CS_nSRST**.

Reset sequence

The following figure shows the reset and powerup timing cycle including Musca-B1 test chip and board configuration.

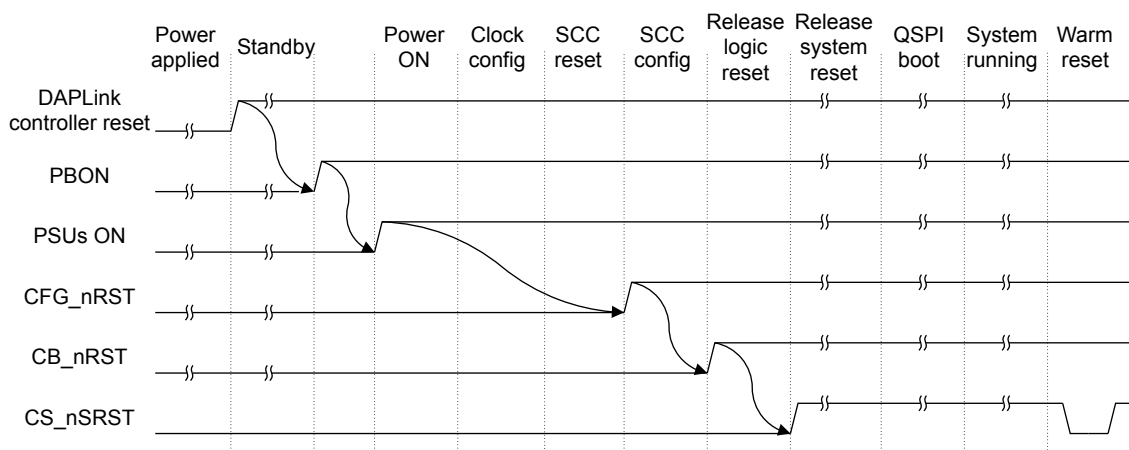


Figure 2-7 Musca-B1 test chip and board reset and configuration timing

Related information

[1.3 Location of components on page 1-14](#)

[2.5 User components and status LEDs on page 2-31](#)

2.9 Power

The DAPLink 5V USB connector supplies the power requirements of the Musca-B1 board. The board also supports use of an external battery as an alternative to the 5V USB supply.

Overview of board power

The Musca-B1 board provides on-board regulators to supply power rails in the board and to the test chip. The following figure shows the Musca-A board power supplies.

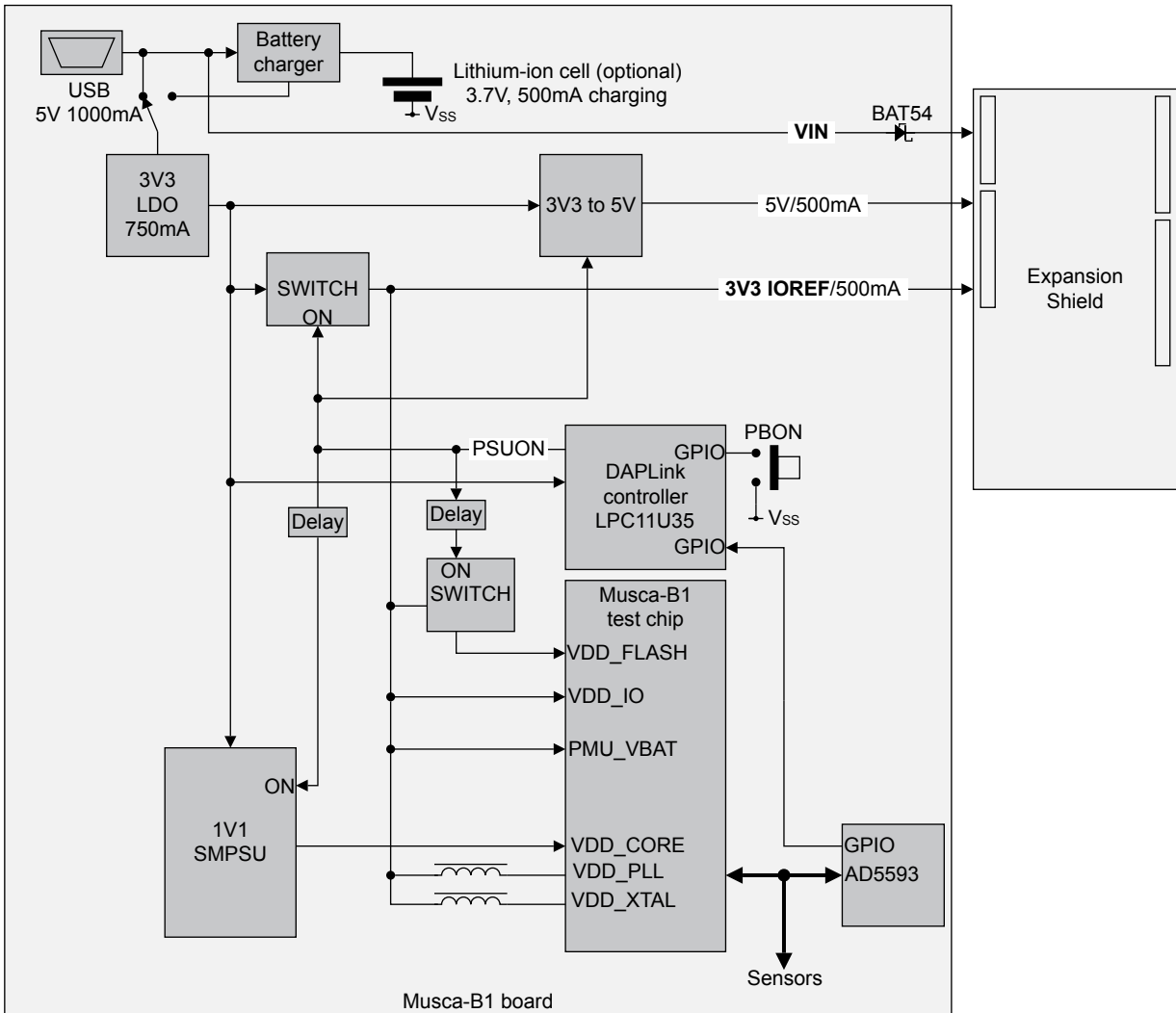


Figure 2-8 Musca-B1 board power supplies

Caution

Do not fit an Arduino Expansion Shield to the Musca-B1 board while the Musca-B1 board is powered up.

Note

The maximum values of decoupling capacitance that can be fitted to the Arduino 3V3 and 5V power rails are:

- 100µF to the Arduino 3V3 power rail.
 - 22µF to the Arduino 5V power rail.
-

Musca-B1 board and Musca-B1 test chip power rails

The following table shows the maximum loads that the Musca-B1 board power rails draw from the power supplies.

Table 2-5 Musca-B1 board and Musca-B1 test chip power rails

Power rail	Voltage	Max load (mA)	Comment
USB_5V	5V	USB 2.0: 500 Charging point: 1000	Maximum current from USB
VBAT	4.2-3.3V	500	Lithium-ion battery, when charging
SB_3V3	3.3V	750	-
3V3	3.3V	500	Arduino Shield 3V3
5V	5V	500	Arduino Shield 5V
		250	Startup 5V

External power

The DAPLink 5V USB connector supplies all external power to the Musca-B1 board.

Backup battery

A backup battery can power the Musca-B1 board, using the connector on the lower face of the board.

Arm recommends using the Lithium Ion, CLN 523450, 3.7V, 950mAh battery. The battery is recharged from an external supply during USB 5V operation.

Note

- A slider switch selects the source of board power to be either external power or the backup battery. See [1.3 Location of components on page 1-14](#) for the location of the slider switch.
 - If a battery is fitted while external power is connected, circuitry on the board automatically charges the battery with a maximum charging current of 500mA.
-

Related information

[1.3 Location of components on page 1-14](#)

[A.3 USB connector on page Appx-A-204](#)

2.10 I²C interfaces and sensors

To minimize usage of the Musca-B1 test chip pins, the Musca-B1 test chip provides a single I²C interface for the board sensors.

The board sensors provide basic support for *Internet of Things* (IoT) software demonstrations and analog support for the Arduino Expansion Shield.

The analog converter supports programmable I/O that can be ADC, DAC, or GPIO. Two of the I/O are used as GPIO and connect to the DAPLink controller. This connection can control power by enabling powerdown of the system from the Musca-B1 test chip application program.

The following figure shows the Musca-B1 test chip I²C interface and connected peripherals.

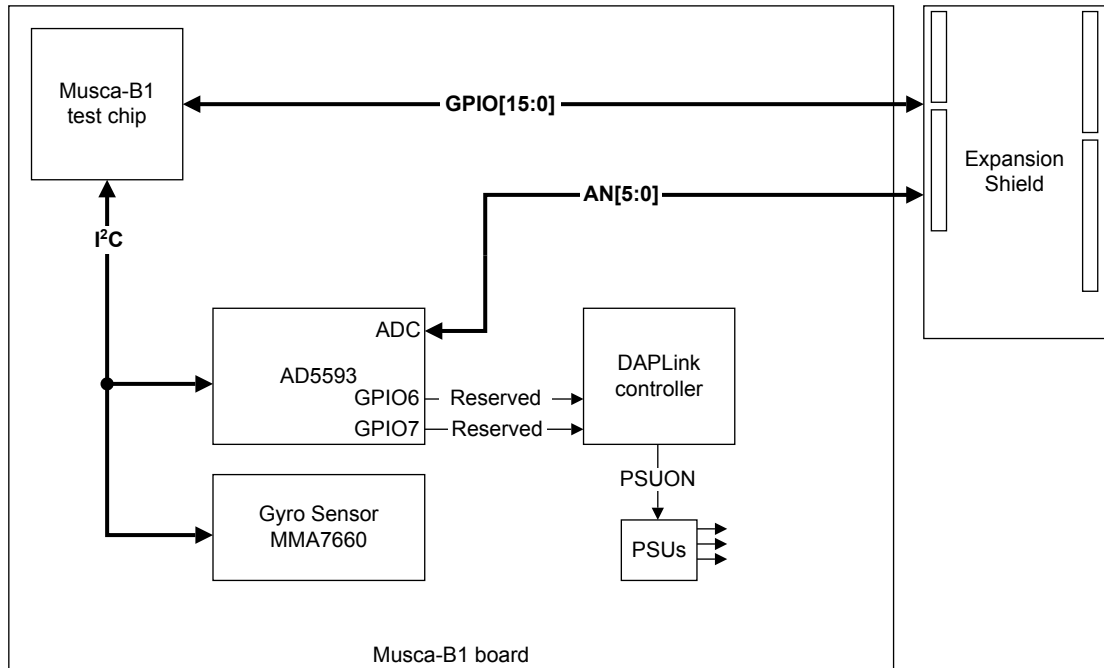


Figure 2-9 I²C interfaces and I²C sensors

Note

The I²C and GPIO[15:0] signals are on multiplexed Musca-B1 test chip I/O pins. The I/O multiplexer must select the correct signals for the required functions to be available. See the following for information on how to select the required functions at the Musca-B1 test chip I/O pins:

- [2.2.2 Test chip multiplexed I/O on page 2-23.](#)
- [3.12.1 IOMUX registers on page 3-126.](#)

Related information

[1.3 Location of components on page 1-14](#)

2.11 microSD and debug interfaces

The microSD, 4-bit trace, *Serial Wire Debug* (SWD), and P-JTAG interfaces connect directly to the Musca-B1 test chip pins.

The microSD and 4-bit trace interfaces are multiplexed onto the same Musca-B1 test chip pins, Musca-B1 test chip I/O PA31-1PA26. The microSD interface is the primary, or value at reset, function. The 4-bit trace function is chosen by using the IOMUX registers to select alternative function ALTF1 for these pins.

The I²S signals to the Arduino Expansion Shield are also on multiplexed Musca-B1 test chip I/O pins. The IOMUX registers must select the correct signals for these functions to be available.

See the following for information on how to select the required functions at the Musca-B1 test chip I/O pins:

- [2.2.2 Test chip multiplexed I/O on page 2-23.](#)
- [3.12.1 IOMUX registers on page 3-126.](#)

The following figure shows the microSD and debug interfaces.

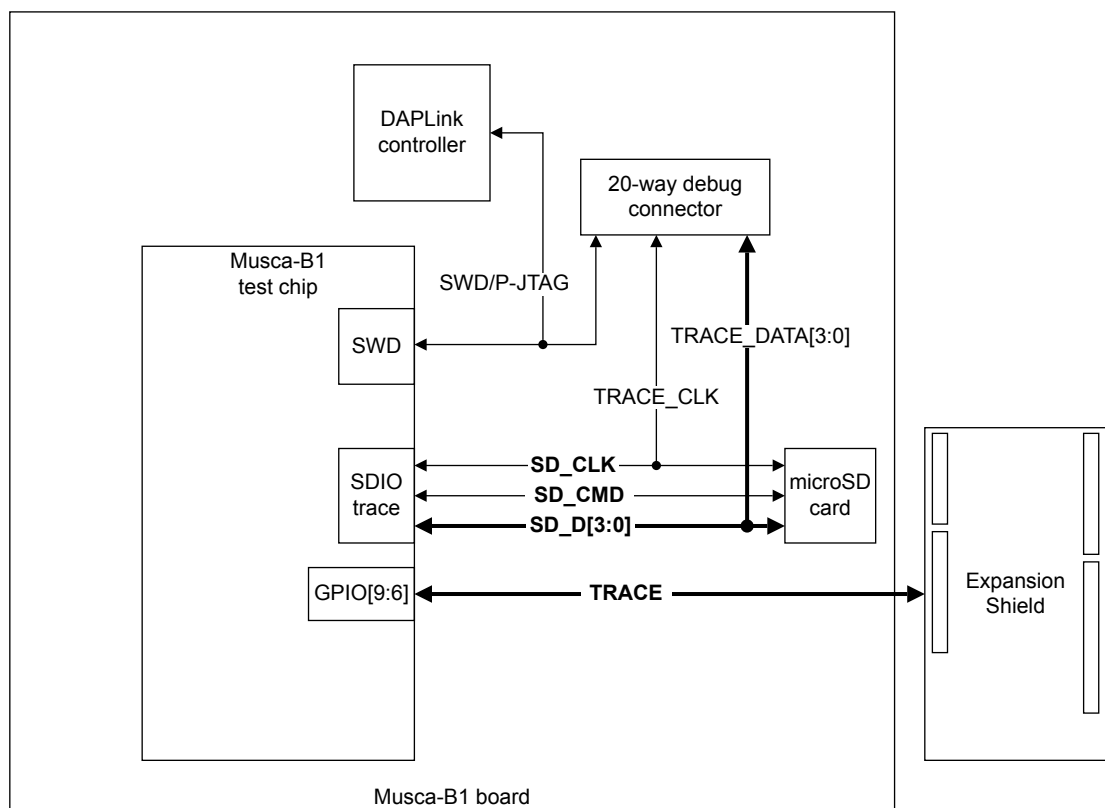


Figure 2-10 microSD and debug interfaces

Related information

[1.3 Location of components on page 1-14](#)

2.12 Arduino Expansion Shield interface

The Musca-B1 board supports custom system and peripheral design by providing one Arduino Shield interface.

Overview of Arduino Expansion Shield interface

The Arduino Shield interface enables fitting off-the-shelf boards including:

- Sensors.
- Peripherals.
- PHYs.
- Breakout boards for full custom design.

Caution

Do not fit an Arduino Shield while the Musca-B1 board is powered up.

The following figure shows the Arduino Expansion Shield interface of the Musca-B1 board.

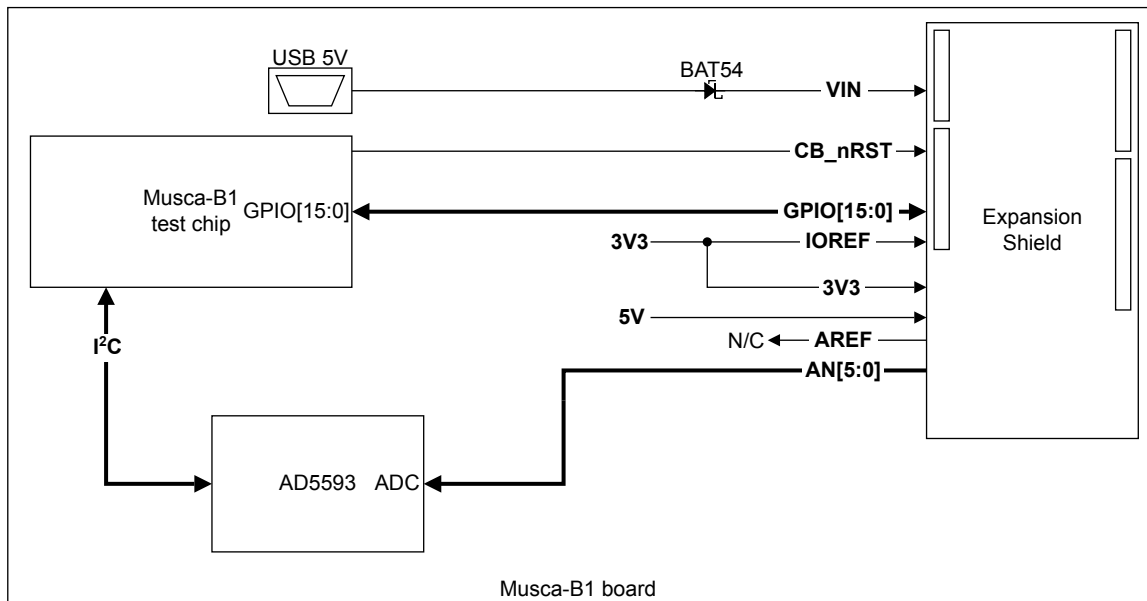


Figure 2-11 Arduino Expansion Shield interface

The Arduino Shield expansion interface provides:

- Up to 16 3V3 digital I/O.
- I²C.
- I²S.
- SPI, master only.
- UART. The UART on the Musca-B1 test chip does not support hardware flow control.
- 6-channel 3V3 analog from Expansion Shield to the Musca-B1 board.
- **IOREF**, fixed at 3V3.
- Reset.

Caution

The maximum currents available from the Musca-B1 board for the Arduino Expansion Shield power and reference pins are:

3V3/IOREF	Maximum current available is 500mA.
5V	Maximum current available is 500mA.

Note

The maximum value of decoupling capacitance that can be fitted to the Arduino 3V3 and 5V power rails is 100µF.

Arduino Expansion Shield multiplexed I/O

The **GPIO[15:0]** signals form part of the multiplexed Musca-B1 test chip I/O. The IOMUX registers control the GPIO multiplexer to select the signals at the Musca-B1 test chip I/O. The registers must select the correct signals for the I²C, I²S, SPI, and UART interfaces to be available at the Arduino Expansion Shield.

See the following for information on how to select the required signals at the Musca-B1 test chip I/O pins:

- [2.2.2 Test chip multiplexed I/O](#) on page 2-23.
- [3.12.1 IOMUX registers](#) on page 3-126.

Related information

[1.3 Location of components](#) on page 1-14

[A.1 Arduino Expansion Shield connectors](#) on page Appx-A-200

2.13 Boot memory

Normal Musca-B1 test chip boot operation is from eFlash memory.

Boot options

The following boot options are available:

- eFlash, 4MB: eFlash is the default option and it offers the fastest boot method.
- External QSPI, 8MB: A method of booting from QSPI is available from Arm.
- Code SRAM, 512KB.

Caution

Warm reset of eFlash by asserting reset **nSRST** externally or internally using SW/32K/WDOG is not supported. Only Cold reset of eFlash by powering the board ON or pressing the PBON button is supported. Asserting Warm reset results in unreliable initialization of the eFlash controller.

The default debugger connection configuration settings (Normal+Autodetect) must be used when debugging applications in eFlash. This configuration connects without asserting **nSRST** and enables normal debug operation.

Warm reset of eFlash by pressing the nSRST button is not supported. Use the PBON button instead.

This Caution does not affect or refer to Warm reset of QSPI or SRAM.

Note

A workaround procedure is available to enable Warm reset from eFlash or internal software resets. See the Community pages, which are accessible from <https://www.arm.com/musca>.

Programming boot memory

The following methods of programming boot memory, using the DAPLink controller are available:

- SW debug programming over USB:
 - Programming of the eFlash or QSPI image is done through the DAPLink SW debug interface which is connected over USB to the host computer. The host computer uses a code development environment such as Arm Keil® µVision or Arm DS-5 to develop and upload the application code to the Musca-B1 board using SW debug.
- Drag and Drop:
 - The host computer is connected to the DAPLink interface over USB. The DAPLink firmware enables application code to be dropped into QSPI memory.

Note

The QSPI control signals are on the multiplexed Musca-B1 test chip I/O pins. The I/O multiplexer must select the correct signals for QSPI to be available. See the following for information on how to select the required functions at the Musca-B1 test chip I/O pins:

- [2.2.2 Test chip multiplexed I/O on page 2-23.](#)
- [3.12.1 IOMUX registers on page 3-126.](#)

2.14 DAPLink controller

The DAPLink controller is an Arm Mbed component that uses a Cortex-M0 processor. The DAPLink controller contains pre-defined firmware that enables access to the CoreSight component in Musca-B1 test chip, *USB Mass Storage Device* (USBMSD), USB UART, and remote reset.

The DAPLink firmware binary image is available at the Arm Community pages which are accessible from <https://www.arm.com/musca>.

Note

The DAPLink controller is only accessible when P-JTAG is disconnected from the debug connector.

2.15 Debug

The Musca-B1 board provides several ways of performing debug.

- P-JTAG processor debug available through the debug connector.
- *Serial Wire Debug* (SWD), available through the following:
 - Debug connector.
 - CMSIS-DAP over USB.
- 4-bit trace available through the debug connector.

Caution

There are restrictions on the use of eFlash under Warm reset. See [2.13 Boot memory on page 2-44](#).

Note

The trace signals are on multiplexed Musca-B1 test chip I/O pins. The I/O multiplexer must select the correct signals for trace to be available on the debug connector.

See the following for information on how to select the required functions at the Musca-B1 test chip I/O pins:

- [2.2.2 Test chip multiplexed I/O on page 2-23](#).
- [3.12.1 IOMUX registers on page 3-126](#).

Related information

[1.3 Location of components on page 1-14](#)

[A.2 Debug connector on page Appx-A-203](#)

Chapter 3

Programmers model

This chapter describes the programmers model of the Musca-B1 test chip and board.

It contains the following sections:

- *3.1 About this programmers model* on page 3-48.
- *3.2 Memory maps* on page 3-49.
- *3.3 Processor elements* on page 3-58.
- *3.4 Base element* on page 3-65.
- *3.5 System control element* on page 3-96.
- *3.6 SSE-200 subsystem debug system* on page 3-102.
- *3.7 Real Time Clock* on page 3-106.
- *3.8 General-purpose timer* on page 3-107.
- *3.9 PVT sensor control registers* on page 3-112.
- *3.10 One-Time Programmable (OTP) security* on page 3-123.
- *3.11 CryptoIsland-300 remap at Musca-B1 test chip level* on page 3-124.
- *3.12 Serial Configuration Control registers* on page 3-126.
- *3.13 UART control registers* on page 3-194.
- *3.14 GPIO control registers* on page 3-196.
- *3.15 Third-party IP* on page 3-198.

3.1 About this programmers model

The following information applies to all registers in this programmers model:

- Do not attempt to access reserved or unused address locations. Attempting to access these locations can result in UNPREDICTABLE behavior.
- Unless otherwise stated in the accompanying text:
 - Do not modify undefined register bits.
 - Ignore undefined register bits on reads.
 - All register bits are reset to a logic 0 by a system or powerup reset.
 - All register summary tables in this chapter describe register access types as follows:

RW	Read/write.
RO	Read-only.
WO	Write-only.

Caution

In the Musca-B1 test chip level, the MPC controlling eFlash and QSPI are not reset by the SIE-200 WARMRESET. After reset, the MPCs might block some memory areas and, if the MPCs are locked, reconfiguring is not possible.

3.2 Memory maps

The memory map in the Musca-B1 test chip is based on the SSE-200 memory map. The SSE-200 memory map alternates between Secure and Non-secure regions every 256MB. Only a few address areas are exempt from security mapping because they are related to debug functionality.

See the *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual* for information on the SSE-200 subsystem memory map.

This section contains the following subsections:

- [3.2.1 Code \(AHB expansion\) and SRAM regions memory map on page 3-49.](#)
- [3.2.2 Peripheral \(expansion\) region memory map on page 3-51.](#)
- [3.2.3 Non-secure Expansion 1 region memory map on page 3-52.](#)
- [3.2.4 Secure Expansion 1 region memory map on page 3-53.](#)
- [3.2.5 System region memory map on page 3-54.](#)
- [3.2.6 Complete memory map on page 3-55.](#)

3.2.1 Code (AHB expansion) and SRAM regions memory map

The following figure shows the Musca-B1 test chip implementation of the code, AHB5 expansion, and SRAM regions of the SSE-200 system memory map.

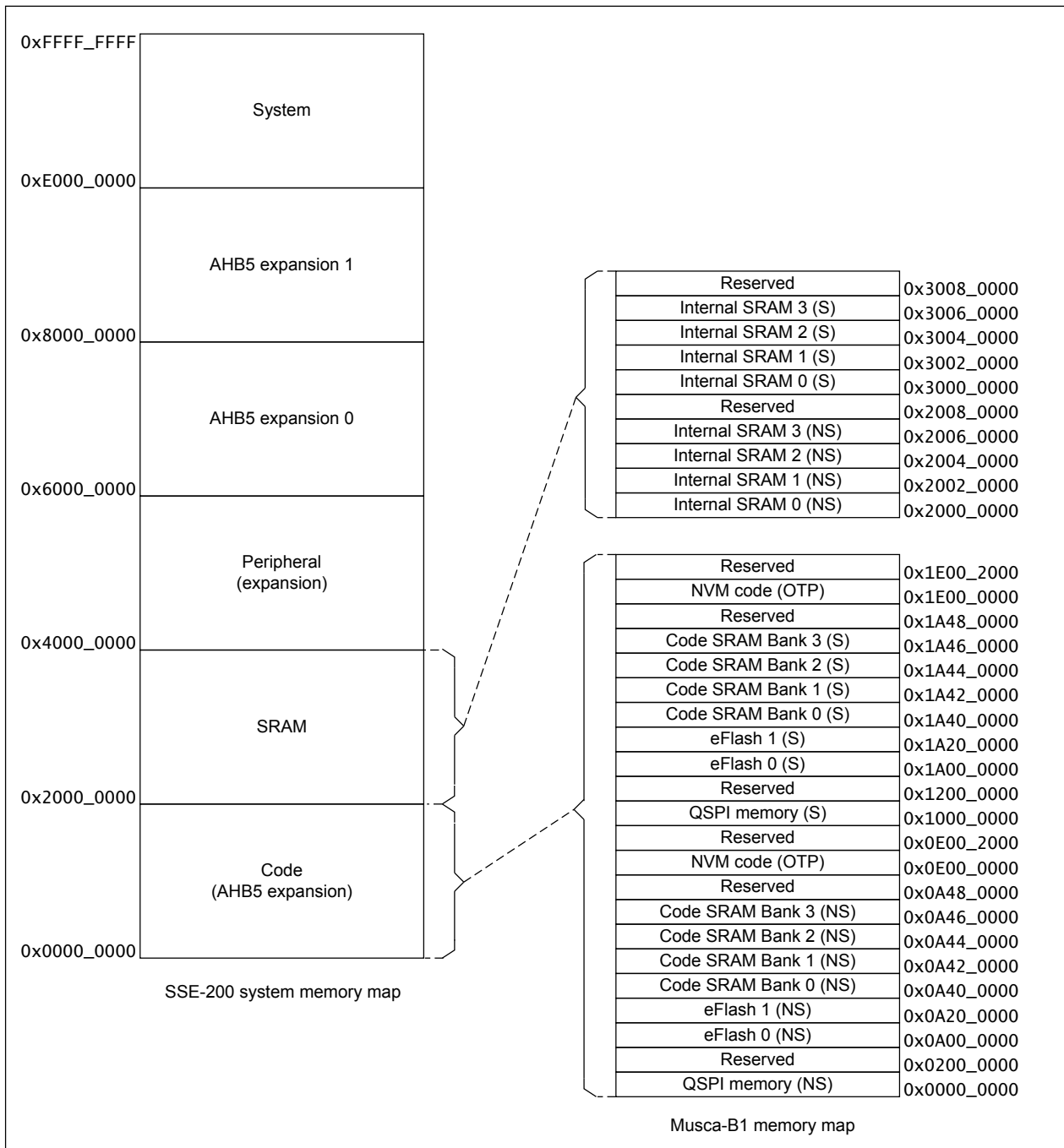


Figure 3-1 Musca-B1 test chip memory map code and SRAM regions

3.2.2 Peripheral (expansion) region memory map

The following figure shows the Musca-B1 test chip implementation of the Peripheral (expansion) region of the SSE-200 memory map.

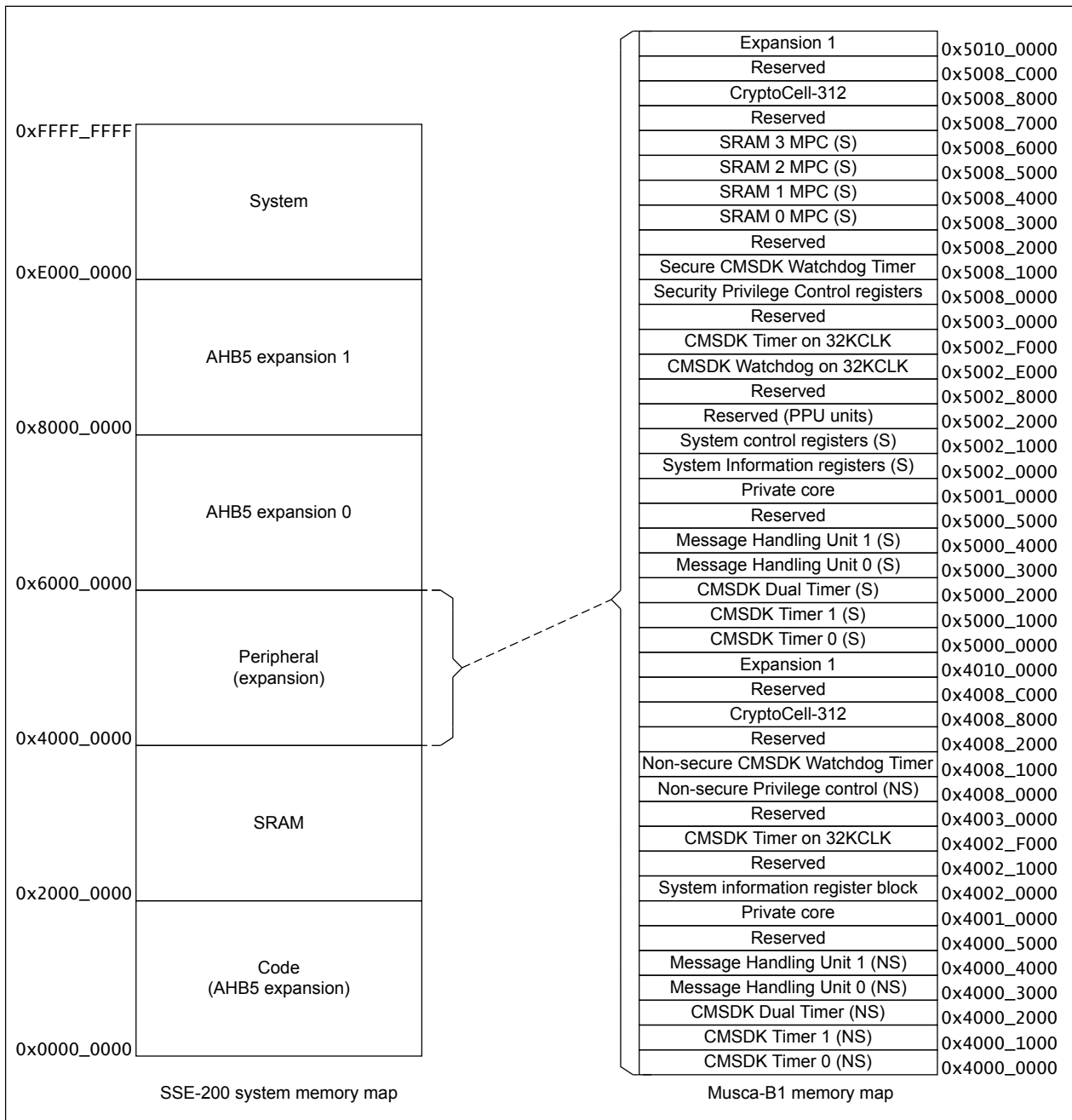


Figure 3-2 Musca-B1 test chip memory map Peripheral region

3.2.3 Non-secure Expansion 1 region memory map

The following figure shows the Musca-B1 test chip implementation of the Non-secure Expansion 1 region of the SSE-200 memory map.

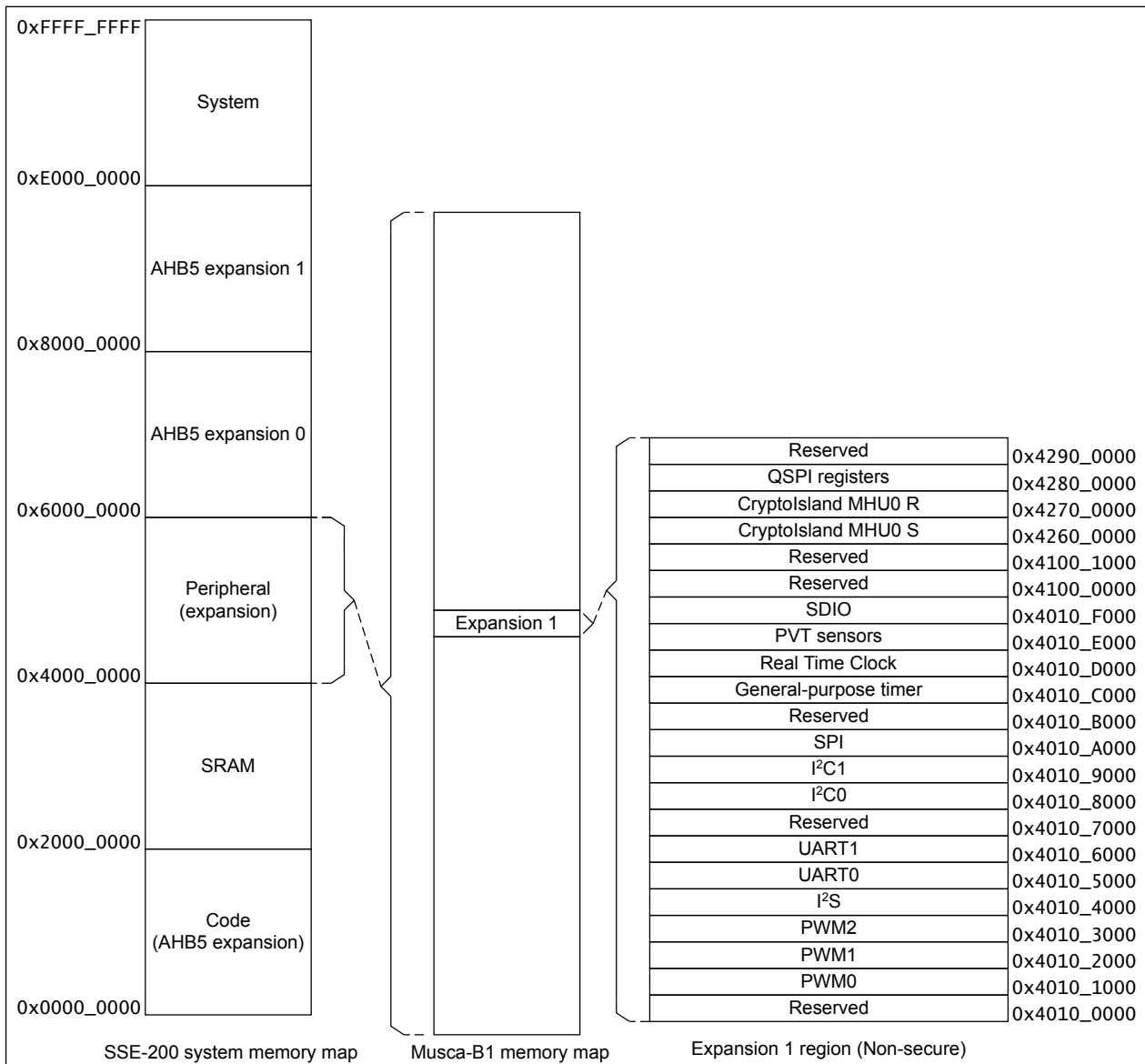


Figure 3-3 Musca-B1 test chip memory map Non-secure Expansion 1 region

3.2.4 Secure Expansion 1 region memory map

The following figure shows the Musca-B1 test chip implementation of the Secure Expansion 1 region of the SSE-200 memory map.

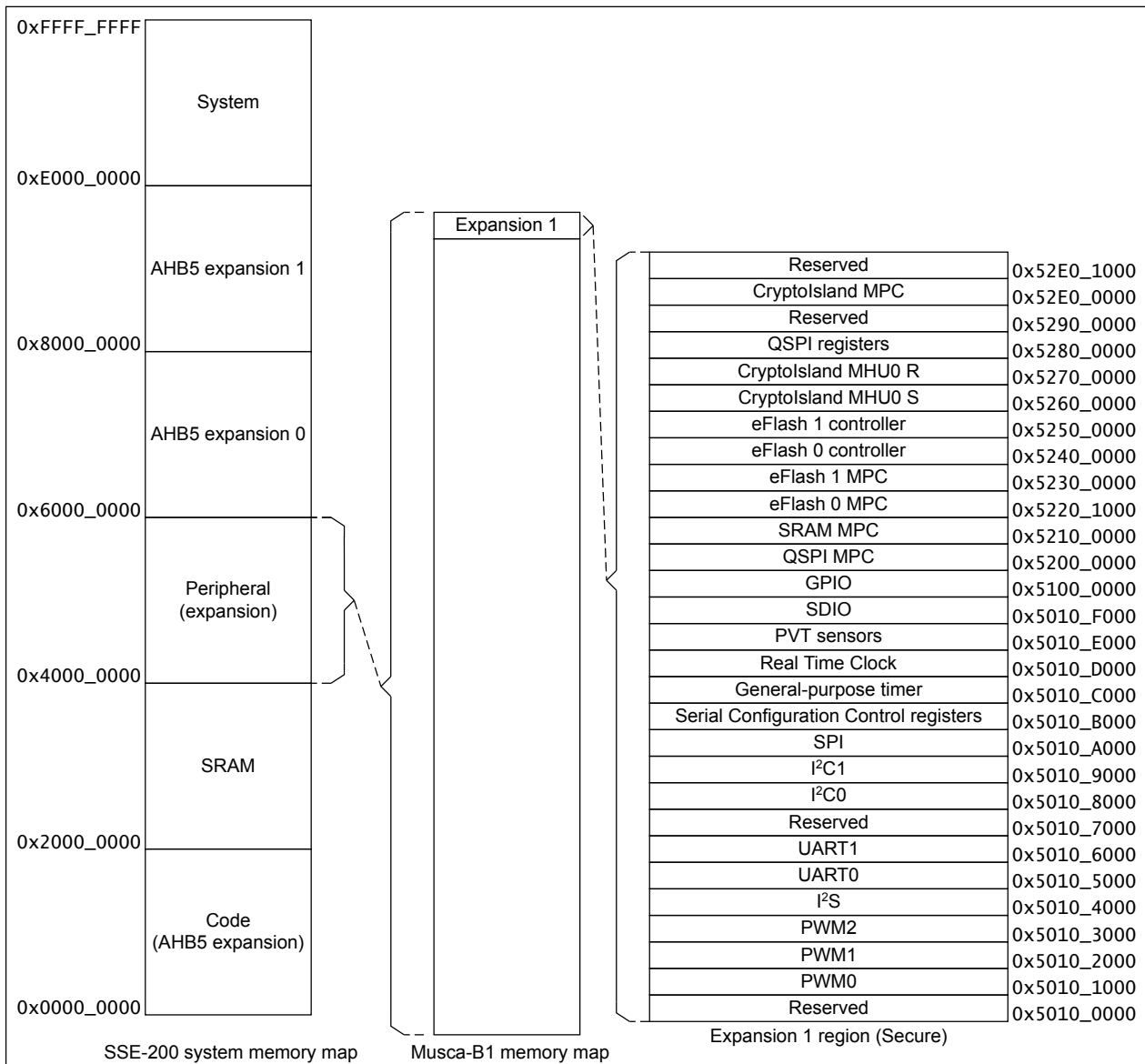


Figure 3-4 Musca-B1 test chip memory map Secure Expansion 1 region

3.2.5 System region memory map

The following figure shows the Musca-B1 test chip implementation of the System region of the SSE-200 memory map.

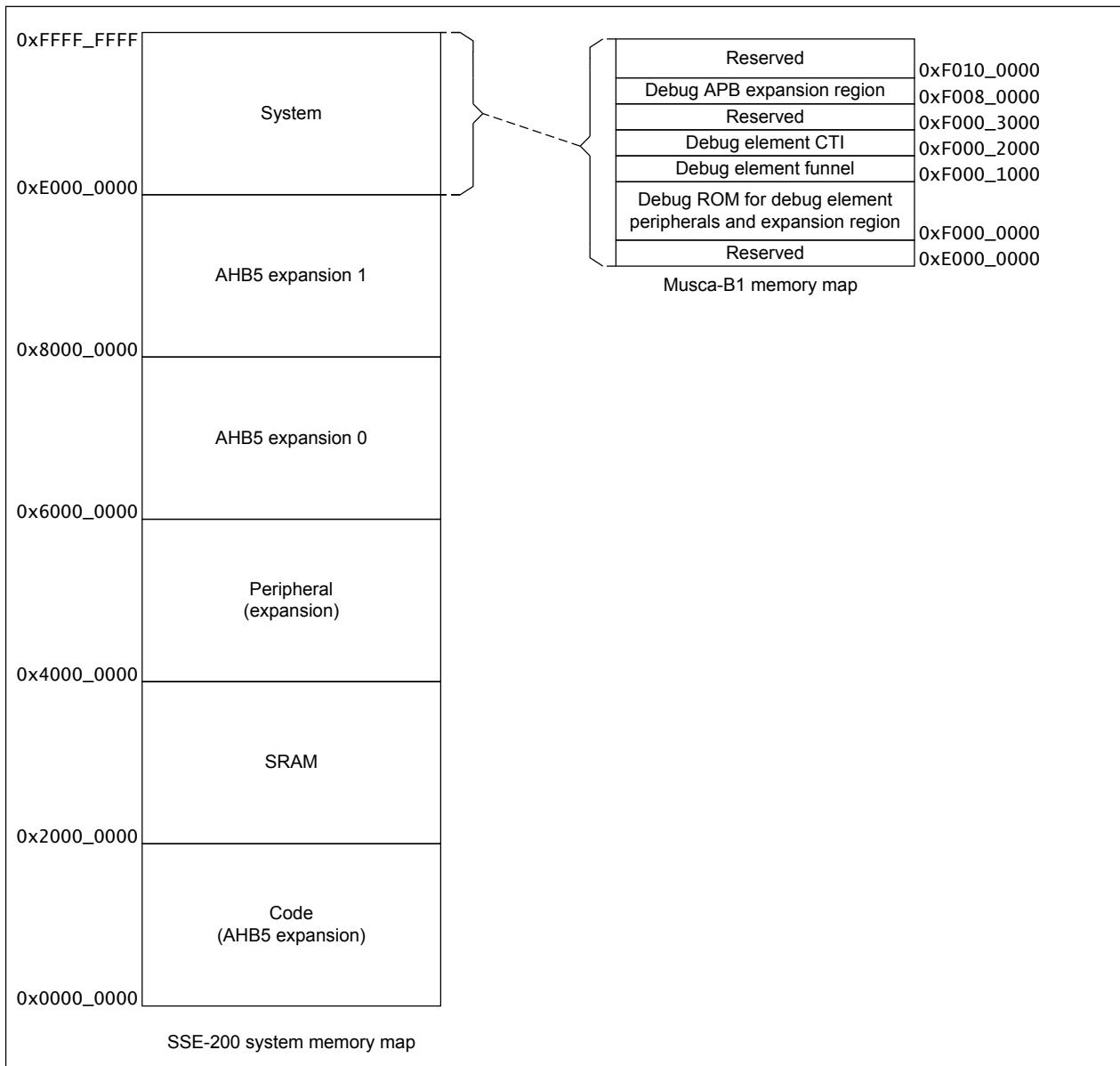


Figure 3-5 Musca-B1 test chip memory map System region

3.2.6 Complete memory map

The following table shows the complete Musca-B1 test chip memory map. Undefined memory locations are reserved and software must not attempt to access these locations.

Table 3-1 Memory map

Non-secure		Secure		Description		
From	To	From	To	Size	Non-secure	Secure
0x0000_0000	0x01FF_FFFF	0x1000_0000	0x11FF_FFFF	2MB	QSPI - memory	QSPI - memory
0x0A00_0000	0x0A1F_FFFF	0x1A00_0000	0x1A1F_FFFF	2MB	eFlash 0	eFlash 0
0x0A20_0000	0x0A3F_FFFF	0x1A20_0000	0x1A3F_FFFF	2MB	eFlash 1	eFlash 1
0x0A40_0000	0x0A41_FFFF	0x1A40_0000	0x1A41_FFFF	128KB	Code SRAM Bank 0	Code SRAM Bank 0
0x0A42_0000	0x0A43_FFFF	0x1A42_0000	0x1A43_FFFF	128KB	Code SRAM Bank 1	Code SRAM Bank 1
0x0A44_0000	0x0A45_FFFF	0x1A44_0000	0x1A45_FFFF	128KB	Code SRAM Bank 2	Code SRAM Bank 2
0x0A46_0000	0x0A47_FFFF	0x1A46_0000	0x1A47_FFFF	128KB	Code SRAM Bank 3	Code SRAM Bank 3
0x0E00_0000	0x0E00_1FFF	0x1E00_0000	0x1E00_1FFF	8KB	NVM code (OTP)	NVM code (OTP)
0x2000_0000	0x2001_FFFF	0x3000_0000	0x3001_FFFF	128KB	Internal SRAM Bank 0	Internal SRAM Bank 0
0x2002_0000	0x2003_FFFF	0x3002_0000	0x3003_FFFF	128KB	Internal SRAM Bank 1	Internal SRAM Bank 1
0x2004_0000	0x2005_FFFF	0x3004_0000	0x3005_FFFF	128KB	Internal SRAM Bank 2	Internal SRAM Bank 2
0x2006_0000	0x2007_FFFF	0x3006_0000	0x3007_FFFF	128KB	Internal SRAM Bank 3	Internal SRAM Bank 3
0x4000_0000	0x4000_0FFF	0x5000_0000	0x5000_0FFF	4KB	CMSDK Timer 0	CMSDK Timer 0
0x4000_1000	0x4000_1FFF	0x5000_1000	0x5000_1FFF	4KB	CMSDK Timer 1	CMSDK Timer 1
0x4000_2000	0x4000_2FFF	0x5000_2000	0x5000_2FFF	4KB	CMSDK Dual Timer	CMSDK Dual Timer
0x4000_3000	0x4000_3FFF	0x5000_3000	0x5000_3FFF	4KB	Message Handling Unit 0	Message Handling Unit 0
0x4000_4000	0x4000_4FFF	0x5000_4000	0x5000_4FFF	4KB	Message Handling Unit 1	Message Handling Unit 1
0x4001_0000	0x4001_FFFF	0x5001_0000	0x5001_FFFF	64KB	Private core	Private core
0x4002_0000	0x4002_0FFF	0x5002_0000	0x5002_0FFF	4KB	System information registers	System information registers
-	-	0x5002_1000	0x5002_0FFF	4KB	-	System control registers
-	-	0x5002_E000	0x5002_EFFF	4KB	-	CMSDK Watchdog on 32K
0x4002_F000	0x4002_FFFF	0x5002_F000	0x5002_FFFF	4KB	CMSDK Timer on 32K	CMSDK Timer on 32K
0x4008_0000	0x4008_0FFF	0x5008_0000	0x5008_0FFF	4KB	Non-secure privilege control	Secure privilege control registers

Table 3-1 Memory map (continued)

Non-secure		Secure		Description		
From	To	From	To	Size	Non-secure	Secure
0x4008_1000	0x4008_1FFF	0x5008_1000	0x5008_1FFF	4KB	Non-secure CMSDK Watchdog Timer	Secure CMSDK Watchdog Timer
-	-	0x5008_3000	0x5008_3FFF	4KB	-	SRAM 0 Memory Protection Controller
-	-	0x5008_4000	0x5008_4FFF	4KB	-	SRAM 1 Memory Protection Controller
-	-	0x5008_5000	0x5008_5FFF	4KB	-	SRAM 2 Memory Protection Controller
-	-	0x5008_6000	0x5008_6FFF	4KB	-	SRAM 3 Memory Protection Controller
0x4008_8000	0x4008_BFFF	0x5008_8000	0x5008_BFFF	16KB	CryptoCell-312	CryptoCell-312
0x4010_1000	0x4010_1FFF	0x5010_1000	0x5010_1FFF	4KB	PWM0	PWM0
0x4010_2000	0x4010_2FFF	0x5010_2000	0x5010_2FFF	4KB	PWM1	PWM1
0x4010_3000	0x4010_3FFF	0x5010_3000	0x5010_3FFF	4KB	PWM2	PWM2
0x4010_4000	0x4010_4FFF	0x5010_4000	0x5010_4FFF	4KB	I ² S	I ² S
0x4010_5000	0x4010_5FFF	0x5010_5000	0x5010_5FFF	4KB	UART0	UART0
0x4010_6000	0x4010_6FFF	0x5010_6000	0x5010_6FFF	4KB	UART1	UART1
0x4010_8000	0x4010_8FFF	0x5010_8000	0x5010_8FFF	4KB	I ² C0	I ² C0
0x4010_9000	0x4010_9FFF	0x5010_9000	0x5010_9FFF	4KB	I ² C1	I ² C1
0x4010_A000	0x4010_AFFF	0x5010_A000	0x5010_AFFF	4KB	SPI	SPI
-	-	0x5010_B000	0x5010_BFFF	4KB	-	Serial Configuration Control registers
0x4010_C000	0x4010_CFFF	0x5010_C000	0x5010_CFFF	4KB	General -purpose timer	General -purpose timer
0x4010_D000	0x4010_DFFF	0x5010_D000	0x5010_DFFF	4KB	Real Time Clock	Real Time Clock
0x4010_E000	0x4010_EFFF	0x5010_E000	0x5010_EFFF	4KB	PVT sensors	PVT sensors
0x4010_F000	0x4010_FFFF	0x5010_F000	0x5010_FFFF	4KB	SDIO	SDIO
-	-	0x5100_0000	0x5100_0FFF	4KB	-	GPIO
-	-	0x5200_0000	0x5200_0FFF	4KB	-	QSPI Memory Protection Controller

Table 3-1 Memory map (continued)

Non-secure		Secure		Description		
From	To	From	To	Size	Non-secure	Secure
-	-	0x5210_0000	0x5210_0FFF	4KB	-	SRAM Memory Protection Controller
-	-	0x5220_0000	0x5220_0FFF	4KB	-	eFlash 0 Memory Protection Controller
-	-	0x5230_0000	0x5230_0FFF	4KB	-	eFlash 1 Memory Protection Controller
-	-	0x5240_0000	0x5240_0FFF	4KB	-	eFlash 0 controller
-	-	0x5250_0000	0x5250_0FFF	4KB	-	eFlash 1 controller
0x4260_0000	0x426F_FFFF	0x5260_0000	0x526F_FFFF	1MB	CryptoIsland-300 MHU0 S	CryptoIsland-300 MHU0 S
0x4270_0000	0x427F_FFFF	0x5270_0000	0x527F_FFFF	1MB	CryptoIsland-300 MHU1 R	CryptoIsland-300 MHU1 R
0x4280_0000	0x428F_FFFF	0x5280_0000	0x528F_FFFF	1MB	QSPI registers	QSPI registers
-	-	0x52E0_0000	0x52E0_0FFF	4KB	-	CryptoIsland-300 Memory Protection Controller
0x6000_0000	0x6FFF_FFFF	0x7000_0000	0x7FFF_FFFF	2GB	Default slave	Unused AHB Master Exp0
-	-	0xF000_0000	0xF000_0FFF	4KB	-	Debug system ROM
-	-	0xF000_1000	0xF000_1FFF	4KB	-	Debug element funnel
-	-	0xF000_2000	0xF000_2FFF	4KB	-	Debug element Cross Trigger Interface (CTI)
-	-	0xF008_0000	0xF00F_FFFF	512KB	-	Debug APB expansion region

3.3 Processor elements

The SSE-200 subsystem in the Musca-B1 test chip implements two processor elements. Each element contains a Cortex-M33 core.

Processor 0, CPU0, is the main processor. It is a Cortex-M33 with FPU and DSP, and no coprocessor. The maximum operating clock frequency is 40.96MHz.

Processor 1, CPU1, is the secondary processor. It is a Cortex-M33 with FPU and DSP, and no coprocessor. The maximum operating clock frequency is 163.84MHz.

This section contains the following subsections:

- [3.3.1 Private processor regions on page 3-58.](#)
- [3.3.2 Instruction cache configuration interface registers on page 3-58.](#)
- [3.3.3 Processor cache programming on page 3-59.](#)
- [3.3.4 Ensuring the cache handles memory modifications on page 3-60.](#)
- [3.3.5 Interrupts on page 3-60.](#)

3.3.1 Private processor regions

Both processor elements in the system implements a private memory region that only it can see.

The base memory addresses of the private processor regions are:

- 0x4001_0000 in the Non-secure region.
- 0x5001_0000 in the Secure region.

See the *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual* for more information on the private processor regions.

3.3.2 Instruction cache configuration interface registers

The following table shows the Instruction cache configuration interface registers. Undefined registers are reserved. Software must not attempt to access these registers.

Table 3-2 Instruction cache configuration interface registers

Offset	Name	Type	Reset	Width	Description
0x0000	ICHWPARAMS	RO	0x0000_0000	32	Hardware Parameter Register
0x0004	ICCTRL	RW	0x0000_0000	32	Instruction cache Control Register
0x0100	ICIRQSTAT	RO	0x0000_0000	32	Interrupt Request Status Register
0x0104	ICHRQSCLR	WO	0x0000_0000	32	Interrupt Status Clear Register
0x0108	ICIRQEN	RW	0x0000_0000	32	Interrupt Enable Register
0x010C	ICDBGFILLERR	RO	0x0000_0000	32	Debug Fill Error Register
0x0300	ICSHR	RO	0x0000_0000	32	Instruction cache Statistic Hit Register
0x0304	ICSMR	RO	0x0000_0000	32	Instruction cache Statistic Mismatch Register
0x0308	ICSUC	RO	0x0000_0000	32	Instruction cache Statistic Uncached Count Register
0x0FD0	PIDR4	RO	0x0000_0004	32	Product ID Register 4
0x0FE4	PIDR1	RO	0x0000_00B8	32	Product ID Register 1

Table 3-2 Instruction cache configuration interface registers (continued)

Offset	Name	Type	Reset	Width	Description
0x0FE8	PIDR2	RO	0x0000_000B	32	Product ID Register 2
0x0FEC	PIDR3	RO	0x0000_0000	32	Product ID Register 3
0x0FF0	CIDR0	RO	0x0000_000D	32	Component ID Register 0
0x0FF4	CIDR1	RO	0x0000_00F0	32	Component ID Register 1
0x0FF8	CIDR2	RO	0x0000_0005	32	Component ID Register 2
0x0FFC	CIDR3	RO	0x0000_00B1	32	Component ID Register 3

Note

- All Instruction cache configuration interface registers are Secure Privilege access only.
- See the *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual* for more information about the Instruction cache configuration interface registers.

3.3.3 Processor cache programming

The following practices and techniques are recommended when programming the L1 cache in the Musca-B1 test chip:

Initialization

After powerup or reset, the cache powers up in a disabled state and begins the invalidation process. Accesses arriving at the cache are not cached and bypass the cache. The cache can be enabled during the invalidation process by setting the CACHEEN control bit in the *Instruction Cache Control Register*, ICCTRL, to 0b1. However, all accesses are still treated as uncached and bypass the cache until the cache invalidation process completes.

At the end of the cache invalidation process, the interrupt status signal, IC, in the *Interrupt Request Status Register*, ICIRQSTAT, is asserted. If that interrupt is already enabled or is enabled later, an interrupt is raised. To enable caching of code fetches, you can poll this status register, or wait for this interrupt to be raised before continuing code execution.

Cache disable

The cache can be disabled by clearing the CACHEEN control bit in the ICCTRL. Outstanding accesses are completed before the cache is disabled. Software can read the CDC bit in ICIRQSTAT Register, or enable the CDC interrupt and wait for the interrupt to arrive, after clearing the CACHEEN bit.

Cache invalidation

You can invalidate the cache by setting the partial invalidate bit, PINV, or the full invalidate bit, FINV, in the ICCTRL Register. Because the cache does not support Locked Lines, setting either of these bits initiates a full cache invalidation. During cache invalidation, all accesses through the cache are treated as uncached and bypass the cache until the invalidation process completes. At the end of the invalidation process, the interrupt status, IC, is asserted. If that interrupt is already enabled, or is enabled later, an interrupt is raised.

Performance targets

The cache improves the average performance of the connected processor by holding local copies of previously accessed or specified memory locations. The improvement in performance cannot be determined precisely because many design parameters, code behavior, and system considerations affect the performance.

The cache can reduce processor performance in the following events:

- Uncacheable memory. The cache adds a cycle of latency to the transaction.
- Writes are treated as uncacheable, and create an extra cycle of bus latency.
- A cache miss causes a fetch to occur, and causes an extra cycle of bus latency for the initial data. Subsequent transactions are also stalled while the rest of the fetch process occurs. The time that is taken for the memory subsystem to return the rest of the WRAP4 transaction determines the extra latency.

3.3.4 Ensuring the cache handles memory modifications

The instruction cache does not support coherency between an external code location and a corresponding code line that is already in the cache.

The software must invalidate the cache to modify the external location.

Caution

Non-coherency between cached lines in the cache and the lines in the external code memory is a security issue.

To invalidate the cache, do the following:

1. Disable the instruction cache.
2. Manually invalidate the full instruction cache.
3. Modify the code space content.
4. Enable the instruction cache.

Cache misses occur when a modification to the Secure Access Unit, or the Memory Protection Controller, changes the security setting of a recently cached memory region. The instruction cache retains the old security attribute and disables hits on the cached line using the new security attribute. This situation can result in Secure and Non-secure versions of the same memory location residing in the cache, reducing its efficiency. If the older cached line, not intended to be available in that system, is accessed with the original access attribute, the presence of the two versions poses a security risk.

3.3.5 Interrupts

The Musca-B1 test chip implements an Arm *Nested Vector Interrupt Controller* (NVIC) and an Arm *Wakeup Interrupt Controller* (WIC).

See the following documentation for more information on the interrupt controller.

- *Arm® Cortex®-M33 Processor Technical Reference Manual*.
- *Arm® v7-M Architecture Reference Manual*.

Caution

The Musca-B1 board does not reset reliably when the `NVIC_SystemReset` function is called. To ensure reliable reset, you must call the function `NVIC_ClearAllPendingIRQ()` before calling `NVIC_SystemReset`.

Nested Vector Interrupt Controller (NVIC) features

The NVIC in the Musca-B1 test chip supports the following features:

- A programmable priority level of 0-255 for each interrupt. A higher level corresponds to a lower priority, so level 0 is the highest interrupt priority.
- Level and pulse detection of interrupt signals.

- Dynamic reprioritization of interrupts.
- Grouping of priority values into group priority and subpriority fields.
- Interrupt tail-chaining.
- An external *Non-Maskable Interrupt* (NMI).

Interrupts from the SSE-200 subsystem

The following table shows the interrupt signals and exceptions to the two processor cores from blocks in the SSE-200 subsystem.

Table 3-3 SSE-200 interrupt signals

Interrupt input	CPU0 and CPU1 interrupt source
NMI	Combined SECURE WATCHDOG, S32KWATCHDOG, and NMI_Expansion
IRQ[0]	NON-SECURE WATCHDOG Reset Request
IRQ[1]	NON-SECURE WATCHDOG Interrupt
IRQ[2]	S32K Timer
IRQ[3]	TIMER 0
IRQ[4]	TIMER 1
IRQ[5]	DUAL TIMER
IRQ[6]	MHU0 CPU0 Interrupt: MHU0 CPU1 Interrupt
IRQ[7]	MHU1 CPU0 Interrupt: MHU1 CPU1 Interrupt
IRQ[8]	Reserved
IRQ[9]	MPC Combined (Secure)
IRQ[10]	PPC Combined (Secure)
IRQ[11]	MSC Combined (Secure)
IRQ[12]	Bridge Error Combined Interrupt (Secure)
IRQ[13]	CPU0 Instruction Cache Invalidation Interrupt
IRQ[14]	Reserved
IRQ[15]	SYS_PPU
IRQ[16]	CPU0_PPU
IRQ[17]	CPU1_PPU
IRQ[18]	CPU0DBG_PPU
IRQ[19]	CPU1DBG_PPU
IRQ[20]	Reserved
IRQ[21]	Reserved
IRQ[22]	RAM0_PPU
IRQ[23]	RAM1_PPU
IRQ[24]	RAM2_PPU
IRQ[25]	RAM3_PPU
IRQ[26]	DBG_PPU
IRQ[27]	Reserved

Table 3-3 SSE-200 interrupt signals (continued)

Interrupt input	CPU0 and CPU1 interrupt source
IRQ[28]	CPU0CTIIRQ0, CPU1CTIIRQ0
IRQ[29]	CPU0CTIIRQ1, CPU1CTIIRQ1
IRQ[31:30]	Reserved

Interrupts from outside the SSE-200 subsystem

The following table shows the expansion interrupt signals, that is, from Musca-B1 test chip blocks outside the SSE-200 subsystem.

Table 3-4 Expansion interrupt signals from blocks outside the SSE-200

Interrupt input	CPU0 and CPU1 interrupt source	Wake up	Description
IRQ[32]	Reserved	-	Reserved
IRQ[33]	GPTIMERINTR	Yes	General-purpose timer combined interrupt.
IRQ[34]	I2C0INTR	-	I ² C0 interrupt
IRQ[35]	I2C1INTR	-	I ² C1 interrupt
IRQ[36]	I2SINTR	-	I ² S interrupt
IRQ[37]	SPIINTR	-	SPI interrupt
IRQ[38]	QSPIINTR	-	QSPI interrupt
IRQ[39]	UARTRXINTR0	-	UART0 receive FIFO interrupt, active HIGH.
IRQ[40]	UARTTXINTR0	-	UART0 transmit FIFO interrupt, active HIGH.
IRQ[41]	UARTRTINTR0	-	UART0 receive timeout interrupt, active HIGH.
IRQ[42]	UARTMSINTR0	-	UART0 modem status interrupt, active HIGH.
IRQ[43]	UARTEINTR0	-	UART0 error interrupt, active HIGH.
IRQ[44]	UARTINTR0	-	UART0 interrupt, active HIGH.
IRQ[45]	UARTRXINTR1	-	UART1 receive FIFO interrupt, active HIGH.
IRQ[46]	UARTTXINTR1	-	UART1 transmit FIFO interrupt, active HIGH.
IRQ[47]	UARTRTINTR1	-	UART1 receive timeout interrupt, active HIGH.
IRQ[48]	UARTMSINTR1	-	UART1 modem status interrupt, active HIGH.
IRQ[49]	UARTEINTR1	-	UART1 error interrupt, active HIGH.
IRQ[50]	UARTINTR1	-	UART1 interrupt, active HIGH.
IRQ[66:51]	GPIOINT[15:0]	-	GPIO interrupts.
IRQ[67]	COMBINT	-	GPIO combined interrupt.
IRQ[68]	PVTINTR	-	PVT sensor interrupt.
IRQ[69]	-	-	Reserved.
IRQ[70]	PWMINT0	-	PWM0 interrupt.
IRQ[71]	RTCINT	-	RTC interrupt.
IRQ[72]	GPTIMERINT1	Yes	General-purpose timer interrupt[1] (Comparator 1).

Table 3-4 Expansion interrupt signals from blocks outside the SSE-200 (continued)

Interrupt input	CPU0 and CPU1 interrupt source	Wake up	Description
IRQ[73]	GPTIMERINT0	Yes	General-purpose timer interrupt[0] (Comparator 0).
IRQ[74]	PWMINT1	-	PWM1 interrupt.
IRQ[75]	PWMINT2	-	PWM2 interrupt.
IRQ[76]	GPIO_COMB_NONSEC_INTR	-	GPIO Non-secure interrupt.
IRQ[77]	SDIO_INTR	-	SDIO interrupt.
IRQ[78]	-	-	Reserved.
IRQ[79]	-	-	
IRQ[80]	-	-	
IRQ[81]	-	-	
IRQ[82]	-	-	
IRQ[83]	-	-	
IRQ[84]	AZ_CRYPTSS_RESET_STATUS	-	CryptoIsland-300 interrupts
IRQ[85]	HOSTMHUS0_INT_ACCESS_NR2R	-	
IRQ[86]	HOSTMHUS0_INT_ACCESS_R2NR	-	
IRQ[88:87]	HOSTMHUR0_IRQ	-	
IRQ[89]	HOSTMHUR0_IRQ_COMB	-	
IRQ[90]	HOSTMHUS1_INT_ACCESS_NR2R	-	
IRQ[91]	HOSTMHUS1_INT_ACCESS_R2NR	-	
IRQ[93:92]	HOSTMHUR1_IRQ	-	
IRQ[94]	HOSTMHUR1_IRQCOMB	-	
IRQ[95]	FLASH0_IRQ	-	eFlash 0 interrupt
IRQ[96]	FLASH1_IRQ	-	eFlash 1 interrupt
IRQ[127:97]	-	-	Reserved

Interrupt controller registers

The following table shows the Musca-B1 test chip interrupt controller registers. Undefined registers are reserved. Software must not attempt to access these registers.

Table 3-5 Summary of interrupt controller registers

Address	Name	Type	Reset value	Description
0xE000E004	ICTR	RO	-	Interrupt Controller Type Register
0xE000_E100-0xE000_E11C	NVIC_ISER0-NVIC_ISER7	RW	0x0000_0000	Interrupt Set Enable Registers
0xE000_E180-0xE000_E19C	NVIC_ICER0-NVIC_ICER7	RW	0x0000_0000	Interrupt Clear Enable Registers
0xE000_E200-0xE000_E21C	NVIC_ISPR0-NVIC_ISPR7	RW	0x0000_0000	Interrupt Set Pending Registers
0xE000_E280-0xE000_E29C	NVIC_ICPR0-NVIC_ICPR7	RW	0x0000_0000	Interrupt Clear Pending Registers

Table 3-5 Summary of interrupt controller registers (continued)

Address	Name	Type	Reset value	Description
0xE000_E300-0xE000_E31C	NVIC_IABR0-NVIC_IABR7	RO	0x0000_0000	Interrupt Active Bit Registers
0xE000_E400-0xE000_E41F	NVIC_IPRO-NVIC_IPR7	RW	0x0000_0000	Interrupt Priority Registers

See the following documents for more information on the interrupt controller:

- *Arm® Cortex®-M33 Processor Technical Reference Manual.*
- *Arm® v7-M Architecture Reference Manual.*

Processor core Interrupt Registers

The SSE-200 block implements CPU0 and CPU1 core Interrupt Registers. The Interrupt Registers enable software to raise interrupts, clear interrupts, and check the written value that raises the interrupts to the cores.

Set and Clear registers support setting and clearing of individual bits which means the individual bits can represent events that can be independently set and cleared.

The CPU0 and CPU1 Interrupt Registers are:

- CPU0INTR_STAT - Core 0 Interrupt Status Register.
- CPU0INTR_SET - Core 0 Interrupt Set Register.
- CPU0INTR_CLR - Core 0 Interrupt Clear Register.
- CPU1INTR_STAT - Core 1 Interrupt Status Register.
- CPU1INTR_SET - Core 1 Interrupt Set Register.
- CPU1INTR_CLR - Core 1 Interrupt Clear Register.

See the following for more information on the CPU0 and CPU1 Interrupt Registers.

- [3.4.8 Message Handling Unit on page 3-90.](#)
- *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual.*

Wakeup Interrupt Controller (WIC)

The WIC is a peripheral that detects an interrupt signal and wakes the processor from deep-sleep mode. The WIC is active only when the system is in deep-sleep mode.

The WIC is not programmable and does not have registers or a user interface. It operates entirely under the control of hardware signals.

When the WIC is enabled and the processor is in deep-sleep mode, the *Power Management Unit* (PMU) can power down most of the processor. When the WIC receives an interrupt, it takes several clock cycles to wake up the processor to a state where it can service the interrupt. Latency is increased in deep-sleep mode.

Note

The IoT System uses latches to implement the WIC, unlike in the standard Cortex-M33 processor. **FCLK** can be gated completely during WIC-based deep-sleep. This complete gating is not a standard Cortex-M33 processor feature.

See the *Arm® Cortex®-M33 Processor Technical Reference Manual* for more information on the WIC.

3.4 Base element

This section describes control registers that are associated with several base element components.

This section contains the following subsections:

- [3.4.1 Internal SRAM regions on page 3-65.](#)
- [3.4.2 Base peripheral regions on page 3-65.](#)
- [3.4.3 CMSDK timers on page 3-65.](#)
- [3.4.4 CMSDK dual timer on page 3-67.](#)
- [3.4.5 CMSDK watchdog timers on page 3-68.](#)
- [3.4.6 Secure Privilege Control Block on page 3-70.](#)
- [3.4.7 Non-secure Privilege Control Block on page 3-84.](#)
- [3.4.8 Message Handling Unit on page 3-90.](#)
- [3.4.9 AHB5 TrustZone Memory Protection Controllers on page 3-91.](#)

3.4.1 Internal SRAM regions

The base element contains four internal SRAM regions of the same size that form a contiguous area of memory. The SRAMs are mapped to both the Secure and Non-secure regions of memory.

A *Memory Protection Controller* (MPC) determines how the memory locations with internal SRAM are mapped to the Secure and Non-secure regions.

See [3.2.2 Peripheral \(expansion\) region memory map on page 3-51](#) and [3.2.6 Complete memory map on page 3-55](#).

3.4.2 Base peripheral regions

The base peripheral regions are where the peripherals of the base element reside. There are four regions, two Secure and two Non-secure.

See [3.2.2 Peripheral \(expansion\) region memory map on page 3-51](#) and [3.2.6 Complete memory map on page 3-55](#). The base peripheral regions are:

- 0x4000_0000 to 0x4000_FFFF is a Non-secure region.
- 0x4008_0000 to 0x400f_FFFF is a Non-secure region.
- 0x5000_0000 to 0x5000_FFFF is a Secure region.
- 0x5008_0000 to 0x500f_FFFF is a Secure region.

Some peripherals are aliased to both the Secure and the Non-secure regions. The Peripheral Protection Controllers determine the final mapping to both the Secure and Non-secure regions and Privileged or Non-Privileged access support.

3.4.3 CMSDK timers

The base element of the Musca-B1 test chip contains two CMSDK timers and associated control registers.

TIMER 0 registers are at the following base memory addresses:

- 0x4000_0000 in the Non-secure region.
- 0x5000_0000 in the Secure region.

TIMER 1 registers are at the following base memory addresses:

- 0x4000_1000 in the Non-secure region.
- 0x5000_1000 in the Secure region.

Cross Trigger Interface (CTI) triggers from the debug subsystem can halt the timers.

————— Note —————

The EXTIN input of the timers is connected to the CTI debug halt logic, and if there is a debug halt access it is used to stop the timer counter logic.

To enable this functionality, the EXTIN must be enabled by writing to the CTRL Register.

- CTRL bit[2] = 0b1.
- CTRL bit[1] = 0b0.

The timers reside in the PD_SYS power domain and are reset by **nWARMRESETSYS**.

See the *Arm® Cortex®-M System Design Kit Technical Reference Manual*.

The following table shows the CMSDK timer control registers in the base element in address offset order from the base memory address. Undefined registers are reserved. Software must not attempt to access these registers.

Table 3-6 CMSDK timer control registers summary

Offset	Name	Type	Reset	Width	Function
0x0000	CTRL	RW	0x0000_0000	32	Bit[3]: Interrupt enable. Bit[2]: Select external input as clock. Bit[1]: Select external input as enable. Bit[0]: Enable.
0x0004	VALUE	RW	0x0000_0000	32	Current value.
0x0008	RELOAD	RW	0x0000_0020	32	Reload value. A write to this register sets the current value.
0x000C	INSTATUS INTCLEAR	RW	0x0000_0020	32	Timer interrupt. Write 0x1 to clear.
0x0FD0	PID4	RO	0x0000_0004	32	Peripheral ID Register 4
0x0FD4	PID5	RO	0x0000_0000	32	Peripheral ID Register 5
0x0FD8	PID6	RO	0x0000_0000	32	Peripheral ID Register 6
0x0FDC	PID7	RO	0x0000_0000	32	Peripheral ID Register 7
0x0FE0	PID0	RO	0x0000_0022	32	Peripheral ID Register 0. Bits [7:0] Part number [7:0].
0x0FE4	PID1	RO	0x0000_00B8	32	Peripheral ID Register 1: Bits [7:4] jep106_id_3_0. Bits [3:0] Part number [11:8].
0x0FE8	PID2	RO	0x0000_000B	32	Peripheral ID Register 2: Bits [7:4] Revision. Bits [3] jedec_used. Bits [2:0] jep106_id_6_4.
0x0FEC	PID3	RO	0x0000_0000	32	Peripheral ID Register 3: Bits [7:4] ECO revision number. Bits [3:0] Customer modification number.

Table 3-6 CMSDK timer control registers summary (continued)

Offset	Name	Type	Reset	Width	Function
0x0FF0	CID0	RO	0x0000_000D	32	Component ID Register 0
0x0FF4	CID1	RO	0x0000_00F0	32	Component ID Register 1
0x0FF8	CID2	RO	0x0000_0005	32	Component ID Register 2
0x0FFC	CID3	RO	0x0000_00B1	32	Component ID Register 3

3.4.4 CMSDK dual timer

The base element of the Musca-B1 test chip contains a CMSDK dual timer and associated control registers.

The timers can be halted by CTI triggers from the debug subsystem.

The dual timer resides in the PD_SYS power domain and is reset by **nWARMRESETSYS**.

The base memory addresses of the CMSDK dual timer are:

- 0x4000_2000 in the Non-secure region.
- 0x5000_2000 in the Secure region.

See *Arm® Cortex®-M System Design Kit Technical Reference Manual* for full descriptions of the dual timer control registers.

The following table shows the dual timer control registers in the Musca-B1 test chip in address offset order from the base memory address. Undefined registers are reserved. Software must not attempt to access these registers.

Table 3-7 CMSDK dual timer control registers summary

Offset	Name	Type	Reset	Width	Function
0x0000	DTIMER1LOAD	RW	0x0000_0000	32	Dual timer 1 load register.
0x0004	DTIMER1VALUE	RO	0xFFFF_FFFF	32	Dual timer 1 current value register.
0x0008	DTIMER1CONTROL	RW	0x0000_0020	32	Dual timer 1 control register. Bits [31:8] are reserved.
0x000C	DTIMER1INTCLR	WO	-	32	Dual timer 1 interrupt clear register.
0x0010	DTIMER1RIS	RO	0x0000_0000	32	Dual timer 1 raw interrupt status register. Bits [31:1] are reserved.
0x0014	DTIMER1MIS	RO	0x0000_0000	32	Dual timer 1 interrupt status register. Bits [31:1] are reserved.
0x0018	DTIMER1BGLOAD	RW	0x0000_0000	32	Dual timer 1 background load register.
0x0020	DTIMER2LOAD	RW	0x0000_0000	32	Dual timer 2 load register.
0x0024	DTIMER2VALUE	RO	0xFFFF_FFFF	32	Dual timer 2 current value register.
0x0028	DTIMER2CONTROL	RW	0x0000_0020	32	Dual timer 2 control register. Bits [31:8] are reserved.

Table 3-7 CMSDK dual timer control registers summary (continued)

Offset	Name	Type	Reset	Width	Function
0x002C	DTIMER2INTCLR	WO	-	32	Dual timer 2 interrupt clear register.
0x0030	DTIMER2RIS	RO	0x0000_0000	32	Dual timer 2 raw interrupt status register. Bits [31:1] are reserved.
0x0034	DTIMER2MIS	RO	0x0000_0000	32	Dual timer 2 interrupt status register. Bits [31:1] are reserved.
0x0038	DTIMER2BGLOAD	RW	0x0000_0000	32	Dual timer 2 background load register.
0x0F00	DTIMERITCR	RW	0x0000_0000	32	Integration test control register.
0x0F04	DTIMERITOP	WO	0x0000_0000	32	Integration test output set register. Bits [31:2] are reserved.
0x0FD0	DTIMERPERIPHID4	RO	0x0000_0004	32	Peripheral ID Register 4. Bits [31:8] are reserved.
0x0FE0	DTIMERPERIPHID0	RO	0x0000_0023	32	Peripheral ID Register 0. Bits [31:8] are reserved.
0x0FE4	DTIMERPERIPHID1	RO	0x0000_00B8	32	Peripheral ID Register 1. Bits [31:8] are reserved.
0x0FE8	DTIMERPERIPHID2	RO	0x0000_000B	32	Peripheral ID Register 2. Bits [31:8] are reserved.
0x0FEC	DTIMERPERIPHID3	RO	0x0000_0000	32	Peripheral ID Register 3. Bits [31:8] are reserved.
0x0FF0	DTIMERPCCELLID0	RO	0x0000_000D	32	Component ID Register 0. Bits [31:8] are reserved.
0x0FF4	DTIMERPCCELLID1	RO	0x0000_00F0	32	Component ID Register 1. Bits [31:8] are reserved.
0x0FF8	DTIMERPCCELLID2	RO	0x0000_0005	32	Component ID Register 2. Bits [31:8] are reserved.
0x0FFC	DTIMERPCCELLID3	RO	0x0000_00B1	32	Component ID Register 3. Bits [31:8] are reserved.

3.4.5 CMSDK watchdog timers

The base element of the Musca-B1 test chip contains two CMSDK watchdog timers.

The base memory addresses of the two CMSDK watchdog timers are:

- 0x4008_1000 in the Non-secure region.
- 0x5008_1000 in the Secure region.

Each watchdog is permanently mapped to either a Secure or a Non-secure region of address space:

- The Secure watchdog can raise a *Non-Maskable Interrupt* (NMI) to both processor cores. However, in this case, a watchdog reset event resets the entire system.
- The Non-secure watchdog can raise an interrupt to both processor cores. On a watchdog reset request event, a separate interrupt is raised instead, but software can also choose to allow it to directly reset the system.

CTI triggers from the debug subsystem can halt the watchdog timers.

The timers reside in the PD_SYS power domain and are reset by **nWARMRESETSYS**.

See *Arm® Cortex®-M System Design Kit Technical Reference Manual* for more information on the watchdog timers.

The following table shows the watchdog timer control registers in the base element in address offset order from the base memory address. Undefined registers are reserved. Software must not attempt to access these registers.

Table 3-8 CMSDK watchdog timers control registers summary

Offset	Name	Type	Reset	Width	Function
0x0000	WDOGLOAD	RW	0xFFFF_FFFF	32	Watchdog load register. The counter decrements from the value in this register. The count restarts from this value immediately following a write access. Minimum write value: 0b1
0x0004	WDOGVALUE	RO	0xFFFF_FFFF	32	Current value of watchdog counter register.
0x0008	WDOGCONTROL	RW	0x0000_0000	8	Timer 1 control register. Bits [31:2] are reserved.
0x000C	WDOGINTCLR	WO	-	32	Watchdog interrupt clear register.
0x0010	WDOGRIS	RO	0x0000_0000	1	Watchdog interrupt status register. Bits [31:1] are reserved.
0x0014	WDOGMIS	RO	0x0000_0000	1	Watchdog status register. Bits [31:1] are reserved.
0x0C00	WDOGLOCK	RW	0x0000_0000	32	Watchdog lock register.
0x0F00	WDOGITCR	RW	0x0000_0000	32	Watchdog integration test control register. Bits [31:1] are reserved.
0x0F04	WDOGITOP	WO	0x0000_0000	32	Watchdog integration test output set register.
0x0FD0	WDOGPERIPHID4	RO	0x0000_0004	8	Peripheral ID Register 4. Bits [31:8] are reserved.
0x0FE0	WDOGPERIPHID0	RO	0x0000_0024	32	Peripheral ID Register 0. Bits [31:8] are reserved.
0x0FE4	WDOGPERIPHID1	RO	0x0000_00B8	1	Peripheral ID Register 1. Bits [31:8] are reserved.

Table 3-8 CMSDK watchdog timers control registers summary (continued)

Offset	Name	Type	Reset	Width	Function
0x0FE8	WDOGPERIPHID2	RO	0x0000_000B	1	Peripheral ID Register 2. Bits [31:8] are reserved.
0x0FEC	WDOGPERIPHID3	RO	0x0000_0000	32	Peripheral ID Register 3. Bits [31:8] are reserved.
0x0FF0	WDOGCELLID0	RO	0x0000_000D	8	Component ID Register 0. Bits [31:8] are reserved.
0x0FF4	WDOGCELLID1	RO	0x0000_00F0	8	Component ID Register 1. Bits [31:8] are reserved.
0x0FF8	WDOGCELLID2	RO	0x0000_0005	8	Component ID Register 2. Bits [31:8] are reserved.
0x0FFC	WDOGCELLID3	RO	0x0000_00B1	8	Component ID Register 3. Bits [31:8] are reserved.

3.4.6 Secure Privilege Control Block

The Secure Privilege Control Block implements program-visible states that enable software to control security gating units within the design.

The base memory address of the Secure Privilege Control Block is 0x5008_0000.

Writes to the registers must be 32 bits wide. Attempted byte and halfword writes are ignored.

Reads and writes are supported only from Secure Privileged access.

See the *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual* for more information.

The following table shows the registers in address offset order from the base memory address. Undefined registers are reserved. Software must not attempt to access these registers.

Table 3-9 Secure Privilege Control Block registers

Offset	Name	Type	Reset value	Function
0x0000	SPCSECCTRL	RW	0x0000_0000	Secure Privilege Controller Secure Configuration Control Register. See the <i>Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual</i> for more information.
0x0004	BUSWAIT	RW	0x0000_0001	Bus Access wait control after reset. See the <i>Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual</i> for more information.
0x0010	SECRESPCFG	RW	0x0000_0000	Security Violation Response Configuration Register. See the <i>Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual</i> for more information.

Table 3-9 Secure Privilege Control Block registers (continued)

Offset	Name	Type	Reset value	Function
0x0014	NSCCFG	RW	0x0000_0000	Non-secure Callable Configuration for IDAU. See the <i>Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual</i> for more information.
0x001C	SECMPCINTSTATUS	RO	0x0000_0000	Secure MPC Interrupt Status. See <i>SECMPCINTSTATUS Register</i> on page 3-72 for information on how this register is implemented in the Musca-B1 test chip.
0x0020	SECPPCINTSTAT	RO	0x0000_0000	Secure PPC Interrupt Status. See <i>SECPPCINTSTAT Register</i> on page 3-73 for information on how this register is implemented in the Musca-B1 test chip.
0x0024	SECPPCINTCLR	WO	0x0000_0000	Secure PPC Interrupt Clear. See <i>SECPPCINTCLR Register</i> on page 3-74 for information on how this register is implemented in the Musca-B1 test chip.
0x0028	SECPPCINTEN	RW	0x0000_0000	Secure PPC Interrupt Enable. See <i>SECPPCINTEN Register</i> on page 3-75 for information on how this register is implemented in the Musca-B1 test chip.
0x0070	APBNSPPC0	RW	0x0000_0000	Non-secure Access APB slave Peripheral Protection Control #0. This register controls peripherals in the base element. See the <i>Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual</i> for more information.
0x0074	APBNSPPC1	RW	0x0000_0000	Non-secure Access APB slave Peripheral Protection Control #1. This register controls peripherals in the system control element. See the <i>Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual</i> for more information.
0x0084	APBNSPPCEXP1	RW	0x0000_0000	Expansion 0 Non-secure access APB slave Peripheral Protection Control. See <i>APBNSPPCEXP1 Register</i> on page 3-76 for information on how this register is implemented in the Musca-B1 test chip.
0x00B0	APBSPPPC0	RW	0x0000_0000	Secure Unprivileged Access APB slave Peripheral. Protection Control #0. This register controls the PPC within the Base element. See the <i>Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual</i> for more information.
0x00B4	APBSPPPC1	RW	0x0000_0000	Secure Unprivileged Access APB slave Peripheral. Protection Control #1. This register controls the PPC within the System Control element. See the <i>Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual</i> for more information.
0x00C0	APBSPPPCEXP0	RW	0x0000_0000	Expansion 0 Secure Unprivileged access APB slave Peripheral Protection Control. See <i>APBSPPPCEXP0 Register</i> on page 3-79 for information on how this register is implemented in the Musca-B1 test chip.

Table 3-9 Secure Privilege Control Block registers (continued)

Offset	Name	Type	Reset value	Function
0x00C4	APBSPPPCEXP1	RW	0x0000_0000	Expansion 1 Secure Unprivileged access APB slave Peripheral Protection Control. See <i>APBSPPPCEXP1 Register</i> on page 3-81 for information on how this register is implemented in the Musca-B1 test chip.
0x0FD0	PID4	RO	0x0000_0004	Peripheral ID 4
0x0FE0	PID0	RO	0x0000_0052	Peripheral ID 0
0x0FE4	PID1	RO	0x0000_00B8	Peripheral ID 1
0x0FE8	PID2	RO	0x0000_000B	Peripheral ID 2
0x0FEC	PID3	RO	0x0000_0000	Peripheral ID 3
0x0FF0	CID0	RO	0x0000_000D	Component ID 0
0x0FF4	CID1	RO	0x0000_00F0	Component ID 1
0x0FF8	CID2	RO	0x0000_0005	Component ID 2
0x0FFC	CID3	RO	0x0000_00B1	Component ID 3

SECMPCINTSTATUS Register

The SECMPCINTSTATUS Register characteristics are:

Purpose

Stores the interrupt statuses of the *Memory Protection Controllers* (MPCs).

See the *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual* for more information.

Usage constraints

This register is read-only.

Memory offset and full register reset value

See *3.4.6 Secure Privilege Control Block* on page 3-70.

The following table shows the bit assignments of the SECMPCINTSTATUS Register.

Table 3-10 SECMPCINTSTATUS Register bit assignments

Bits	Name	Function
[31:21]	-	Reserved.
[20]	S_MPCAZ_STATUS	Interrupt status of CryptoIsland-300 Memory Protection Controller. Reset value:: 0b0.
[19]	S_MPCFLASH1_STATUS	Interrupt status of eFlash 1 Memory Protection Controller. Reset value: 0b0.
[18]	S_MPCFLASH0_STATUS	Interrupt status of eFlash 0 Memory Protection Controller. Reset value: 0b0.

Table 3-10 SECMPINTSTATUS Register bit assignments (continued)

Bits	Name	Function
[17]	S_MPCSRAM_STATUS	Interrupt status of Code SRAM Memory Protection Controller. Reset value: 0b0.
[16]	S_MPCQSPI_STATUS	Interrupt status of QSPI Memory Protection Controller. Reset value: 0b0.
[15:4]	-	Reserved.
[3]	S_MPCSRAM3_STATUS	Interrupt Status of SRAM bank 3 Memory Protection Controller. Reset value: 0b0.
[2]	S_MPCSRAM2_STATUS	Interrupt Status of SRAM bank 2 Memory Protection Controller. Reset value: 0b0.
[1]	S_MPCSRAM1_STATUS	Interrupt Status of SRAM bank 1 Memory Protection Controller. Reset value: 0b0.
[0]	S_MPCSRAM0_STATUS	Interrupt Status of SRAM bank 0 Memory Protection Controller. Reset value: 0b0.

SECPPCINTSTAT Register

The SECPPCINTSTAT Register characteristics are:

Purpose

Stores the interrupt statuses of *Peripheral Protection Controllers* (PPCs).

See the *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual* for more information.

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.4.6 Secure Privilege Control Block on page 3-70](#).

The following table shows the bit assignments of the SECPPCINTSTAT Register.

Table 3-11 SECPPCINTSTAT Register bit assignments

Bits	Name	Function
[31:21]	-	Reserved.
[20]	S_AHBPPCGPIO_STATUS	Interrupt status of Peripheral Protection Controller for AHB GPIO slave. Reset value: 0b0.

Table 3-11 SECPPCINTSTAT Register bit assignments (continued)

Bits	Name	Function
[19:6]	-	Reserved.
[5]	S_APBPPCSYSP_STATUS	Interrupt status of Peripheral Protection Controller for APB slaves within the Musca-B1 test chip system level peripherals. Reset value: 0b0.
[4]	S_APBPPCFASH_STATUS	Interrupt status of Peripheral Protection Controller for APB slaves within the Flash subsystem elements. Reset value: 0b0.
[3:2]	-	Reserved.
[1]	S_APBPPC1PERIP_STATUS	Interrupt status of Peripheral Protection Controller for APB slaves within the system control element. Reset value: 0b0.
[0]	S_APBPPC0PERIP_STATUS	Interrupt status of Peripheral Protection Controller for APB slaves within the base element. Reset value: 0b0.

SECPPCINTCLR Register

The SECPPCINTCLR Register characteristics are:

Purpose

Clears the *Peripheral Protection Controller* (PPC) interrupts.

See the *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual* for more information.

Usage constraints

This register is write-only.

Memory offset and full register reset value

See [3.4.6 Secure Privilege Control Block](#) on page 3-70.

The following table shows the bit assignments of the SECPPCINTCLR Register.

Table 3-12 SECPPCINTCLR Register bit assignments

Bits	Name	Function
[31:21]	-	Reserved.
[20]	S_AHBPPCGPIO_CLR	Interrupt Clear of Peripheral Protection Controller for AHB slaves within the GPIO. 0b0: No effect. 0b1: Clear interrupt. Reset value: 0b0.

Table 3-12 SECPPCINTCLR Register bit assignments (continued)

Bits	Name	Function
[19:6]	-	Reserved.
[5]	S_APBPPCSYSP_CLR	Interrupt Clear of Peripheral Protection Controller for APB slaves within the peripherals subsystem. 0b0: No effect. 0b1: Clear interrupt. Reset value: 0b0.
[4]	S_APBPPCFASH_CLR	Interrupt Clear of Peripheral Protection Controller for APB slaves within the Flash subsystem. 0b0: No effect. 0b1: Clear interrupt. Reset value: 0b0.
[3:2]	-	Reserved.
[1]	S_APBPPC1PERIP_CLR	Interrupt Clear of Peripheral Protection Controller for APB slaves within the system control element. 0b0: No effect. 0b1: Clear interrupt. Reset value: 0b0.
[0]	S_APBPPC0PERIP_CLR	Interrupt Clear of Protection Controller for APB slaves within the base element. 0b0: No effect. 0b1: Clear interrupt. Reset value: 0b0.

SECPPCINTEN Register

The SECPPCINTEN Register characteristics are:

Purpose

Enables or disables, that is, masks, the *Peripheral Protection Controller* (PPC) interrupts. See the *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual* for more information.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.4.6 Secure Privilege Control Block on page 3-70](#).

The following table shows the bit assignments of the SECPPCINTEN Register.

Table 3-13 SECPPCINTEN Register bit assignments

Bits	Name	Function
[31:21]	-	Reserved.
[20]	S_AHBPPCGPIO_EN	<p>Interrupt Enable of Expansion Peripheral Protection Controller for AHB slaves within the GPIO.</p> <p>0b0: Mask interrupt.</p> <p>0b1: Enable interrupt.</p> <p>Reset value: 0b0.</p>
[19:6]	-	Reserved.
[5]	S_APBPPCSYSP_EN	<p>Interrupt Enable of Expansion Peripheral Protection Controller for APB slaves within the peripherals subsystem.</p> <p>0b0: Mask interrupt.</p> <p>0b1: Enable interrupt.</p> <p>Reset value: 0b0.</p>
[4]	S_APBPPCFLASH_EN	<p>Interrupt Enable of Expansion Peripheral Protection Controller for APB slaves within the Flash subsystem.</p> <p>0b0: Mask interrupt.</p> <p>0b1: Enable interrupt.</p> <p>Reset value: 0b0.</p>
[3:2]	-	Reserved.
[1]	S_APBPPC1PERIP_EN	<p>Interrupt Enable of Expansion Peripheral Protection Controller for APB slaves within the system control element.</p> <p>0b0: Mask interrupt.</p> <p>0b1: Enable interrupt.</p> <p>Reset value: 0b0.</p>
[0]	S_APBPPC0PERIP_EN	<p>Interrupt Enable of <i>Peripheral Protection Controller</i> for APB slaves within the base element.</p> <p>0b0: Mask interrupt.</p> <p>0b1: Enable interrupt.</p> <p>Reset value: 0b0.</p>

APBNSPPCEXP1 Register

The APBNSPPCEXP1 Register characteristics are:

Purpose

Defines access security settings for the associated APB slave *Peripheral Protection Controllers* (PPCs) outside the SSE-200 subsystem.

See the *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual* for more information.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.4.6 Secure Privilege Control Block on page 3-70](#).

The following table shows the bit assignments of the APBNSPPCEXP1 Register.

Table 3-14 APBNSPPCEXP1 Register bit assignments

Bits	Name	Function
[31:16]	-	Reserved.
[15]	NS_SDIO	Defines the access security setting for the SDIO interface: 0b0: Secure access only. 0b1: Non-secure access only. Reset value 0b0.
[14]	NS_PVT	Defines the access security setting for the PVT sensors: 0b0: Secure access only. 0b1: Non-secure access only. Reset value 0b0.
[13]	NS_RTC	Defines the access security setting for the Real Time Clock: 0b0: Secure access only. 0b1: Non-secure access only. Reset value 0b0.
[12]	NS_GPTIMER	Defines the access security setting for the General-purpose timer: 0b0: Secure access only. 0b1: Non-secure access only. Reset value 0b0.
[11]	NS_SCC	Defines the access security setting for the <i>Serial Configuration Control</i> (SCC): 0b0: Secure access only. 0b1: Non-secure access only. Reset value 0b0.

Table 3-14 APBNSPPCEXP1 Register bit assignments (continued)

Bits	Name	Function
[10]	NS_SPI	Defines the access security setting for the SPI interface: 0b0: Secure access only. 0b1: Non-secure access only. Reset value 0b0.
[9]	NS_I2C1	Defines the access security setting for the I ² C1 interface: 0b0: Secure access only. 0b1: Non-secure access only. Reset value 0b0.
[8]	NS_I2C0	Defines the access security setting for the I ² C0 interface: 0b0: Secure access only. 0b1: Non-secure access only. Reset value 0b0.
[7]	-	Reserved.
[6]	NS_UART1	Defines the access security setting for the UART1: 0b0: Secure access only. 0b1: Non-secure access only. Reset value 0b0.
[5]	NS_UART0	Defines the access security setting for the UART0: 0b0: Secure access only. 0b1: Non-secure access only. Reset value 0b0.
[4]	NS_I2S	Defines the access security setting for the I ² S interface: 0b0: Secure access only. 0b1: Non-secure access only. Reset value 0b0.
[3]	NS_PWM2	Defines the access security setting for the PWM2 interface: 0b0: Secure access only. 0b1: Non-secure access only. Reset value 0b0.

Table 3-14 APBNSPPCEXP1 Register bit assignments (continued)

Bits	Name	Function
[2]	NS_PWM1	Defines the access security setting for the PWM1 interface: 0b0: Secure access only. 0b1: Non-secure access only. Reset value 0b0.
[1]	NS_PWM0	Defines the access security setting for the PWM0 interface: 0b0: Secure access only. 0b1: Non-secure access only. Reset value 0b0.
[0]	-	Reserved.

APBSPPCEXP0 Register

The APBSPPCEXP0 Register characteristics are:

Purpose

Defines the Secure Privileged access settings for the associated APB slave *Peripheral Protection Controllers* (PPCs) for the Flash subsystem and CryptoIsland-300.
See the *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual* for more information.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.4.6 Secure Privilege Control Block on page 3-70](#).

The following table shows the bit assignments of the APBSPPCEXP0 Register.

Table 3-15 APBSPPCEXP0 Register bit assignments

Bits	Name	Function
[31:15]	-	Reserved.
[14]	S_AZ_MPC	Defines the Secure Privileged access setting for the CryptoIsland-300 Memory Protection Controller: 0b0: Secure Privileged access only. 0b1: Secure Unprivileged and Privileged access. Reset value 0b0.
[13:9]	-	Reserved.

Table 3-15 APBSPPPCEXP0 Register bit assignments (continued)

Bits	Name	Function
[8]	S_AZMHU1	<p>Defines the Secure Privileged access setting for CryptoIsland-300 Message Handling Unit 1:</p> <p>0b0: Secure Privileged access only.</p> <p>0b1: Secure Unprivileged and Privileged access.</p> <p>Reset value 0b0.</p>
[7]	S_AZMHU0_MPC	<p>Defines the Secure Privileged access setting for CryptoIsland-300 Message Handling Unit 0:</p> <p>0b0: Secure Privileged access only.</p> <p>0b1: Secure Unprivileged and Privileged access.</p> <p>Reset value 0b0.</p>
[6]	S_QSPI_MPC	<p>Defines the Secure Privileged access setting for the QSPI Memory Protection Controller:</p> <p>0b0: Secure Privileged access only.</p> <p>0b1: Secure Unprivileged and Privileged access.</p> <p>Reset value 0b0.</p>
[5]	S_SRAM_MPC	<p>Defines the Secure Privileged access setting for the Code SRAM Memory Protection Controller:</p> <p>0b0: Secure Privileged access only.</p> <p>0b1: Secure Unprivileged and Privileged access.</p> <p>Reset value 0b0.</p>
[4]	S_FLASH1_MPC	<p>Defines the Secure Privileged access setting for the eFlash 1 Memory Protection Controller:</p> <p>0b0: Secure Privileged access only.</p> <p>0b1: Secure Unprivileged and Privileged access.</p> <p>Reset value 0b0.</p>

Table 3-15 APBSPPPCEXP0 Register bit assignments (continued)

Bits	Name	Function
[3]	S_FLASH0_MPC	Defines the Secure Privileged access setting for the eFlash 0 Memory Protection Controller: 0b0: Secure Privileged access only. 0b1: Secure unPrivileged and Privileged access. Reset value 0b0.
[2]	S_QSPI	Defines the Secure Privileged access setting for the QSPI APB interface: 0b0: Secure Privileged access only. 0b1: Secure Unprivileged and Privileged access. Reset value 0b0.
[1]	S_FLASH1	Defines the Secure Privileged access setting for the eFlash 1 controller: 0b0: Secure Privileged access only. 0b1: Secure Unprivileged and Privileged access. Reset value 0b0.
[0]	S_FLASH0	Defines the Secure Privileged access setting for the eFlash 0 controller: 0b0: Secure Privileged access only. 0b1: Secure Unprivileged and Privileged access. Reset value 0b0.

APBSPPPCEXP1 Register

The APBSPPPCEXP1 Register characteristics are:

Purpose

Defines the Secure Unprivileged access settings for the associated APB slave *Peripheral Protection Controllers* (PPCs) for peripherals on the APB PPC Mux.
See the *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual* for more information.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.4.6 Secure Privilege Control Block on page 3-70](#).

The following table shows the bit assignments of the APBSPPPCEXP1 Register.

Table 3-16 APBSPPPCEXP1 Register bit assignments

Bits	Name	Function
[31:16]	-	Reserved.
[15]	S_SDIO	Defines the Secure Unprivileged access setting for the SDIO: 0b0: Secure Privileged access only. 0b1: Secure Unprivileged and Privileged access. Reset value 0b0.
[14]	S_PVT	Defines the Secure Unprivileged access setting for the PVT sensor system: 0b0: Secure Privileged access only. 0b1: Secure Unprivileged and Privileged access. Reset value 0b0.
[13]	S_RTC	Defines the Secure Unprivileged access setting for the <i>Real Time Clock</i> (RTC): 0b0: Secure Privileged access only. 0b1: Secure Unprivileged and Privileged access. Reset value 0b0.
[12]	S_GPTIMER	Defines the Secure Unprivileged access setting for the General-purpose timer: 0b0: Secure Privileged access only. 0b1: Secure Unprivileged and Privileged access. Reset value 0b0.
[11]	S_SCC	Defines the Secure Unprivileged access setting for the <i>Serial Configuration Controller</i> (SCC): 0b0: Secure Privileged access only. 0b1: Secure Unprivileged and Privileged access. Reset value 0b0.
[10]	S_SPI	Defines the Secure Unprivileged access setting for the SPI: 0b0: Secure Privileged access only. 0b1: Secure Unprivileged and Privileged access. Reset value 0b0.

Table 3-16 APBSPPPCEXP1 Register bit assignments (continued)

Bits	Name	Function
[9]	S_I2C1	Defines the Secure Unprivileged access setting for I ² C1: 0b0: Secure Privileged access only. 0b1: Secure Unprivileged and Privileged access. Reset value 0b0.
[8]	S_I2C0	Defines the Secure Unprivileged access setting for I ² C0: 0b0: Secure Privileged access only. 0b1: Secure Unprivileged and Privileged access. Reset value 0b0.
[7]	-	Reserved.
[6]	S_UART1	Defines the Secure Unprivileged access setting for UART1: 0b0: Secure Privileged access only. 0b1: Secure Unprivileged and Privileged access. Reset value 0b0.
[5]	S_UART0	Defines the Secure Unprivileged access setting for UART0: 0b0: Secure Privileged access only. 0b1: Secure Unprivileged and Privileged access. Reset value 0b0.
[4]	S_I2S	Defines the Secure Unprivileged access setting for I ² S: 0b0: Secure Privileged access only. 0b1: Secure Unprivileged and Privileged access. Reset value 0b0.
[3]	S_PWM2	Defines the Secure Unprivileged access setting for PWM2: 0b0: Secure Privileged access only. 0b1: Secure Unprivileged and Privileged access. Reset value 0b0.

Table 3-16 APBSPPCEXP1 Register bit assignments (continued)

Bits	Name	Function
[2]	S_PWM1	Defines the Secure Unprivileged access setting for PWM1: 0b0: Secure Privileged access only. 0b1: Secure Unprivileged and Privileged access. Reset value 0b0.
[1]	S_PWM0	Defines the Secure Unprivileged access setting for PWM0: 0b0: Secure Privileged access only. 0b1: Secure Unprivileged and Privileged access. Reset value 0b0.
[0]	-	Reserved.

3.4.7 Non-secure Privilege Control Block

The Non-secure Privilege Control Block implements program-visible states that enable software to control various security gating units within the design.

The base memory address of the Non-secure Privilege Control Block is 0x4008_0000.

Writes to the registers must be 32 bits wide. Attempted byte and halfword writes are ignored.

Reads and writes are supported only from Non-secure Privileged access.

See the *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual* for more information.

The following table shows the registers in address offset order from the base memory address. Undefined registers are reserved. Software must not attempt to access these registers.

Table 3-17 Non-secure Privilege Control Block registers

Offset	Name	Type	Reset value	Function
0x00B0	APBNSPPPC0	RW	0x0000_0000	Non-secure Unprivileged Access APB slave Peripheral Protection Control 0. See the <i>Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual</i> for more information.
0x00B4	APBNSPPPC1	RW	0x0000_0000	Non-secure Unprivileged Access APB slave Peripheral Protection Control 1. See the <i>Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual</i> for more information.
0x00C0	APBNSPPCEXP0	RW	0x0000_0000	Expansion 0 Non-secure Unprivileged Access APB slave Peripheral Protection Control. See APBNSPPCEXP0 Register on page 3-85 for information on how this register is implemented in the Musca-B1 test chip.

Table 3-17 Non-secure Privilege Control Block registers (continued)

Offset	Name	Type	Reset value	Function
0x00C4	APBNSPPPCEXP1	RW	0x0000_0000	Expansion 1 Non-secure Unprivileged Access APB slave Peripheral Protection Control. See APBNSPPPCEXP1 Register on page 3-87 for information on how this register is implemented in the Musca-B1 test chip.
0x0FD0	PID4	RO	0x0000_0004	Peripheral ID 4
0x0FE0	PID0	RO	0x0000_0053	Peripheral ID 0
0x0FE4	PID1	RO	0x0000_00B8	Peripheral ID 1
0x0FE8	PID2	RO	0x0000_000B	Peripheral ID 2
0x0FEC	PID3	RO	0x0000_0000	Peripheral ID 3
0x0FF0	CID0	RO	0x0000_000D	Component ID 0
0x0FF4	CID1	RO	0x0000_00F0	Component ID 1
0x0FF8	CID2	RO	0x0000_0005	Component ID 2
0x0FFC	CID3	RO	0x0000_00B1	Component ID 3

APBNSPPPCEXP0 Register

The APBNSPPPCEXP0 Register characteristics are:

Purpose

Defines the Non-secure access settings for the associated APB slave *Peripheral Protection Controllers* (PPCs) outside the SSE-200 subsystem.

See the *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual* for more information.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.4.7 Non-secure Privilege Control Block](#) on page 3-84.

The following table shows the bit assignments of the APBNSPPPCEXP0 Register.

Table 3-18 APBNSPPPCEXP0 Register bit assignments

Bits	Name	Function
[31:15]	-	Reserved.
[14]	NS_AZ_MPC	Defines the Non-secure Unprivileged access settings for the CryptoIsland-300 Memory Protection Controller: 0: Non-secure Privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.
[13:9]	-	Reserved.

Table 3-18 APBNSPPPCEXP0 Register bit assignments (continued)

Bits	Name	Function
[8]	NS_AZMHU1_MPC	Defines the Non-secure Unprivileged access settings for CryptoIsland-300 Message Handling Unit 1 Memory Protection Controller: 0: Non-secure Privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.
[7]	NS_AZMHU0_MPC	Defines the Non-secure Unprivileged access settings for the CryptoIsland-300 Message Handling Unit 0 Memory Protection Controller: 0: Non-secure Privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.
[6]	NS_QSPI_MPC	Defines the Non-secure Unprivileged access settings for the QSPI Memory Protection Controller: 0: Non-secure Privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.
[5]	NS_SRAM_MPC	Defines the Non-secure Unprivileged access settings for the Code SRAM Memory Protection Controller: 0: Non-secure Privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.
[4]	NS_FLASH1_MPC	Defines the Non-secure Unprivileged access settings for the eFlash 1 Memory Protection Controller: 0: Non-secure Privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.

Table 3-18 APBNSPPPCEXP0 Register bit assignments (continued)

Bits	Name	Function
[3]	NS_FLASH0_MPC	Defines the Non-secure Unprivileged access settings for the eFlash 0 Memory Protection Controller: 0: Non-secure Privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.
[2]	NS_QSPI	Defines the Non-secure Unprivileged access settings for the QSPI APB interface: 0: Non-secure Privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.
[1]	NS_FLASH1	Defines the Non-secure Unprivileged access settings for the eFlash 1 controller: 0: Non-secure Privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.
[0]	NS_FLASH0	Defines the Non-secure Unprivileged access settings for the eFlash 0 controller: 0: Non-secure Privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.

APBNSPPPCEXP1 Register

The APBNSPPPCEXP1 Register characteristics are:

Purpose

Defines the Non-secure access settings for the associated APB slave *Peripheral Protection Controllers* (PPCs) outside the SSE-200 subsystem.
See the *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual* for more information.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.4.7 Non-secure Privilege Control Block on page 3-84](#).

The following table shows the bit assignments of the APBNSPPPCEXP1 Register.

Table 3-19 APBNSPPPCEXP1 Register bit assignments

Bits	Name	Function
[31:16]	-	Reserved.
[15]	NS_SDIO	Defines the Non-secure access setting for the SDIO: 0: Non-secure privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.
[14]	NS_PVT	Defines the Non-secure access setting for the PVT sensor system: 0: Non-secure privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.
[13]	NS_RTC	Defines the Non-secure access setting for the <i>Real Time Clock</i> (RTC): 0: Non-secure privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.
[12]	NS_GPTIMER	Defines the Non-secure access setting for the General-purpose timer: 0: Non-secure privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.
[11]	NS_SCC	Defines the Non-secure access setting for the <i>Serial Configuration Controller</i> (SCC): 0: Non-secure privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.
[10]	NS_SPI	Defines the Non-secure access setting for the SPI: 0: Non-secure privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.

Table 3-19 APBNSPPPCEXP1 Register bit assignments (continued)

Bits	Name	Function
[9]	NS_I2C1	Defines the Non-secure access setting for I ² C1: 0: Non-secure privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.
[8]	NS_I2C0	Defines the Non-secure access setting for I ² C0: 0: Non-secure privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.
[7]	-	Reserved.
[6]	NS_UART1	Defines the Non-secure access setting for UART1: 0: Non-secure privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.
[5]	NS_UART0	Defines the Non-secure access setting for UART0: 0: Non-secure privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.
[4]	NS_I2S	Defines the Non-secure access setting for I ² S: 0: Non-secure privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.
[3]	NS_PWM2	Defines the Non-secure access setting for PWM2: 0: Non-secure privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.

Table 3-19 APBNSPPPCEXP1 Register bit assignments (continued)

Bits	Name	Function
[2]	NS_PWM1	Defines the Non-secure access setting for PWM1: 0: Non-secure privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.
[1]	NS_PWM0	Defines the Non-secure access setting for PWM0: 0: Non-secure privileged access only. 1: Non-secure Privileged and Unprivileged access. Reset value 0b0.
[0]	-	Reserved.

3.4.8 Message Handling Unit

Two *Message Handling Units* (MHUs) in the base element enable software to raise interrupts to the processor cores.

MHU0 base memory addresses are:

- 0x4000_3000 in the Non-secure region.
- 0x5000_3000 in the Secure region.

MHU1 base memory addresses are:

- 0x4000_4000 in the Non-secure region.
- 0x5000_4000 in the Secure region.

The TrustZone *Peripheral Protection Controller* (PPC) controls the area in which the MHU resides.

Only 32-bit writes are supported. Byte and halfword writes are ignored.

See the *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual*.

The following table shows the MHU0 and MHU1 registers in address offset order from the base memory address. Undefined registers are reserved. Software must not attempt to access these registers.

Table 3-20 MHU registers

Offset	Name	Type	Reset value	Description
0x0000	CPU0INTR_STAT	RO	0x0000_0000	Core 0 interrupt status register.
0x0004	CPU0INTR_SET	WO	0x0000_0000	Core 0 interrupt set register.
0x0008	CPU0INTR_CLR	WO	0x0000_0000	Core 0 interrupt clear register.
0x0010	CPU1INTR_STAT	RO	0x0000_0000	Core 1 interrupt status register.
0x0014	CPU1INTR_SET	WO	0x0000_0000	Core 1 interrupt set register.
0x0018	CPU1INTR_CLR	WO	0x0000_0000	Core 1 interrupt clear register.

Table 3-20 MHU registers (continued)

Offset	Name	Type	Reset value	Description
0x0FD0	PIDR4	RO	0x0000_0004	Peripheral ID 4.
0x0FE0	PIDR0	RW	0x0000_0056	Peripheral ID 0.
0x0FE4	PIDR1	RO	0x0000_00B8	Peripheral ID 1.
0x0FE8	PIDR2	RO	0x0000_0000	Peripheral ID 2.
0x0FEC	PIDR3	WO	0x0000_0000	Peripheral ID 3.
0x0FF0	CIDR0	RO	0x0000_000D	Component ID 0.
0x0FF4	CIDR1	RO	0x0000_00F0	Component ID 1.
0x0FF8	CIDR2	RO	0x0000_0005	Component ID 2.
0x0FFC	CIDR3	RO	0x0000_00B1	Component ID 3.

3.4.9 AHB5 TrustZone Memory Protection Controllers

The Musca-B1 test chip implements AHB5 TrustZone *Memory Protection Controllers* (MPCs) for certain blocks including blocks in the base element.

The base memory addresses of the MPC APB configuration interfaces are in the Secure region. The base memory addresses of the configuration interfaces in the base element are:

- 0x5008_3000 for internal SRAM bank 0.
- 0x5008_4000 for internal SRAM bank 1.
- 0x5008_5000 for internal SRAM bank 2.
- 0x5008_6000 for internal SRAM bank 3.

The following base memory addresses are not in the base element but are shown here for convenience:

- 0x5200_0000 for QSPI.
- 0x5210_0000 for SRAM.
- 0x5220_1000 for eFlash 0.
- 0x5230_0000 for eFlash 1.
- 0x52E0_0000 for CryptoIsland-300.

The AHB5 TrustZone MPC gates transactions towards a memory interface when a security violation occurs. The security checking is done based on block/page level which is configured externally by the security controller through an APB interface.

The configuration registers can only be set by the security controller in the system with secure accesses (PRTO[1]=0). Any type of access can read the identification registers.

APB accesses are internally aligned to word boundaries, so PADDR[1:0] bits are ignored. The PSTRB[3:0] write strobe signals indicate which byte or bytes of the data bus contain valid data.

See the *Arm® CoreLink™ SIE-200 System IP for Embedded Technical Reference Manual*.

The following table shows the AHB5 TrustZone MPC registers in address offset order from the base memory address. Undefined registers are reserved. Software must not attempt to access these registers.

Table 3-21 AHB5 TrustZone MPC registers

Offset	Name	Type	Reset value	Function
0x0000	CTRL	RW	0x0000_0000	Bit[31]: Security lockdown Bit[30:9]: Reserved Bit[8]: Autoincrement Reserved when BLK_SIZE > ADDR_WIDTH-11 Bit[7]: Data interface gating acknowledge (RO) Reserved when GATE_PRESENT = 0 Bit[6]: Data interface gating request. Reserved when GATE_PRESENT = 0 Bit[5]: Reserved Bit[4]: Security error response configuration (CFG_SEC_RESP) 0:RAZ-WI 1: Bus Error Bit[3:0]: Reserved
0x0010	BLK_MAX	RO	-	Maximum value of block-based index register.
0x0014	BLK_CFG	RO	-	Bit[31]: Init in progress Bit[30:4]: Reserved Bit[3:0]: Block size: 0: 32 Bytes 1: 64 Bytes ... 15: 1MByte Block size = 1 << (BLK_CFG+5)
0x0018	BLK_IDX	RW	0x0000_0000	Index value for accessing block-based look up table.
0x001C	BLK_LUT[n]	RW	0x0000_0000	Block-based gating Look Up Table (LUT): Access to block-based look up configuration space pointed to by BLK_IDX. Bit[31:0]: each bit indicates one block: If BLK_IDX is 0x0, bit[0] is block #0, bit[31] is block#31. If BLK_IDX is 0x1, bit[0] is block #32, bit[31] is block#63. If BLK_IDX is 0x2, bit[0] is block#64, bit[31] is block#95 If BLK_IDX is 0xFFF, bit[0] is block#131040, bit[31] is block#131071. The maximum value of BLK_IDX is defined by the BLK_MAX register. For each configuration bit, 0 indicates secure, 1 indicates Non-secure. A full word write or read to this register automatically increments the BLK_IDX by one if enabled by CTRL[8]. The upper bits are reserved if BLK_SIZE > ADDR_WIDTH - 11.
0x0020	INT_STAT	RO	0x0000_0000	Bits[31:1]: Reserved. Bit[0]: mpe_irq triggered.

Table 3-21 AHB5 TrustZone MPC registers (continued)

Offset	Name	Type	Reset value	Function
0x0024	INT_CLEAR	WO	0x0000_0000	Bits[31:1]: Reserved Bit[0]: mpc_irq clear (cleared automatically).
0x0028	INT_EN	RW	0x0000_0000	Bits[31:1]: Reserved. Bit[0]: mpc_irq enable. Enables interrupt output generation. The INT_STAT, INT_INFO1, and INT_INFO2 registers are still set for errors.
0x002C	INT_INFO1	RO	0x0000_0000	haddr[31:0] of the first security violating address. Bits are valid when mpc_irq is triggered. Subsequent security violation transfers remain blocked, that is, not captured in this register and the register retains its value until mpc_irq is cleared.
0x0030	INT_INFO2	RO	0x0000_0000	Additional control bits of the first security violating transfer. Bit [31:18]: Reserved. Bit [17]: cfg_ns . Bit [16]: hnonsec . Bit [15:0]: hmaster . Bits are valid when mpc_irq is triggered. Subsequent security violating transfers remain blocked, that is, not captured in this register and the register retains its value until mpc_irq is cleared.
0x0034	INT_SET	WO	0x0000_0000	Bit[31:1]: Reserved. Bit[0]: mpc_irq set. Debug purpose only. Sets mpc_irq triggered in INT_STAT regardless of the mpc_irq_enable input.
0x0FD0	PIDR4	RO	0x0000_0004	Peripheral ID 4. Bits[7:4] block count. Bits [3:0] jep106_c_code.
0x0FD4	PIDR5	RO	0x0000_0000	Peripheral ID 5 (not used).
0x0FD8	PIDR6	RO	0x0000_0000	Peripheral ID 6, not used.
0x0FDC	PIDR7	RO	0x0000_0000	Peripheral ID 7 (not used).
0x0FE0	PIDR0	RO	0x0000_0060	Peripheral ID 0. Bits [31:8]: Reserved Bits [7:0]. Part number [7:0].
0x0FE4	PIDR1	RO	0x0000_00B8	Peripheral ID 1. Bits[7:4] jep106_id_3_0. Bits[3:0] Part number[11:8]).

Table 3-21 AHB5 TrustZone MPC registers (continued)

Offset	Name	Type	Reset value	Function
0x0FE8	PIDR2	RO	00000_000B	Peripheral ID 2. Bits[7:4] revision. Bit[3] jedec_used Bits[2:0] jep106_id_6_4.
0x0FEC	PIDR3	RO	0x0000_0000	Peripheral ID 3. Bits[7:4] ECO revision number. Bits[3:0] customer modification number.
0x0FF0	CIDR0	RO	0x0000_000D	Component ID 0.
0x0FF4	CIDR1	RO	0x0000_00F0	Component ID 1 (PrimeCell class).
0x0FF8	CIDR2	RO	0x0000_0005	Component ID 2.
0x0FFC	CIDR3	RO	0x0000_00B1	Component ID 3.

Look Up Table examples

The contents of the *Look Up Table* (LUT) can be accessed in several ways that might require different configurations of the autoincrement function of the BLK_IDX register.

To read the full contents of the LUT:

1. Set the autoincrement enable bit, CTRL[8], to 0x1.
2. Read the BLK_MAX register. The value in this register, 0xN, represents the last address in the LUT.
3. Write 0x0 to the BLK_IDX register.
4. Read the BLK_LUT register 0xN times to read the complete LUT.

To write the full contents of the LUT:

1. Set autoincrement enable bit, CTRL[8], to 0x1.
2. Read the BLK_MAX register. This register has a value 0xN which represents the last address in the LUT.
3. Write 0x0 to the BLK_IDX register.
4. Write the new values to the BLK_LUT register 0xN times to fill the complete LUT.

To read/write/modify a single location:

1. Set autoincrement enable bit, CTRL[8], to 0x1.
2. Write the required address to the BLK_IDX.
3. Read the current contents of the LUT.
4. Write the new contents to the LUT.

Note

Even byte accesses can be used to update only the required byte of the register without reading the full contents.

Configuration lockdown

The AHB5 TrustZone MPC provides a configuration lockdown feature that prevents malicious software from changing the security configuration. Writing 0x1 to the security lockdown bit, CTRL[31], enables the configuration lockdown feature.

When the configuration lockdown feature is enabled:

- The lockdown feature can only be disabled by a component reset that resets CTRL[31] to 0x0.
- The following registers are read-only:
 - CTRL.
 - BLK_LUT.
 - INT_EN.

Note

Arm recommends that you write 0x1 to the LUT autoincrement bit, CTRL[8], before enabling the configuration lockdown feature. When the feature is enabled, only LUT reading is available which is simpler when BLK_IDX increments automatically during the read sequence.

3.5 System control element

This section describes the registers that control the blocks in the SSE-200 subsystem.

This section contains the following subsections:

- [3.5.1 System control regions on page 3-96.](#)
- [3.5.2 System Information Register Block on page 3-97.](#)
- [3.5.3 System Control Register Block on page 3-97.](#)
- [3.5.4 CMSDK timer on page 3-100.](#)
- [3.5.5 CMSDK watchdog timer on page 3-101.](#)

3.5.1 System control regions

The system control regions contain the peripherals in the system control element.

The System Control Region occupies the following areas:

- 0x4002_0000 to 0x4003_FFFF which is Non-secure.
- 0x5002_0000 to 0x5003_FFFF which is Secure.

Table 3-22 System control regions

Row ID (alias)	Address		Size	Region name	Description	Security
	From	To				
1 (5)	0x4002_0000	0x4002_0FFF	4KB	SYSINFO	System Information Registers Block	NS
2	0x4002_1000	0x4002_EFFF	-	Reserved	Reserved ^a	-
3 (18)	0x4002_F000	0x4002_FFFF	4KB	S32KTIMER	CMSDK Timer running on S32KCLK .	NS-PPC
4	0x4003_0000	0x4003_FFFF	-	Reserved	Reserved	-
5 (1)	0x5002_0000	0x5002_0FFF	4KB	SYSINFO	System Information Registers Block	S
6	0x5002_1000	0x5002_1FFF	4KB	S_SYSCONTROL	System Control Registers Block	SP
7	0x5002_2000	0x5002_2FFF	4KB	SYS_PPU	System Power Policy Unit	SP
8	0x5002_3000	0x5002_3FFF	4KB	CPU0CORE_PPU	CPU0 Core Power Policy Unit	SP
9	0x5002_4000	0x5002_4FFF	4KB	CPU0DBG_PPU	CPU0 Debug Power Policy Unit	SP
10	0x5002_5000	0x5002_5FFF	4KB	CPU1CORE_PPU	CPU1 Core Power Policy Unit	SP
11	0x5002_6000	0x5002_6FFF	4KB	CPU1DBG_PPU	CPU1 Debug Power Policy Unit	SP
	0x5002_7000	0x5002_7FFF	4KB	CRYPTO_PPU	CryptoCell Power Policy Unit	SP
	0x5002_8000	0x5002_8FFF	-	Reserved	Reserved. ^b	-
12	0x5002_9000	0x5002_9FFF	4KB	DEBUG_PPU	System Debug Power Policy Unit.	SP
13	0x5002_A000	0x5002_AFFF	4KB	RAM0_PPU	SRAM Bank 0 Power Policy Unit	SP
14	0x5002_B000	0x5002_BFFF	4KB	RAM1_PPU	SRAM Bank 1 Power Policy Unit	SP
15	0x5002_C000	0x5002_CFFF	4KB	RAM2_PPU	SRAM Bank 2 Power Policy Unit	SP
16	0x5002_D000	0x5002_DFFF	4KB	RAM3_PPU	SRAM Bank 3 Power Policy Unit	SP
17	0x5002_E000	0x5002_EFFF	4KB	S32KWATCHDOG	CMSDK Watchdog on S32KCLK .	SP

^a This region is RZZ/WI.

^b This region is RAZ/WI.

Table 3-22 System control regions (continued)

Row ID (alias)	Address		Size	Region name	Description	Security
	From	To				
18 (3)	0x5002_F000	0x5002_FFFF	4KB	S32KTIMER	CMSDK Timer on S32KCLK .	S-PPC
19	0x5003_0000	0x5003_FFFF	-	Reserved	Reserved	-

3.5.2 System Information Register Block

The System Information Register Block provides information on the system configuration and identity. This register block is read-only and accessible by accesses of any security attributes.

The base memory addresses of the System Information Register Block are:

- 0x4002_0000 in the Non-secure region.
- 0x5002_0000 in the Secure region.

Note

The System Information Registers Block is visible to both regions without any security protection.

See the *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual*.

The following table shows the System Information registers in address offset order from the base memory address. Undefined registers are reserved. Software must not attempt to access these registers.

Table 3-23 System Information Registers summary

Offset	Name	Access	Reset value	Description	Security
0x000	SYS_VERSION	RO	0x2004_1743	System Version Register	All
0x004	SYS_CONFIG	RO	0x2230_1544	System Hardware Configuration Register	All
0x010 – 0xFCC	Reserved	-	-	-	-
0xFD0	PIDR4	RO	0x0000_0004	Peripheral ID 4	All
0xFD4	PIDR5	RO	0x0	Reserved	-
0xFD8	PIDR6	RO	0x0	Reserved	-
0xFDC	PIDR7	RO	0x0	Reserved	-
0xFE0	PIDR0	RO	0x0000_0058	Peripheral ID 0	All
0xFE4	PIDR1	RO	0x0000_00B8	Peripheral ID 1	All
0xFE8	PIDR2	RO	0x0000_000B	Peripheral ID 2	All
0xFEC	PIDR3	RO	0x0000_0000	Peripheral ID 3	All
0xFF0	CIDR0	RO	0x0000_000D	Component ID 0	All
0xFF4	CIDR1	RO	0x0000_00F0	Component ID 1	All
0xFF8	CIDR2	RO	0x0000_0005	Component ID 2	All
0xFFC	CIDR3	RO	0x0000_00B1	Component ID 3	All

3.5.3 System Control Register Block

The System Control Register Block implements registers for power, clocks, resets, and other general system control.

The base memory address of the System Control Register Block is 0x5002_1000 in the Secure region of the base peripheral region.

The System Control Registers are secure privilege access only and support only 32-bit writes. Attempted byte and halfword writes are ignored.

See the *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual*.

The following table shows the System Control Registers in address offset order from the base memory address. Undefined registers are reserved. Software must not attempt to access these registers.

Table 3-24 System Control Registers summary

Offset	Name	Access	Reset value	Description
0x0000	SECDBGSTAT	RO	0x0000_0000	Secure Debug Configuration Status.
0x0004	SECDBGSET	WO	0x0000_0000	Secure Debug Configuration Set.
0x0008	SECDBGCLR	WO	0x0000_0000	Secure Debug Configuration Clear.
0x000C	SCSECCTRL	RW	0x0000_0000	System Security Control.
0x0010	FCLK_DIV	RW	0x0000_0000	Fast Clock Divider Configuration.
0x0014	SYSCLK_DIV	RW	0x0000_0000	System Clock Divider Configuration.
0x0018	CLOCK_FORCE	RW	0x0000_0000	Clock Force.
0x0100	RESET_SYNDROME	RW	0x0000_0001	Reset syndrome. Register only cleared at Powerup Reset.
0x0104	RESET_MASK	RW	0x0000_0030	Reset mask.
0x0108	SWRESET	WO	0x0000_0000	Software Reset.
0x010C	GRETREG	RW	0x0000_0000	General-purpose retention.
0x0110	INITSVRTOR0	RW	0x0020_0000	Initial Secure Reset Vector Register for CPU0.
0x0114	INITSVRTOR1	RW	0x0020_0000	Initial Secure Reset Vector Register for CPU1.
0x0118	CPUWAIT	RW	0x0000_0000	CPU Boot wait control after reset.
0x011C	NMI_ENABLE	RW	0x0000_0001	NMI Enable.
0x0120	WICCTRL	RW	0x0000_0000	WIC request and acknowledge handshake.
0x0124	EWCTRL	RW	0x0000_0000	External Wakeup Control.
0x0200	PDCM_PD_SYS_SENSE	RW	0x0000_007F	Power Control Dependency Matrix. PD_SYS Power Domain Sensitivity.
0x020C	PDCM_PD_SRAM0_SENSE	RW	0x0000_0000	Power Control Dependency Matrix. PD_SRAM0 Power Domain Sensitivity.
0x0210	PDCM_PD_SRAM1_SENSE	RW	0x0000_0000	Power Control Dependency Matrix. PD_SRAM1 Power Domain Sensitivity.
0x0214	PDCM_PD_SRAM2_SENSE	RW	0x0000_0000	Power Control Dependency Matrix. PD_SRAM2 Power Domain Sensitivity.

Table 3-24 System Control Registers summary (continued)

Offset	Name	Access	Reset value	Description
0x0218	PDCM_PD_SRAM3_SENSE	RW	0x0000_0000	Power Control Dependency Matrix. PD_SRAM3 Power Domain Sensitivity.
0x0FD0	PIDR4	RO	0x0000_0004	Peripheral ID4
0x0FE0	PIDR0	RO	0x0000_0054	Peripheral ID0
0x0FE4	PIDR1	RO	0x0000_00B8	Peripheral ID1
0x0FE8	PIDR2	RO	0x0000_000B	Peripheral ID2
0x0FEC	PIDR3	RO	0x0000_0000	Peripheral ID3
0x0FF0	CIDR0	RO	0x0000_000D	Component ID0
0x0FF4	CIDR1	RO	0x0000_00F0	Component ID1
0x0FF8	CIDR2	RO	0x0000_0005	Component ID2
0x0FFC	CIDR3	RO	0x0000_00B1	Component ID3

FCLK_DIV Register

The FCLK_DIV Register characteristics are:

Purpose

Controls the divider value of clock divider FCLKDIV that derives **FCLK**, in the SSE-200 subsystem, from **MAINCLK** in the Musca-B1 test chip. **FCLK** drives the secondary processor element, CPU1.

Usage constraints

Bits[20:16] are read-only. Bits[4:0] are read/write. The other bits are reserved.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the bit assignments.

Table 3-25 FCLK_DIV Register bit assignments

Bits	Name	Function
[31:21]	-	Reserved.
[20:16]	FCLKDIV_CUR	Current value of FCLKDIV: The division value of FCLKDIV divider is FCLKDIV_CUR+1. These bits are read-only. Reset value 0b00000.

Table 3-25 FCLK_DIV Register bit assignments (continued)

Bits	Name	Function
[15:5]	-	Reserved.
[4:0]	FCLKDIV	Controls FCLKDIV divide value in SSE-200 subsystem: Division value = FCLKDIV+1. These bits are read/write. Reset value 0b00000, no division.

SYSCLOCK_DIV Register

The SYSCLOCK_DIV Register characteristics are:

Purpose

Controls the divider value of clock divider SYSCLOCKDIV that derives **SYSCLOCK** from **FCLK** in the Musca-B1 test chip. **SYSCLOCK** drives the primary processor element, CPU0.

Usage constraints

Bits[20:16] are read-only. Bits[4:0] are read/write. The other bits are reserved.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the bit assignments.

Table 3-26 SYSCLOCK_DIV Register bit assignments

Bits	Name	Function
[31:21]	-	Reserved.
[20:16]	SYSCLOCKDIV_CUR	Current value of SYSCLOCKDIV: The division value of SYSCLOCKDIV divider is SYSCLOCKDIV_CUR+1. These bits are read-only. Reset value 0b00011.
[15:5]	-	Reserved.
[4:0]	SYSCLOCKDIV	Controls SYSCLOCKDIV divide value in SSE-200 subsystem: Division value = SYSCLOCKDIV+1. These bits are read/write. Reset value 0b00011.

3.5.4 CMSDK timer

The system control element implements a CMSDK watchdog timer running on the **S32KCLK** clock.

The base memory addresses of the control registers of the CMSDK timer in the system control element are:

- 0x4002_F000 in the Non-secure region.
- 0x5002_F000 in the Secure region.

The system control element APB *Peripherals Protection Controller* (PPC) determines the region in which the timer resides.

See [3.4.3 CMSDK timers on page 3-65](#) for a summary of the CMSDK timer control registers.

See *Arm® Cortex®-M System Design Kit Technical Reference Manual* for full descriptions of the CMSDK timer control registers.

3.5.5 CMSDK watchdog timer

The system control element implements a CMSDK watchdog timer running on the **S32KCLK** clock.

The CMSDK watchdog timer in the system control element is mapped to the secure region only. The base memory address is:

- 0x5002_E000 in the secure region.

The system control element APB *Peripherals Protection Controller* (PPC) determines the region in which the timer resides.

See [3.4.5 CMSDK watchdog timers on page 3-68](#) for a summary of the CMSDK timer control registers.

See *Arm® Cortex®-M System Design Kit Technical Reference Manual* for full descriptions of the CMSDK timer control registers.

3.6 SSE-200 subsystem debug system

The debug access interface of the SSE-200 subsystem provides access to three debug Access Ports within the debug subsystem. The ports provide access to the System debug region of the memory map, the processor debug Access Ports, and associated debug logic.

System debug region

The system debug region is only accessible through the debug access interface and is not visible to any other master interface in the system.

Debug access interface

The debug access interface of the subsystem provides three access ports (APs) within the debug subsystem. The following table shows the address map of the interface.

Table 3-27 Debug access region interface

Row ID	Address		Size	Region name	Description
	From	To			
1	0x0000	0x00FF	256B	SYSTEM APB-AP	Debug System Access APB-AP.
2	0x0100	0x01FF	256B	CPU0 AHB-AP	CPU0 Access AHB-AP.
3	0x0200	0x02FF	256B	CPU1 AHB-AP	CPU1 Access AHB-AP.
4	0x0300	0xFFFF	-	-	Reserved.

The debug system APB-AP is used to access debug components that are in the debug subsystem, which includes components in the debug element and components that are connected to the debug APB expansion interface. The following table shows the memory map that can be accessed by the system APB-AP.

A CoreSight ROM is also expected at address 0xF008_0000 in the debug expansion logic which catalogs all CoreSight expansion debug components outside the subsystem which are accessible through the debug APB expansion interface.

Table 3-28 System APB-AP address map

Row ID	Address		Size	Region name	Description
	From	To			
1	0x0000_0000	0xFFFF_FFFF	-	-	Reserved.
2	0xF000_0000	0xF000_0FFF	4KB	SYSCROM	Debug System CoreSight ROM.
3	0xF000_1000	0xF000_1FFF	256B	SYSFUNNEL	Debug System trace funnel.
4	0xF000_2000	0xF000_2FFF	-	SYSCFI	Debug System Cross Trigger Interface.
5	0xF000_3000	0xF007_FFFF	500KB	-	Reserved.
6	0xF008_0000	0xF00F_FFFF	512KB	Debug APB Expansion Interface	Debug APB Expansion Interface Region.
4	0xF010_0000	0xFFFF_FFFF	-	-	Reserved.

CPU0 AHB-AP is for CPU0, primary core, debug access and also for certification access. It also maps a CoreSight ROM and a *Granular Power Requester* (GPR).

The values of CERTDISABLE, CERTDISABLED, CERTREADEN, and CERTREADENABLED control the accessibility of the certification access path.

The address map for CPU0 depends on the value of CERTDISABLED.

Note

CERTDISABLE, CERTDISABLED, CERTREADEN, and CERTREADENABLED are indicated by the register SCSECCTRL. See [3.5.3 System Control Register Block](#) on page 3-97 and the *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual*.

The following table shows the map for CPU0 when CERTDISABLED is LOW.

Table 3-29 CPU0 AHB-AP address map when CERTDISABLED is LOW

Row ID	Address		Size	Region name	Description
	From	To			
1	0x0000_0000	0x2FFF_FFFF	-	-	System memory access by the CPU0 debug Access Port.
2	0x3000_0000	0x3000_1FFF	8KB	CERTMEM	Certificate Access Memory region, residing in SRAM0. Write access is allowed and read data is masked to zero if CERTREADENABLED is LOW. Access bypasses the processor core.
3	0x3000_2000	0xF000_7FFF	-	-	System memory access by the CPU0 debug Access Port.
2	0xF000_8000	0xF000_8FFF	4KB	CPU0CSROM	CPU0 Access CoreSight ROM.
3	0xF000_9000	0xF000_9FFF	4KB	CPU0GPR	CPU0 <i>Granular Power Requester</i> (GPR)
4	0xF000_A000	0xFFFF_FFFF	-	-	System memory access by the CPU0 debug Access Port.

The following table shows the map for CPU0 when CERTDISABLED is HIGH.

Table 3-30 CPU0 AHB-AP address map when CERTDISABLED is HIGH

Row ID	Address		Size	Region name	Description
	From	To			
1	0x0000_0000	0xF000_7FFF	-	-	System memory access by the CPU0 debug Access Port.
2	0xF000_8000	0xF000_8FFF	4KB	CPU0CSCROM	CPU0 Access CoreSight ROM.
3	0xF000_9000	0xF000_9FFF	4KB	CPU0GPR	CPU0 <i>Granular Power Requester</i> (GPR).
4	0xF000_A000	0xFFFF_FFFF	-	-	System memory access by the CPU0 debug Access Port.

CPU1 AHB-AP is for CPU1, secondary core, debug access. It also maps a CoreSight ROM and a *Granular Power Requester* (GPR).

The following table shows the memory map for CPU1 AHB-AP.

Table 3-31 CPU1 AHB-AP address map

Row ID	Address		Size	Region name	Description
	From	To			
1	0x0000_0000	0xF000_7FFF	-	-	System memory access by the CPU1 debug Access Port.
2	0xF000_8000	0xF000_8FFF	4KB	CPU1SCROM	CPU1 Access CoreSight ROM.
3	0xF000_9000	0xF000_9FFF	4KB	CPU1GPR	CPU1 <i>Granular Power Requester</i> (GPR).
4	0xF000_A000	0xFFFF_FFFF	-	-	System memory access by the CPU1 debug Access Port.

Security violations from debug memory accesses to system memory through CPU0 AHB-AP or CPU1 AHB-AP are blocked in a similar way to a non-debug failed access. However, in these cases, the PPC or MPC do not raise an interrupt for these failed accesses.

Debug system CoreSight™ ROM

The debug system CoreSight ROM is only accessible through the debug System Access APB-AP and is located at address 0xF000_0000.

The following table shows the CoreSight ROM in address offset order from the base memory address. Undefined locations are reserved. Software must not attempt to read from these locations.

Table 3-32 Debug System CoreSight ROM

Offset	Name	Access	Value	Description
0x000	Entry 0	RO	0x0000_1003	ROM entry that points to debug System trace funnel.
0x004	Entry 1	RO	0x0000_2003	ROM entry that points to debug System Cross Trigger Interface.
0x008	Entry 2	RO	0x0008_0003	ROM entry that points to an external ROM on the APB expansion interface.
0xFCC	MEMTYPE	RO	0x0000_0000	MEMTYPE register.
0xFD0	PIDR4	RO	0x0000_0004	Peripheral ID 4. PIDR4[3:0]: JEP106 continuation code which is set by TARGETIDSYS[11:8] .
0xFE0	PIDR0	RO	0x0000_0043	Peripheral ID 0. PIDR0[7:0]: Part number [7:0] which is set by TARGETIDSYS[23:16] .
0xFE4	PIDR1	RO	0x0000_00B7	Peripheral ID 1. PIDR1[3:0]: Part number [11:8] which is set by TARGETIDSYS[27:24] . PIDR1[7:4], JEP106 identity code [3:0] which is set by TARGETIDSYS[4:1] .
0xFE8	PIDR2	RO	0x0000_000B	Peripheral ID 2. PIDR2[2:0]: JEP106 identity code [6:4] which is set by TARGETIDSYS[7:5] . PIDR2[3]: JEDEC identifier. PIDR2[7:4]: Revision code which is set by TARGETIDSYS[31:28] .
0xFF0	CIDR0	RO	0x0000_000D	Component ID 0.
0xFF4	CIDR1	RO	0x0000_0010	Component ID 1.
0xFF8	CIDR2	RO	0x0000_0005	Component ID 2.
0xFFC	CIDR3	RO	0x0000_00B1	Component ID 3.

Note

The PID values are dependent on the **TARGETIDSYS[31:0]** static configuration signal value. This is set to 0x0743_0477 by default. See *Arm® CoreLink™ SSE-200 Subsystem for Embedded Technical Reference Manual*.

CPU Access CoreSight™ ROM

There are two processor system CoreSight ROMs, one for each processor. Each ROM is accessible through its associated processor access AHB-P at address 0xF000_8000. The two ROMs are identical and each one has the following contents.

Table 3-33 CPU Access CoreSight ROM

Offset	Name	Access	Value	Description
0x000	Entry 0	RO	0x0000_1003	ROM entry that points to the <i>Granular Power Controller</i> (GPC).
0x004	Entry 1	RO	0x0000_2003	ROM entry that points to the internal ROM table of the processor.
0xFCC	MEMTYPE	RO	0x0000_0000	MEMTYPE register.
0xFD0	PIDR4	RO	0x0000_0004	Peripheral ID 4. PIDR4[3:0]: JEP106 continuation code.
0xFE0	PIDR0	RO	0x0000_0043	Peripheral ID 0. PIDR0[7:0]: Part number [7:0].
0xFE4	PIDR1	RO	0x0000_00B7	Peripheral ID 1. PIDR1[3:0]: Part number [11:8]. PIDR1[7:4], JEP106 identity code [3:0].
0xFE8	PIDR2	RO	0x0000_000B	Peripheral ID 2. PIDR2[2:0]: JEP106 identity code [6:4]. PIDR2[3]: JEDEC identifier. PIDR2[7:4]: Revision code.
0xFF0	CIDR0	RO	0x0000_000D	Component ID 0.
0xFF4	CIDR1	RO	0x0000_0010	Component ID 1.
0xFF8	CIDR2	RO	0x0000_0005	Component ID 2.
0xFFC	CIDR3	RO	0x0000_00B1	Component ID 3.

3.7 Real Time Clock

The Musca-B1 test chip implements an Arm PrimeCell Real Time Clock.

The base memory addresses of the *Real Time Clock* (RTC) control registers are:

- 0x4010_D000 in the Non-secure region.
- 0x5010_D000 in the Secure region.

See the *Arm® PrimeCell Real Time Clock (PL031) Technical Reference Manual*.

Caution

Warm reset of the Musca-B1 test chip resets the Real Time Clock.

The following table shows the Real Time Clock registers in the Musca-B1 test chip in address offset order from the base memory address. Undefined registers are reserved. Software must not attempt to access these registers.

Table 3-34 Real Time Clock control registers summary

Offset	Name	Type	Reset	Width	Function
0x0000	RTCDR	RO	0x0000_0000	32	Data register.
0x0004	RTCMR	RW	0x0000_0000	32	Match register.
0x0008	RTCLR	RW	0x0000_0000	8	Load register.
0x000C	RTCCR	RW	0x0000_0000	32	Control register.
0x0010	RTCIMSC	RW	0x0000_0000	1	Interrupt mask set and clear register.
0x0014	RTCRIS	RO	0x0000_0000	1	Raw interrupt status register.
0x0018	RTCMIS	RO	0x0000_0000	32	Masked interrupt status register.
0x001C	RTCICR	WO	0x0000_0000	32	Interrupt clear register.
0x0FE0	RTCPeriphID0	RO	0x0000_0031	8	Peripheral ID register bits [7:0]
0x0FE4	RTCPeriphID1	RO	0x0000_0010	8	Peripheral ID register bits [15:8]
0x0FE8	RTCPeriphID2	RO	0x0000_0004	8	Peripheral ID register bits [23:16]
0x0FEC	RTCPeriphID3	RO	0x0000_0000	8	Peripheral ID register bits [31:24]
0xFF0	RTCPCellID0	RO	0x0000_000D	8	PrimeCell ID register bits [7:0]
0xFF4	RTCPCellID1	RO	0x0000_00F0	8	PrimeCell ID register bits [15:8]
0xFF8	RTCPCellID2	RO	0x0000_0005	8	PrimeCell ID register bits [23:16]
0xFFC	RTCPCellID3	RO	0x0000_00B1	8	PrimeCell ID register bits [31:24]

3.8 General-purpose timer

The Musca-B1 test chip implements a general-purpose timer (GPT) in the **32K** domain.

The base memory addresses of the general-purpose timer control registers are:

- 0x4010_C000 in the Non-secure region.
- 0x5010_C000 in the Secure region.

The following table shows the general-purpose timer registers in address offset order from the base memory address. Undefined registers are reserved. Software must not attempt to access these registers.

Table 3-35 General-purpose timer control registers summary

Offset	Name	Type	Reset	Width	Function
0x0000	GPTRESET	RO	0x0000_0000	32	Reset Control Register. See 3.8.1 GPTRESET Register on page 3-107 .
0x0004	GPTINTM	RW	0x0000_0000	32	Masked interrupt status register. See 3.8.2 GPTINTM Register on page 3-108 .
0x0008	GPTINTC	RW	0x0000_0000	8	Interrupt clear register. See 3.8.3 GPTINTC Register on page 3-108 .
0x0010	GPTALARM0	RW	0x0000_0000	32	ALARM0 data value register. See 3.8.4 GPTALARM0 Register on page 3-109 .
0x0014	GPTALARM1	RW	0x0000_0000	1	ALARM1 data value register. See 3.8.5 GPTALARM1 Register on page 3-109 .
0x0018	GPTINTR	RO	0x0000_0000	1	Raw interrupt status register. See 3.8.6 GPTINTR Register on page 3-110 .
0x001C	GPTCOUNTER	RO	0x0000_0000	32	Counter data value register. See 3.8.7 GPTCOUNTER Register on page 3-110 .

This section contains the following subsections:

- [3.8.1 GPTRESET Register on page 3-107](#).
- [3.8.2 GPTINTM Register on page 3-108](#).
- [3.8.3 GPTINTC Register on page 3-108](#).
- [3.8.4 GPTALARM0 Register on page 3-109](#).
- [3.8.5 GPTALARM1 Register on page 3-109](#).
- [3.8.6 GPTINTR Register on page 3-110](#).
- [3.8.7 GPTCOUNTER Register on page 3-110](#).

3.8.1 GPTRESET Register

The GPTRESET Register characteristics are:

Purpose

- A write resets the general-purpose timer counter to 1.
- A read returns the current value of the general-purpose timer counter.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.8 General-purpose timer on page 3-107](#).

The following table shows the bit assignments of the GPTRESET Register.

Table 3-36 GPTRESET Register bit assignments

Bits	Name	Function
[31:1]	-	Reserved.
[0]	GPTRESET	CPU0 interrupt status. Software reset of the timer counter: 0b0: No effect. 0b1: Software reset. Reset value 0b0.

3.8.2 GPTINTM Register

The GPTINTM Register characteristics are:

Purpose

- Writing 1 to the relevant bit enables the ALARM0 or ALARM1 interrupt.
- Reading the relevant bit gives the current masked status value of the corresponding interrupt.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.8 General-purpose timer on page 3-107](#).

The following table shows the bit assignments of the GPTINTM Register.

Table 3-37 GPTINTM Register bit assignments

Bits	Name	Function
[31:2]	-	Reserved.
[1:0]	GPTINTM	Current masked status of the interrupt. Writing 0b1 enables the ALARM[n] interrupt: 0b0: No effect. 0b1: Enable ALARM[n] interrupt. Bit[1] = ALARM1 interrupt. Bit[0]=ALARM0 interrupt. Reset value 0b00.

3.8.3 GPTINTC Register

The GPTINTC Register characteristics are:

Purpose

- Writing 1 to the relevant bit clears the ALARM0 or ALARM1 interrupt.
- Reading a bit returns the current value of the bit.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.8 General-purpose timer on page 3-107](#).

The following table shows the bit assignments of the GPTINTC Register.

Table 3-38 GPTINTC Register bit assignments

Bits	Name	Function
[31:2]	-	Reserved.
[1:0]	GPTINTC	Writing 0b1 disables the ALARM[n] interrupt: 0b0: No effect. 0b1: Clear interrupt. Bit[1] = ALARM1 interrupt. Bit[0]=ALARM0 interrupt. Reset value 0b00.

3.8.4 GPTALARM0 Register

The GPTALARM0 Register characteristics are:

Purpose

- The ALARM0 data value register, GPTALARM0 stores the 32-bit value that triggers the interrupt when the counter reaches that value.
- Reading the register returns the trigger value.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.8 General-purpose timer on page 3-107](#).

The following table shows the bit assignments of the GPTALARM0 Register.

Table 3-39 GPTALARM0 Register bit assignments

Bits	Name	Function
[31:0]	GPTALARM0_DATA	Value that triggers the ALARM0 interrupt when the counter reaches that value. Reset value 0x0000_0000.

3.8.5 GPTALARM1 Register

The GPTALARM1 Register characteristics are:

Purpose

- The ALARM1 data value register, GPTALARM1 stores the 32-bit value that triggers the interrupt when the counter reaches that value.
- Reading the register returns the trigger value.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.8 General-purpose timer on page 3-107](#).

The following table shows the bit assignments of the GPTALARM1 Register.

Table 3-40 GPTALARM1 Register bit assignments

Bits	Name	Function
[31:0]	GPTALARM1_DATA	Value that triggers the ALARM1 interrupt when the counter reaches that value. Reset value 0x0000_0000.

3.8.6 GPTINTR Register

The GPTINTR Register characteristics are:

Purpose

- The raw interrupt status register, GPTINTR, stores the current raw status value of the corresponding interrupt before masking.
- Reading the register returns the trigger value.

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.8 General-purpose timer on page 3-107](#).

The following table shows the bit assignments of the GPTINTR Register.

Table 3-41 GPTINTR Register bit assignments

Bits	Name	Function
[31:1]	-	Reserved.
[2:0]	GPTINTR	Raw interrupt state, before masking, of the GPTINTR interrupt. <ul style="list-style-type: none"> • Bit[0]: ALARM0 interrupt status. • Bit[1]: ALARM1 interrupt status. • Bit[2]: Or-ed ALARM0 and ALARM1 interrupt status. Reset value 0b000.

3.8.7 GPTCOUNTER Register

The GPTCOUNTER Register characteristics are:

Purpose

- The counter data value register, GPTCOUNTER, stores the current 32-bit value of the general-purpose timer counter.
- Reading the register returns the trigger value.

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.8 General-purpose timer on page 3-107](#).

The following table shows the bit assignments of the GPTCOUNTER Register.

Table 3-42 GPTCOUNTER Register bit assignments

Bits	Name	Function
[31:0]	GPTCOUNTER	Current value of 32-bit timer counter. Reset value 0000_0000.

3.9 PVT sensor control registers

The Musca-B1 test chip implements registers that control the *Process, Voltage, Temperature* (PVT) sensor system.

This section contains the following subsection:

- [3.9.1 PVT sensor control registers summary on page 3-112.](#)

3.9.1 PVT sensor control registers summary

The PVT sensor control registers are mapped to both the Non-secure and Secure regions.

The PVT sensor control registers base addresses are:

- 0x4010_E000 in the Non-secure region.
- 0x5010_E000 in the Secure region.

The following table shows the PVT sensor control registers in address offset order from the base memory address. Undefined registers are reserved. Software must not attempt to access these registers.

Table 3-43 PVT sensor control registers summary

Offset	Name	Type	Reset	Width	Description
0x0000	CTRL_REF_CNTR	RW	0x0000_0000	32	See CTRL_REF_COUNTER Register on page 3-113.
0x0004	CRTL_ENABLE	RW	0x0000_0000	32	See CTRL_ENABLE Register on page 3-114.
0x0008	CTRL_AUTOCLEAR	RW	0xFFFF_FFFF	32	See CTRL_AUTOCLEAR Register on page 3-114.
0x000C	CTRL_CLKSEL	RW	0x0000_0000	32	See CTRL_CLKSEL Register on page 3-115.
0x0010	CTRL_SAMPLE	RW	0x0000_0000	32	See CTRL_SAMPLE Register on page 3-115.
0x0014	CTRL_PERIOD	RW	0x0000_00FF	32	See CTRL_PERIOD Register on page 3-116.
0x0018	OVERFLOW-STATUS	RO	0x0000_0000	32	See OVERFLOW_STATUS Register on page 3-116.
0x001C	INTR_STATUS	RO	0x0000_0000	32	See INTR_STATUS Register on page 3-117.
0x0020	CLEARED_STATUS	RO	0x0000_0000	32	See CLEARED_STATUS Register on page 3-117.
0x0024	SAMPLED_STATUS	RO	0x0000_0000	32	See SAMPLED_STATUS Register on page 3-117.
0x0028	COUNTER_STATUS	RO	0x0000_0000	32	See COUNTER_STATUS Register on page 3-118.
0x002C	NO_OF_SENSORS	RO	0x0000_1001	32	See NO_OF_SENSORS Register on page 3-118.
0x0080	SENSOR0_VAL	RO	0x0000_0001	32	See SENSOR0_VAL Register on page 3-119.
0x0084	SENSOR1_VAL	RO	0x0000_0000	32	See SENSOR1_VAL Register on page 3-119.
0x0088	SENSOR2_VAL	RO	0x0000_0000	32	See SENSOR2_VAL Register on page 3-119.
0x008C	SENSOR3_VAL	RO	0x0000_0000	32	See SENSOR3_VAL Register on page 3-120.
0x0090	SENSOR4_VAL	RO	0x0000_0000	32	See SENSOR4_VAL Register on page 3-120.
0x0094	SENSOR5_VAL	RO	0x0000_0000	32	See SENSOR5_VAL Register on page 3-120.

Table 3-43 PVT sensor control registers summary (continued)

Offset	Name	Type	Reset	Width	Description
0x0098	SENSOR6_VAL	RO	0x0000_0000	32	See SENSOR6_VAL Register on page 3-121 .
0x009C	SENSOR7_VAL	RO	0x0000_0000	32	See SENSOR7_VAL Register on page 3-121 .
0x00A0	SENSOR8_VAL	RO	0x1A40_0000	32	See SENSOR8_VAL Register on page 3-122 .

CTRL_REF_COUNTER Register

The CTRL_REF_COUNTER Register characteristics are:

Purpose

Controls the PVT sensors reference counter.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.9.1 PVT sensor control registers summary on page 3-112](#).

The following table shows the CTRL_REF_COUNTER Register bit assignments.

Table 3-44 CTRL_REF_COUNTER Register bit assignments

Bits	Name	Function
[31:19]	-	Reserved.
[18]	CLEAR_SAMPLED_VAL	Clear sensors sampled flags: 0b0 : No effect. 0b1 : Clear sensors sampled flags. Reset value 0b0 .
[17]	CLEAR_OVERFLOW	Clear sensors overflows: 0b0 : No effect. 0b1 : Clear overflows: Reset value 0b0 .
[16]	CLEAR_CNTR	Clear sensors counters: 0b0 : No effect. 0b1 : Clear counters: Reset value 0b0 .
[15:4]	CTRL_SEL_M38K_MUX_CLK	Reserved.
[3]	CTRL_IRQ_CLEAR	Clear PVT interrupt: 0b0 : No effect. 0b1 : Clear interrupt: Reset value 0b0 .

Table 3-44 CTRL_REF_COUNTER Register bit assignments (continued)

Bits	Name	Function
[2]	CTRL_IRQ_EN	Enable PVT interrupt: 0b0: No effect. 0b1: Clear interrupt: Reset value 0b0.
[1]	CTRL_AUTORESTART_EN	Select operating mode of PVT sensors: 0b0: One-shot mode. 0b1: Repeat mode: Reset value 0b0.
[0]	CTR_CNTR_EN	Enable reference counter: 0b0: Not enabled. 0b1: Enabled: Reset value 0b0.

CTRL_ENABLE Register

The CTRL_ENABLE Register characteristics are:

Purpose

Individually enables or disables the nine PVT sensors.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.9.1 PVT sensor control registers summary on page 3-112](#).

The following table shows the CTRL_ENABLE Register bit assignments.

Table 3-45 CTRL_ENABLE Register bit assignments

Bits	Name	Function
[31:9]	-	Reserved.
[8:0]	CTRL_ENABLE[8:0]	PVT sensors Enable input: 0b0: Not enabled. 0b1: Enabled. Reset value 0x000.

CTRL_AUTOCLEAR Register

The CTRL_AUTOCLEAR Register characteristics are:

Purpose

Individually enables the nine PVT sensors autoclear functions.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.9.1 PVT sensor control registers summary on page 3-112](#).

The following table shows the CTRL_AUTOCLEAR Register bit assignments.

Table 3-46 CTRL_AUTOCLEAR Register bit assignments

Bits	Name	Function
[31:9]	-	Reserved.
[8:0]	CTRL_AUTOCLEAR[8:0]	Enable or disable PVT sensors autoclear functions: 0b0: Not enabled. 0b1: Enabled. Reset value 0x1FF.

CTRL_CLKSEL Register

The CTRL_CLKSEL Register characteristics are:

Purpose

Individually selects the nine PVT sensors input clocks.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.9.1 PVT sensor control registers summary on page 3-112](#).

The following table shows the CTRL_CLKSEL Register bit assignments.

Table 3-47 CTRL_CLKSEL Register bit assignments

Bits	Name	Function
[31:9]	-	Reserved.
[8:0]	CTRL_CLKSEL[8:0]	Selects the PVT sensor input clocks: 0b0: Ring oscillator clock. 0b1: REFCLK. Reset value 0x000.

CTRL_SAMPLE Register

The CTRL_SAMPLE Register characteristics are:

Purpose

Individually initiates the PVT measurements.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.9.1 PVT sensor control registers summary on page 3-112](#).

The following table shows the CTRL_SAMPLE Register bit assignments.

Table 3-48 CTRL_SAMPLE Register bit assignments

Bits	Name	Function
[31:9]		Reserved.
[8:0]	CTRL_SAMPLE[8:0]	Initiate PVT measurements: 0b0: No effect. 0b1: Initiate measurement. Reset value 0x000.

CTRL_PERIOD Register

The CTRL_PERIOD Register characteristics are:

Purpose

Stores the reference counter period in **REFCLK** cycles.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.9.1 PVT sensor control registers summary on page 3-112](#).

The following table shows the CTRL_PERIOD Register bit assignments.

Table 3-49 CTRL_PERIOD Register bit assignments

Bits	Name	Function
[31:0]	CTRL_PERIOD[8:0]	Reference counter period in REFCLK periods: Reset value 0x0000_00FF.

OVERFLOW_STATUS Register

The OVERFLOW_STATUS Register characteristics are:

Purpose

Individually indicates the PVT sensors overflow status.

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.9.1 PVT sensor control registers summary on page 3-112](#).

The following table shows the OVERFLOW_STATUS Register bit assignments.

Table 3-50 OVERFLOW_STATUS Register bit assignments

Bits	Name	Function
[31:9]	-	Reserved.
[8:0]	OVERFLOW_STATUS[8:0]	Indicates the PVT sensors overflow status: 0b0: No overflow. 0b1: Overflow: Reset value 0x000.

INTR_STATUS Register

The INTR_STATUS Register characteristics are:

Purpose

Indicates the reference counter interrupt status.

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.9.1 PVT sensor control registers summary](#) on page 3-112.

The following table shows the INTR_STATUS bit assignments.

Table 3-51 INTR_STATUS Register bit assignments

Bits	Name	Function
[31:1]	-	Reserved.
[0]	INTR_STATUS[8:0]	Indicates the reference counter interrupt status: 0b0: No interrupt. 0b1: Interrupt: Reset value 0b0.

CLEARED_STATUS Register

The CLEARED_STATUS Register characteristics are:

Purpose

Individually indicates the sensor counters cleared status.

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.9.1 PVT sensor control registers summary](#) on page 3-112.

The following table shows the CLEARED_STATUS Register bit assignments.

Table 3-52 CLEARED_STATUS Register bit assignments

Bits	Name	Function
[31:9]	-	Reserved.
[8:0]	CLEARED_STATUS[8:0]	Indicates the sensor counters cleared status: 0b0: Not cleared. 0b1: Cleared. Reset value 0x000.

SAMPLED_STATUS Register

The SAMPLED_STATUS Register characteristics are:

Purpose

Individually indicates that PVT measurements are valid.

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.9.1 PVT sensor control registers summary](#) on page 3-112.

The following table shows the SAMPLED_STATUS Register bit assignments.

Table 3-53 SAMPLED_STATUS Register bit assignments

Bits	Name	Function
[31:9]	-	Reserved.
[8:0]	SAMPLED_STATUS[8:0]	Indicates that PVT measurements are valid: 0b0: Not valid. 0b1: Valid. Reset value 0x000.

COUNTER_STATUS Register

The COUNTER_STATUS Register characteristics are:

Purpose

Stores the current value of the reference counter.

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.9.1 PVT sensor control registers summary](#) on page 3-112.

The following table shows the COUNTER_STATUS Register bit assignments.

Table 3-54 COUNTER_STATUS Register bit assignments

Bits	Name	Function
[31:0]	COUNTER_STATUS[8:0]	Stores the current value of the reference counter. Reset value 0x0000_0000.

NO_OF_SENSORS Register

The NO_OF_SENSORS Register characteristics are:

Purpose

Stores the number of PVT sensors that are implemented on the Musca-B1 test chip.

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.9.1 PVT sensor control registers summary](#) on page 3-112.

The following table shows the NO_OF_SENSORS Register bit assignments.

Table 3-55 NO_OF_SENSORS Register bit assignments

Bits	Name	Function
[31:6]	-	Reserved.
[5:0]	NO_OF_SENSORS	Stores the number of PVT sensors. Reset value 0b001001.

SENSOR0_VAL Register

The SENSOR0_VAL Register characteristics are:

Purpose

Stores the value measured by PVT sensor 0.

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.9.1 PVT sensor control registers summary on page 3-112](#).

The following table shows the SENSOR0_VAL Register bit assignments.

Table 3-56 SENSOR0_VAL Register bit assignments

Bits	Name	Function
[31:0]	SENSOR0_VAL	Value measured by PVT sensor 0. Reset value 0x0000_0000.

SENSOR1_VAL Register

The SENSOR1_VAL Register characteristics are:

Purpose

Stores the value measured by PVT sensor 1.

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.9.1 PVT sensor control registers summary on page 3-112](#).

The following table shows the SENSOR1_VAL Register bit assignments.

Table 3-57 SENSOR1_VAL Register bit assignments

Bits	Name	Function
[31:0]	SENSOR1_VAL	Value measured by PVT sensor 1. Reset value 0x0000_0000.

SENSOR2_VAL Register

The SENSOR2_VAL Register characteristics are:

Purpose

Stores the value measured by PVT sensor 2.

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.9.1 PVT sensor control registers summary](#) on page 3-112.

The following table shows the SENSOR2_VAL Register bit assignments.

Table 3-58 SENSOR2_VAL Register bit assignments

Bits	Name	Function
[31:0]	SENSOR2_VAL	Value measured by PVT sensor 2. Reset value 0x0000_0000.

SENSOR3_VAL Register

The SENSOR3_VAL Register characteristics are:

Purpose

Stores the value measured by PVT sensor 3.

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.9.1 PVT sensor control registers summary](#) on page 3-112.

The following table shows the SENSOR3_VAL Register bit assignments.

Table 3-59 SENSOR3_VAL Register bit assignments

Bits	Name	Function
[31:0]	SENSOR3_VAL	Value measured by PVT sensor 3. Reset value 0x0000_0000.

SENSOR4_VAL Register

The SENSOR4_VAL Register characteristics are:

Purpose

Stores the value measured by PVT sensor 4.

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.9.1 PVT sensor control registers summary](#) on page 3-112.

The following table shows the SENSOR4_VAL Register bit assignments.

Table 3-60 SENSOR4_VAL Register bit assignments

Bits	Name	Function
[31:0]	SENSOR4_VAL	Value measured by PVT sensor 4. Reset value 0x0000_0000.

SENSOR5_VAL Register

The SENSOR5_VAL Register characteristics are:

Purpose

Stores the value measured by PVT sensor 5.

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.9.1 PVT sensor control registers summary on page 3-112](#).

The following table shows the SENSOR5_VAL Register bit assignments.

Table 3-61 SENSOR5_VAL Register bit assignments

Bits	Name	Function
[31:0]	SENSOR5_VAL	Value measured by PVT sensor 5. Reset value 0x0000_0000.

SENSOR6_VAL Register

The SENSOR6_VAL Register characteristics are:

Purpose

Stores the value measured by PVT sensor 6.

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.9.1 PVT sensor control registers summary on page 3-112](#).

The following table shows the SENSOR6_VAL Register bit assignments.

Table 3-62 SENSOR6_VAL Register bit assignments

Bits	Name	Function
[31:0]	SENSOR6_VAL	Value measured by PVT sensor 6. Reset value 0x0000_0000.

SENSOR7_VAL Register

The SENSOR7_VAL Register characteristics are:

Purpose

Stores the value measured by PVT sensor 7.

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.9.1 PVT sensor control registers summary on page 3-112](#).

The following table shows the SENSOR7_VAL Register bit assignments.

Table 3-63 SENSOR7_VAL Register bit assignments

Bits	Name	Function
[31:0]	SENSOR7_VAL	Value measured by PVT sensor 7. Reset value 0x0000_0000.

SENSOR8_VAL Register

The SENSOR8_VAL Register characteristics are:

Purpose

Stores the value measured by PVT sensor 8.

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.9.1 PVT sensor control registers summary](#) on page 3-112.

The following table shows the SENSOR8_VAL Register bit assignments.

Table 3-64 SENSOR8_VAL Register bit assignments

Bits	Name	Function
[31:0]	SENSOR8_VAL	Value measured by PVT sensor 8. Reset value 0x0000_0000.

3.10 **One-Time Programmable (OTP) security**

The Musca-B1 test chip implements memory-mapped registers on the SSE-200 subsystem CoreSight-312 and the CryptoIsland-300 secure enclave. The *One-Time Programmable* (OTP) registers are used for life-cycle management, key storage, and Non-volatile firmware counters.

Once these memory cells have been programmed to `0b1`, they are permanent and cannot be cleared.

Contact your Arm representative for information on the OTP security block.

3.11 CryptoIsland-300 remap at Musca-B1 test chip level

The Musca-B1 test chip supports remap for CryptoIsland-300 using the SCC registers. Configurable masks remove the MSB from CryptoIsland-300 and replace it with a programmable offset to direct transactions with the Musca-B1 test chip level memory map.

Updating CryptoIsland-300 boot ROM code

CryptoIsland-300 can be booted from either its internal ROM or from a dedicated region of eFlash. The AZ_ROM_REMAP_OFFSET and AZ_ROM_REMAP_MASK SCC registers control the selection of boot code.

Setting CryptoIsland-300 Musca-B1 test chip remap address

CryptoIsland-300 requires 256KB of memory space for its boot code which can be anywhere in the range 0x3800_0000 to 0x38FF_FFFF of the host access port. But 0x3800_0000 does not access the memory region of the Musca-B1 test chip code interface. SCC registers AZ_CODE_REMAP_OFFSET and AZ_CODE_REMAP_MASK set the remap address.

Setting CryptoIsland-300 SSE-200 remap address

Remapping is necessary to enable CryptoIsland-300 to access the SSE-200 base elements and the EXP0 peripherals. 0xA000_0000 must be remapped to 0x4000_FFFF. SCC registers AZ_SYS_REMAP_OFFSET and AZ_SYS_REMAP_MASK set the remap address.

The following figure and table show the CryptoIsland-300 remapping scheme.

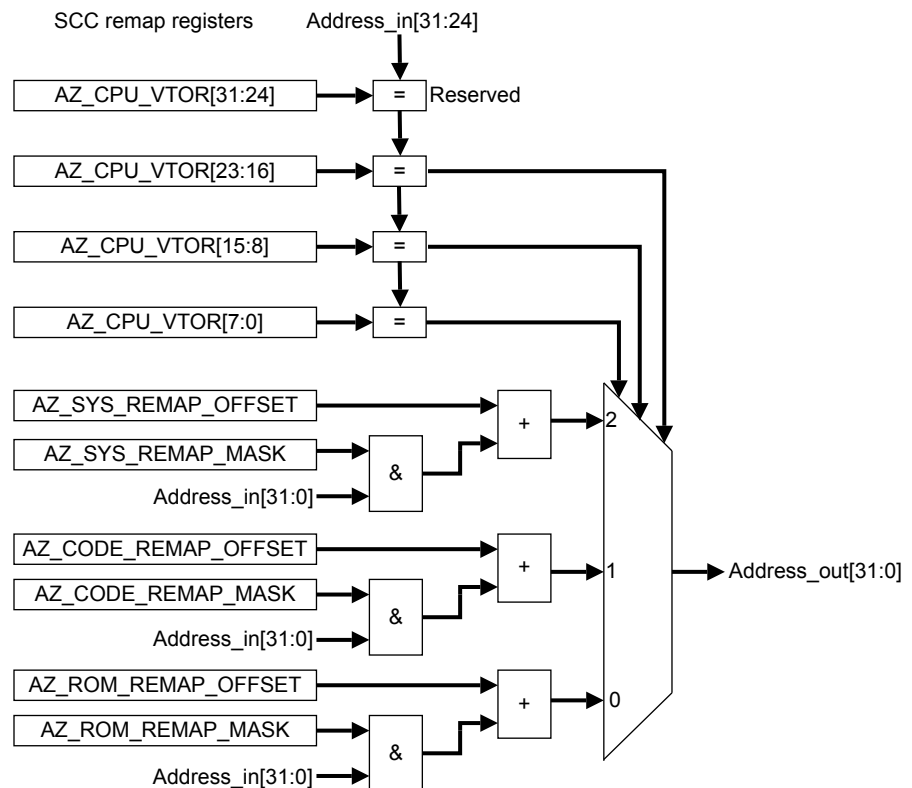


Figure 3-6 CryptoIsland-300 remap scheme

Table 3-65 CryptoIsland-300 remap scheme

Number	CryptoIsland-300 location	CryptoIsland-300 address	Remapped address (SCC default)	Musca-B1:SSE-200 location
0	Internal ROM	0x0000_0000	0x103D_FFFF ¹	Flash subsystem peripherals.
		0x0000_0000+X	0x103D_FFF+X	SSE-200 code interface.
		0x0001_FFFF	0x103F_FFFF	
1	Code access through Host Access Port	0x3800_0000	0x0000_0000	Flash subsystem peripherals.
		0x3800_0000+X	0x0000_0000 ² +X	SSE-200 code interface.
2	System Access Device expansion through Host Access Port	0xA000_0000	0x4000_FFFF ³	SSE-200 base elements.
		0xA000_0000+X	0x4000_FFFF+X	EXP0 peripherals.
		0xA000_0000+256KB	0x4000_FFFF+256KB	

1: SCC registers AZ_ROM_REMAP_OFFSET and AZ_ROM_REMAP_MASK select this address value. The table shows the default values selected by these registers.

2: SCC registers AZ_CODE_REMAP_OFFSET and AZ_CODE_REMAP_MASK select this address value. The table shows the default value that is selected by these registers.

3: SCC registers AZ_SYS_REMAP_OFFSET and AZ_SYS_REMAP_MASK select this address value. The table shows the default value that is selected by these registers.

Related information

[2.7 CryptoCell-312 and CryptoIsland-300 subsystems on page 2-36](#)

[AZ_ROM_REMAP_MASK Register on page 3-186](#)

[AZ_ROM_REMAP_OFFSET Register on page 3-187](#)

[AZ_CODE_REMAP_MASK Register on page 3-187](#)

[AZ_CODE_REMAP_OFFSET Register on page 3-188](#)

[AZ_SYS_REMAP_MASK Register on page 3-188](#)

[AZ_SYS_REMAP_OFFSET Register on page 3-189](#)

3.12 Serial Configuration Control registers

The *Serial Configuration Control* (SCC) registers contain the initial settings of blocks before bootup. Write and read accesses to the registers during runtime enable software to alter and to read the block settings.

This section contains the following subsections:

- [3.12.1 IOMUX registers on page 3-126.](#)
- [3.12.2 SCC registers summary on page 3-130.](#)

3.12.1 IOMUX registers

The IOMUX registers, which are a subset of the SCC register bank, control the multiplexer logic that drives Musca-B1 test chip I/O pins PA37-PA0.

The multiplexer controls Musca-B1 test chip I/O PA37-PA0. The following figure shows the multiplexer logic.

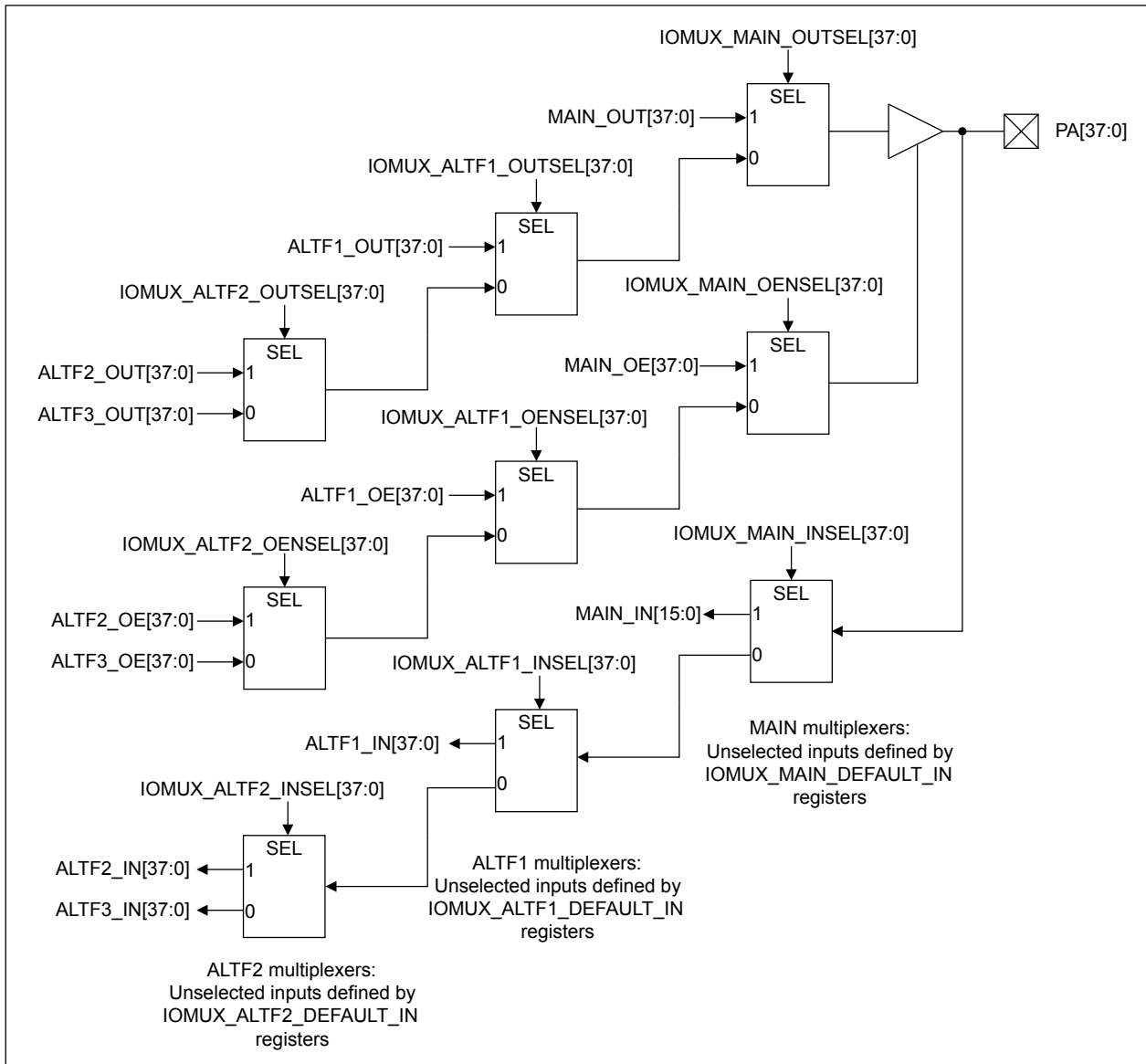


Figure 3-7 Test chip I/O multiplexer logic

The IOMUX registers control the IOMUX multiplexer logic. The following table shows the IOMUX registers in offset order from the SCC base memory address of 0x5010_B000:

Note

See [3.12.2 SCC registers summary](#) on page 3-130 for the read/write access characteristics.

Table 3-66 IOMUX registers

Offset	Register	Register function	Register description
0x0068	IOMUX_MAIN_INSEL_0	Controls Musca-B1 test chip I/O PA31-PA0. Connects Musca-B1 test chip input to either MAIN_IN or ALTF1.	IOMUX_MAIN_INSEL_0 Register on page 3-158
0x006C	IOMUX_MAIN_INSEL_1	Controls the Musca-B1 test chip I/O PA37-PA32. Connects Musca-B1 test chip input to either MAIN_IN or ALTF1.	IOMUX_MAIN_INSEL_1 Register on page 3-158
0x0070	IOMUX_MAIN_OUTSEL_0	Controls the Musca-B1 test chip I/O PA31-PA0. Connects either MAIN_OUT or ALTF1 to Musca-B1 test chip output.	IOMUX_MAIN_OUTSEL_0 Register on page 3-159
0x0074	IOMUX_MAIN_OUTSEL_1	Controls the Musca-B1 test chip I/O PA37-PA32. Connects either MAIN_OUT or ALTF1 to Musca-B1 test chip output.	IOMUX_MAIN_OUTSEL_1 Register on page 3-160
0x0078	IOMUX_MAIN_OENSEL_0	Controls the Musca-B1 test chip I/O PA31-PA0. Selects either MAIN_OE or ALTF1_OENSEL as Musca-B1 test chip output enable signal.	IOMUX_MAIN_OENSEL_0 Register on page 3-161
0x007C	IOMUX_MAIN_OENSEL_1	Controls the Musca-B1 test chip I/O PA37-PA32. Selects either MAIN_OE or ALTF1_OENSEL as Musca-B1 test chip output enable signal.	IOMUX_MAIN_OENSEL_1 Register on page 3-161
0x0080	IOMUX_MAIN_DEFAULT_IN_0	Controls the Musca-B1 test chip I/O PA31-PA0. Drives unselected outputs of MAIN input multiplexers to defined logic levels to prevent floating nodes.	IOMUX_MAIN_DEFAULT_IN_0 Register on page 3-162
0x0084	IOMUX_MAIN_DEFAULT_IN_1	Controls the Musca-B1 test chip I/O PA37-PA32. Drives unselected outputs of MAIN input multiplexers to defined logic levels to prevent floating nodes.	IOMUX_MAIN_DEFAULT_IN_1 Register on page 3-163
0x0088	IOMUX_ALTF1_INSEL_0	Controls the Musca-B1 test chip I/O PA31-PA0. Routes connection from MAIN input multiplexer to either ALTF1_IN or ALTF2.	IOMUX_ALTF1_INSEL_0 Register on page 3-163

Table 3-66 IOMUX registers (continued)

Offset	Register	Register function	Register description
0x008C	IOMUX_ALTF1_INSEL_1	Controls the Musca-B1 test chip I/O PA37-PA32. Routes connection from MAIN input multiplexer to either ALTF1_IN or ALTF2.	<i>IOMUX_ALTF1_INSEL_1 Register on page 3-164</i>
0x0090	IOMUX_ALTF1_OUTSEL_0	Controls the Musca-B1 test chip I/O PA31-PA0. Connects either ALTF1_OUT or ALTF2 to MAIN output multiplexer.	<i>IOMUX_ALTF1_OUTSEL_0 Register on page 3-165</i>
0x0094	IOMUX_ALTF1_OUTSEL_1	Controls the Musca-B1 test chip I/O PA37-PA32. Connects either ALTF1_OUT or ALTF2 to MAIN output multiplexer.	<i>IOMUX_ALTF1_OUTSEL_1 Register on page 3-165</i>
0x0098	IOMUX_ALTF1_OENSEL_0	Controls the Musca-B1 test chip I/O PA31-PA0. Connects either ALTF1_OE or ALTF2 to MAIN_OESEL multiplexer.	<i>IOMUX_ALTF1_OENSEL_0 Register on page 3-166</i>
0x009C	IOMUX_ALTF1_OENSEL_1	Controls the Musca-B1 test chip I/O PA37-PA32. Connects either ALTF1_OE or ALTF2 to MAIN_OESEL multiplexer.	<i>IOMUX_ALTF1_OENSEL_1 Register on page 3-167</i>
0x00A0	IOMUX_ALTF1_DEFAULT_IN_0	Controls the Musca-B1 test chip I/O PA31-PA0. Drives unselected outputs of ALTF1 input multiplexers to defined logic levels to prevent floating nodes.	<i>IOMUX_ALTF1_DEFAULT_IN_0 Register on page 3-167</i>
0x00A4	IOMUX_ALTF1_DEFAULT_IN_1	Controls the Musca-B1 test chip I/O PA37-PA32. Drives unselected outputs of ALTF1 input multiplexers to defined logic levels to prevent floating nodes.	<i>IOMUX_ALTF1_DEFAULT_IN_1 Register on page 3-168</i>
0x00A8	IOMUX_ALTF2_INSEL_0	Controls the Musca-B1 test chip I/O PA31-PA0. Routes connection from ALTF1 input multiplexers to either ALTF2_IN or ALTF3_IN.	<i>IOMUX_ALTF2_INSEL_0 Register on page 3-169</i>
0x00AC	IOMUX_ALTF2_INSEL_1	Controls the Musca-B1 test chip I/O PA37-PA32. Routes connection from ALTF1 input multiplexers to either ALTF2_IN or ALTF3_IN.	<i>IOMUX_ALTF2_INSEL_1 Register on page 3-169</i>

Table 3-66 IOMUX registers (continued)

Offset	Register	Register function	Register description
0x00B0	IOMUX_ALTF2_OUTSEL_0	Controls the Musca-B1 test chip I/O PA31-PA0. Connects either ALTF1_OUT or ALTF3_OUT to ALTF1 output data multiplexer.	IOMUX_ALTF2_OUTSEL_0 Register on page 3-170
0x00B4	IOMUX_ALTF2_OUTSEL_1	Controls the Musca-B1 test chip I/O PA37-PA32. Connects either ALTF1_OUT or ALTF3_OUT to ALTF1 output data multiplexer.	IOMUX_ALTF2_OUTSEL_1 Register on page 3-171
0x00B8	IOMUX_ALTF2_OENSEL_0	Controls the Musca-B1 test chip I/O PA31-PA0. Connects either ALTF2_OE or ALTF3_OE to ALTF1_OENSEL multiplexer.	IOMUX_ALTF2_OENSEL_0 Register on page 3-171
0x00BC	IOMUX_ALTF2_OENSEL_1	Controls the Musca-B1 test chip I/O PA37-PA32. Connects either ALTF2_OE or ALTF3_OE to ALTF1_OENSEL multiplexer.	IOMUX_ALTF2_OENSEL_1 Register on page 3-172
0x00C0	IOMUX_ALTF2_DEFAULT_IN_0	Controls the Musca-B1 test chip I/O PA32-PA0. Drives unselected outputs of ALTF2 input multiplexers to defined logic levels to prevent floating nodes.	IOMUX_ALTF2_DEFAULT_IN_0 Register on page 3-173
0x00C4	IOMUX_ALTF2_DEFAULT_IN_1	Controls the Musca-B1 test chip I/O PA37-PA32. Drives unselected outputs of ALTF2 input multiplexers to defined logic levels to prevent floating nodes.	IOMUX_ALTF2_DEFAULT_IN_1 Register on page 3-173

See [2.2.2 Test chip multiplexed I/O on page 2-23](#) for the ALTF1 and ALTF2 pin functions.

Related information

[2.2.2 Test chip multiplexed I/O on page 2-23](#)

3.12.2 SCC registers summary

The base memory address of the SCC registers is 0x5010_B000 in the Secure region. The registers are not mapped to the Non-secure region.

The following table shows the registers in offset order from the base memory address. Undefined registers are reserved. Software must not attempt to access these registers.

Table 3-67 SCC registers summary

Offset	Name	Type	Reset	Width	Description
0x0000	CLK_CTRL_SEL	RW	0x0000_0072	32	See <i>CLK_CTRL_SEL Register</i> on page 3-135.
0x0004	CLK_PLL_PREDIV_CTRL	RW	0x0000_0000	32	See <i>CLK_PLL_PREDIV_CTRL Register</i> on page 3-137.
0x000C	CLK_POSTDIV_CTRL_FLASH	RW	0x0000_0001	32	See <i>CLK_POSTDIV_CTRL_FLASH Register</i> on page 3-138.
0x0010	CLK_POSTDIV_QSPI	RW	0x0000_0001	32	See <i>CLK_POSTDIV_CTRL_QSPI Register</i> on page 3-138.
0x0014	CLK_POSTDIV_RTC	RW	0x0000_7FFF	32	See <i>CLK_POSTDIV_CTRL_RTC Register</i> on page 3-139.
0x0018	CLK_POSTDIV_SD	RW	0x0000_0001	32	See <i>CLK_POSTDIV_CTRL_SD Register</i> on page 3-139.
0x001C	CLK_POSTDIV_TEST	RW	0x0000_000A	32	See <i>CLK_POSTDIV_CTRL_TEST Register</i> on page 3-140.
0x0020	CTRL_BYPASS_DIV	RW	0x0000_0001	32	See <i>CTRL_BYPASS_DIV Register</i> on page 3-140 .
0x0024	PLL_CTRL_PLL0_CLK	RW	0x0000_0000	32	See <i>PLL_CTRL_PLL0_CLK Register</i> on page 3-141.
0x0028	PLL_POSTDIV_CTRL_PLL0_CLK	RW	0x0000_0000	32	See <i>PLL_POSTDIV_CTRL_PLL0_CLK Register</i> on page 3-142.
0x002C	PLL_CTRL_MULT_PLL0_CLK	RW	0x0000_1388	32	See <i>PLL_CTRL_MULT_PLL0_CLK Register</i> on page 3-143.
0x0030	CLK_CTRL_ENABLE	RW	0x0000_FFFF	32	See <i>CLK_CTRL_ENABLE Register</i> on page 3-143.
0x0034	CLK_STATUS	RW	0x0000_0003	32	See <i>CLK_STATUS Register</i> on page 3-145.
0x0040	RESET_CTRL	RW	0xFFFF_FFFF	32	See <i>RESET_CTRL Register</i> on page 3-146.
0x0044	PWR_CTRL	RW	0x0402_0000	32	See <i>PWR_CTRL Register</i> on page 3-148.
0x0048	DBG_CTRL	RW	0x0000_001F	32	See <i>DBG_CTRL Register</i> on page 3-150.
0x004C	SRAM_CTRL	RW	0x4810_0000	32	See <i>SRAM_CTRL Register</i> on page 3-152.
0x0050	INTR_CTRL	RW	0x0000_0000	32	See <i>INTR_CTRL Register</i> on page 3-154.
0x0054	CLK_TEST_CTRL	RW	0x0000_0000	32	See <i>CLK_TEST_CTRL Register</i> on page 3-155.
0x0058	CPU0_VTOR	RW	0x1000_0000	32	See <i>CPU0_VTOR Register</i> on page 3-156.
0x0060	CPU1_VTOR	RW	0x1000_0000	32	See <i>CPU1_VTOR Register</i> on page 3-157.
0x0064	AZ_CPU_VTOR	RW	0x00A0_3800	32	See <i>AZ_CPU_VTOR Register</i> on page 3-157.

Table 3-67 SCC registers summary (continued)

Offset	Name	Type	Reset	Width	Description
0x0068	IOMUX_MAIN_INSEL_0	RW	0xFFFF_FFFF	32	See <i>IOMUX_MAIN_INSEL_0 Register</i> on page 3-158. and 3.12.1 IOMUX registers on page 3-126.
0x006C	IOMUX_MAIN_INSEL_1	RW	0xFFFF_FFFF	32	See <i>IOMUX_MAIN_INSEL_1 Register</i> on page 3-158. and 3.12.1 IOMUX registers on page 3-126.
0x0070	IOMUX_MAIN_OUTSEL_0	RW	0xFFFF_FFFF	32	See <i>IOMUX_MAIN_OUTSEL_0 Register</i> on page 3-159. and 3.12.1 IOMUX registers on page 3-126.
0x0074	IOMUX_MAIN_OUTSEL_1	RW	0xFFFF_FFFF	32	See <i>IOMUX_MAIN_OUTSEL_1 Register</i> on page 3-160. and 3.12.1 IOMUX registers on page 3-126.
0x0078	IOMUX_MAIN_OENSEL_0	RW	0xFFFF_FFFF	32	See <i>IOMUX_MAIN_OUTSEL_1 Register</i> on page 3-160. and 3.12.1 IOMUX registers on page 3-126.
0x007C	IOMUX_MAIN_OENSEL_1	RW	0xFFFF_FFFF	32	See <i>IOMUX_MAIN_OENSEL_1 Register</i> on page 3-161. and 3.12.1 IOMUX registers on page 3-126.
0x0080	IOMUX_MAIN_DEFAULT_IN_0	RW	0x0000_0000	32	See <i>IOMUX_MAIN_DEFAULT_IN_0 Register</i> on page 3-162 and 3.12.1 IOMUX registers on page 3-126.
0x0084	IOMUX_MAIN_DEFAULT_IN_1	RW	0x0000_0000	32	See <i>IOMUX_MAIN_DEFAULT_IN_1 Register</i> on page 3-163 and 3.12.1 IOMUX registers on page 3-126.
0x0088	IOMUX_ALTF1_INSEL_0	RW	0x0000_0000	32	See <i>IOMUX_ALTF1_INSEL_0 Register</i> on page 3-163 and 3.12.1 IOMUX registers on page 3-126.
0x008C	IOMUX_ALTF1_INSEL_1	RW	0x0000_0000	32	See <i>IOMUX_ALTF1_INSEL_1 Register</i> on page 3-164 and 3.12.1 IOMUX registers on page 3-126.
0x0090	IOMUX_ALTF1_OUTSEL_0	RW	0xFFFF_FFFF	32	See <i>IOMUX_ALTF1_OUTSEL_0 Register</i> on page 3-165 and 3.12.1 IOMUX registers on page 3-126.
0x0094	IOMUX_ALTF1_OUTSEL_1	RW	0xFFFF_FFFF	32	See <i>IOMUX_ALTF1_OUTSEL_1 Register</i> on page 3-165 and 3.12.1 IOMUX registers on page 3-126.
0x0098	IOMUX_ALTF1_OENSEL_0	RW	0xFFFF_FFFF	32	See <i>IOMUX_ALTF1_OENSEL_0 Register</i> on page 3-166 and 3.12.1 IOMUX registers on page 3-126.

Table 3-67 SCC registers summary (continued)

Offset	Name	Type	Reset	Width	Description
0x009C	IOMUX_ALTF1_OENSEL_1	RW	0xFFFF_FFFF	32	See <i>IOMUX_ALTF1_OENSEL_1 Register</i> on page 3-167 and 3.12.1 IOMUX registers on page 3-126.
0x00A0	IOMUX_ALTF1_DEFAULT_IN_0	RW	0x0000_0000	32	See <i>IOMUX_ALTF1_DEFAULT_IN_0 Register</i> on page 3-167 and 3.12.1 IOMUX registers on page 3-126.
0x00A4	IOMUX_ALTF1_DEFAULT_IN_1	RW	0x0000_0000	32	See <i>IOMUX_ALTF1_DEFAULT_IN_1 Register</i> on page 3-168 and 3.12.1 IOMUX registers on page 3-126.
0x00A8	IOMUX_ALTF2_INSEL_0	RW	0x0000_0000	32	See <i>IOMUX_ALTF2_INSEL_0 Register</i> on page 3-169 and 3.12.1 IOMUX registers on page 3-126.
0x00AC	IOMUX_ALTF2_INSEL_1	RW	0x0000_0000	32	See <i>IOMUX_ALTF2_INSEL_1 Register</i> on page 3-169 and 3.12.1 IOMUX registers on page 3-126.
0x00B0	IOMUX_ALTF2_OUTSEL_0	RW	0xFFFF_FFFF	32	See <i>IOMUX_ALTF2_OUTSEL_0 Register</i> on page 3-170 and 3.12.1 IOMUX registers on page 3-126.
0x00B4	IOMUX_ALTF2_OUTSEL_1	RW	0xFFFF_FFFF	32	See <i>IOMUX_ALTF2_OUTSEL_1 Register</i> on page 3-171 and 3.12.1 IOMUX registers on page 3-126.
0x00B8	IOMUX_ALTF2_OENSEL_0	RW	0xFFFF_FFFF	32	See <i>IOMUX_ALTF2_OENSEL_0 Register</i> on page 3-171 and 3.12.1 IOMUX registers on page 3-126.
0x00BC	IOMUX_ALTF2_OENSEL_1	RW	0xFFFF_FFFF	32	See <i>IOMUX_ALTF2_OENSEL_1 Register</i> on page 3-172 and 3.12.1 IOMUX registers on page 3-126.
0x00C0	IOMUX_ALTF2_DEFAULT_IN_0	RW	0x0000_0000	32	See <i>IOMUX_ALTF2_DEFAULT_IN_0 Register</i> on page 3-173 and 3.12.1 IOMUX registers on page 3-126.
0x00C4	IOMUX_ALTF2_DEFAULT_IN_1	RW	0x0000_0000	32	See <i>IOMUX_ALTF2_DEFAULT_IN_1 Register</i> on page 3-173 and 3.12.1 IOMUX registers on page 3-126.
0x00E8	IOPAD_DSO_0	RW	0xFFFF_FFFF	32	See <i>IOPAD_DSO_0 and IOPAD_DSI_0 Registers</i> on page 3-174.
0x00EC	IOPAD_DSO_1	RW	0xFFFF_FFC0	32	See <i>IOPAD_DSO_1 and IOPAD_DSI_1 Registers</i> on page 3-175.
0x00F0	IOPAD_DSI_0	RW	0x000F_FFFF	32	<i>IOPAD_DSO_0 and IOPAD_DSI_0 Registers</i> on page 3-174

Table 3-67 SCC registers summary (continued)

Offset	Name	Type	Reset	Width	Description
0x00F4	IOPAD_DS1_1	RW	0xFFFF_FFFF	32	See <i>IOPAD_DS0_1 and IOPAD_DS1_1 Registers</i> on page 3-175.
0x00F8	IOPAD_PE_0	RW	0xFFFF_FFFF	32	See <i>IOPAD_PE_0 and IOPAD_PE_1 Registers</i> on page 3-176.
0x00FC	IOPAD_PE_1	RW	0xFFFF_FFFF	32	See <i>IOPAD_PE_0 and IOPAD_PE_1 Registers</i> on page 3-176.
0x0100	IOPAD_PS_0	RW	0xFC1F_FFFF	32	See <i>IOPAD_PS_0 and IOPAD_PS_1 Registers</i> on page 3-176.
0x0104	IOPAD_PS_1	RW	0xFFFF_FFFF	32	See <i>IOPAD_PS_0 and IOPAD_PS_1 Registers</i> on page 3-176.
0x0108	IOPAD_SR_0	RW	0x0000_0000	32	See <i>IOPAD_SR_0 and IOPAD_SR_1 Registers</i> on page 3-177.
0x010C	IOPAD_SR_1	RW	0x0000_0000	32	See <i>IOPAD_SR_0 and IOPAD_SR_1 Registers</i> on page 3-177.
0x0110	IOPAD_IS_0	RW	0xFFFF_FFFF	32	See <i>IOPAD_IS_0 and IOPAD_IS_1 Registers</i> on page 3-178.
0x0114	IOPAD_IS_1	RW	0xFFFF_FFFF	32	See <i>IOPAD_IS_0 and IOPAD_IS_1 Registers</i> on page 3-178.
0x0118	PVT_CTRL	RW	0x0000_0000	32	See <i>PVT_CTRL Register</i> on page 3-178.
0x0130	SPARE0	RW	0x0000_0000	32	See <i>SPARE0 Register</i> on page 3-179.
0x013C	STATIC_CONF_SIG1	RW	0x0000_0000	32	See <i>STATIC_CONF_SIG1 Register</i> on page 3-180.
0x01A0	FLASH_DIN_0	RW	0x0000_0000	32	See <i>FLASH_DIN_0 Register</i> on page 3-181.
0x01A4	FLASH_DIN_1	RW	0x0000_0000	32	See <i>FLASH_DIN_1 Register</i> on page 3-181.
0x01A8	FLASH_DIN_2	RW	0x0000_0000	32	See <i>FLASH_DIN_2 Register</i> on page 3-182.
0x01AC	FLASH_DIN_3	RW	0x0000_0000	32	See <i>FLASH_DIN_3 Register</i> on page 3-182.
0x01C0	FLASH0_DOUT_0	RO	0xFFFF_FFFF	32	See <i>FLASH0_DOUT_0 Register</i> on page 3-182.
0x01C4	FLASH0_DOUT_1	RO	0xFFFF_FFFF	32	See <i>FLASH0_DOUT_1 Register</i> on page 3-183.
0x01C8	FLASH0_DOUT_2	RO	0xFFFF_FFFF	32	See <i>FLASH0_DOUT_2 Register</i> on page 3-183.
0x01CC	FLASH0_DOUT_3	RO	0xFFFF_FFFF	32	See <i>FLASH0_DOUT_3 Register</i> on page 3-184.
0x01D0	FLASH1_DOUT_0	RO	0xFFFF_FFFF	32	See <i>FLASH1_DOUT_0 Register</i> on page 3-184.
0x01D4	FLASH1_DOUT_1	RO	0xFFFF_FFFF	32	See <i>FLASH1_DOUT_1 Register</i> on page 3-184.
0x01D8	FLASH1_DOUT_2	RO	0xFFFF_FFFF	32	See <i>FLASH1_DOUT_2 Register</i> on page 3-185.

Table 3-67 SCC registers summary (continued)

Offset	Name	Type	Reset	Width	Description
0x01DC	FLASH1_DOUT_3	RO	0xFFFF_FFFF	32	See <i>FLASH1_DOUT_3 Register</i> on page 3-185.
0x01E0	SELECTION_CONTROL_REG	RW	0x0100_0200	32	See <i>SELECTION_CONTROL_REG Register</i> on page 3-185.
0x01E4	AZ_ROM_REMAP_MASK	RW	0x0001_FFFF	32	See <i>AZ_ROM_REMAP_MASK Register</i> on page 3-186.
0x01E8	AZ_ROM_REMAP_OFFSET	RW	0x1A20_0000	32	See <i>AZ_ROM_REMAP_OFFSET Register</i> on page 3-187.
0x01EC	AZ_CODE_REMAP_MASK	RW	0x00FF_FFFF	32	See <i>AZ_CODE_REMAP_MASK Register</i> on page 3-187.
0x01F0	AZ_CODE_REMAP_OFFSET	RW	0x0000_0000	32	See <i>AZ_CODE_REMAP_OFFSET Register</i> on page 3-188.
0x01F4	AZ_SYS_REMAP_MASK	RW	0x0003_FFFF	32	See <i>AZ_SYS_REMAP_MASK Register</i> on page 3-188.
0x01F8	AZ_SYS_REMAP_OFFSET	RW	0x4001_0000	32	See <i>AZ_SYS_REMAP_OFFSET Register</i> on page 3-189.
0x0200	AZ_CTRL	RW	0x0000_0600	32	See <i>AZ_CTRL Register</i> on page 3-189.
0x0208	SSE_OTP_RD_DATA	RO	0x0000_0000	32	See <i>SSE200_OTP_RD_DATA Register</i> on page 3-191.
0x0210	AZ_OTP_RD_DATA	RO	0x0000_0000	32	See <i>AZ_OTP_RD_DATA Register</i> on page 3-191.
0x021C	SPARE_CTRL0	RW	0x0000_0000	32	See <i>SPARE_CTRL0 Register</i> on page 3-192.
0x0220	SPARE_CTRL1	RW	0x0000_0000	32	See <i>SPARE_CTRL1 Register</i> on page 3-192.
0x0400	CHIP_ID	RO	0x07D0_0477	32	See <i>CHIP_ID Register</i> on page 3-192.

CLK_CTRL_SEL Register

The CLK_CTRL_SEL Register characteristics are:

Purpose

Controls the clock select multiplexers.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the CLK_CTRL_SEL Register bit assignments.

Table 3-68 CLK_CTRL_SEL Register bit assignments

Bits	Name	Function
[31:12]	-	Reserved.
[11:7]	CTRL_SEL_TEST_MUX_CLK[4:0]	<p>Select TESTMUX input:</p> <p>0b00000: No output.</p> <p>0b00001: JTAG_TCK.</p> <p>0b00010: PRE_MUX_CLK.</p> <p>0b00011: SCCCLK.</p> <p>0b00100: SSE_200_SWCLK.</p> <p>0b00101: 32K.</p> <p>0b00110: REF_MUX_CLK.</p> <p>0b00111: RM38K.</p> <p>0b01000: FASTCLK.</p> <p>0b01001: PLL0_CLK.</p> <p>0b01010: PRE_MUX_CLK.</p> <p>0b01011: PRE_PLL_CLK.</p> <p>0b01100: SYSSYSUGCLK.</p> <p>0b01101: FLCLK.</p> <p>0b01110: DAPSWCLK</p> <p>0b01111: MAINCLK.</p> <p>0b10000: REFCLK</p> <p>0b10001: CLK1HZ.</p> <p>0b10010: RM38KCLK</p> <p>0b10100: SDPHYCLK.</p> <p>0b10101: QSPIPHYCLK.</p> <p>0b10110: RFMOD_CLK.</p> <p>0b10111: PVT_SENSOR_OUT.</p> <p>0b11000: I2SCLK0.</p> <p>0b11001: I2SCLK1.</p> <p>0b11010: I2SCLK2.</p> <p>Undefined settings are reserved.</p> <p>Reset value 0b00000.</p>
[6]	SEL_RM38P4_PREMUX_CLK	<p>Select RM38KPREMUX input:</p> <p>0b0: SYSSYSUGCLK.</p> <p>0b1: NRM138P4.</p> <p>Reset value 0b1.</p>

Table 3-68 CLK_CTRL_SEL Register bit assignments (continued)

Bits	Name	Function
[5]	SEL_SCCMUX_CLK	Select SCCMUX input: 0b0: SCCCLK. 0b1: PRE_MUX_CLK. Reset value 0b1.
[4]	SEL_RM38KMUX_CLK	Select RM38KMUX input: 0b0: REF_MUX_CLK. 0b1: RM38K. Reset value 0b1.
[3]	SEL_REFMUX_CLK	Select REFMUX input: 0b0: PRE_MUX_CLK. 0b1: PRE_PLL_CLK. Reset value 0b0.
[2]	SEL_MAINMUX_CLK	Select MAINMUX input: 0b0: PLL0_CLK. 0b1: PRE_MUX_CLK. Reset value 0b0.
[1]	SEL_DAPSWMUX_CLK	Select DAPSWMUX input: 0b0: PRE_MUX_CLK. 0b1: TCK. Reset value 0b1.
[0]	SEL_PREMUX_CLK	Select PREMUX input: 0b0: 32K. 0b1: FASTCLK. Reset value 0b0.

CLK_PLL_PREDIV_CTRL Register

The CLK_PLL_PREDIV_CTRL Register characteristics are:

Purpose

Controls the PLL pre-divider division value.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the CLK_PLL_PREDIV_CTRL Register bit assignments.

Table 3-69 CLK_PLL_PREDIV_CTRL Register bit assignments

Bits	Name	Function
[31:10]	-	Reserved.
[9:0]	PREDIV_CTRL[9:0]	PLL0 pre-divider value: Divison value =PREDIV_CTRL+1. 0x00: Minimum divide value =1, no division. 0x3FF: Maximum divide value =1024. Reset value 0x000, no division.

CLK_POSTDIV_CTRL_FLASH Register

The CLK_POSTDIV_CTRL_FLASH Register characteristics are:

Purpose

Controls the eFlash controller clock divider, FLASHDIV, division value.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the bit assignments.

Table 3-70 CLK_POSTDIV_CTRL_FLASH Register bit assignments

Bits	Name	Function
[31:8]	-	Reserved.
[7:0]	POSTDIV_CTRL_FLASH_DIV[7:0]	eFlash controller clock divider, FLASHDIV, division value: Divison value =POSTDIV_CTRL_RFMOD_DIV+1. 0x00: Minimum division value =1 (no division). 0xFF: Maximum division value =256. Reset value 0x01, division value=2.

CLK_POSTDIV_CTRL_QSPI Register

The CLK_POSTDIV_CTRL_QSPI Register characteristics are:

Purpose

Controls the QSPI clock post PLL clock divider, QSPIDIV, division value.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the CLK_POSTDIV_CTRL_QSPI bit assignments.

Table 3-71 CLK_POSTDIV_CTRL_QSPI Register bit assignments

Bits	Name	Function
[31:8]	-	Reserved.
[7:0]	POSTDIV_CTRL_QSPI_DIV[7:0]	QSPI clock divider, QSPIDIV, division value: Division value = POSTDIV_CTRL_QSPI_DIV + 1. 0x00: Minimum division value = 1 (no division). 0xFF: Maximum division value = 256. Reset value 0x01, division value = 2.

CLK_POSTDIV_CTRL_RTC Register

The CLK_POSTDIV_CTRL_RTC Register characteristics are:

Purpose

Controls the RTC clock post PLL clock divider, RTCDIV, division value.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the CLK_POSTDIV_CTRL_RTC Register bit assignments.

Table 3-72 CLK_POSTDIV_CTRL_RTC Register bit assignments

Bits	Name	Function
[31:0]	POSTDIV_CTRL_RTC_DIV[31:0]	RTC clock divider division value: Division value = POSTDIV_CTRL_RTC_DIV + 1. 0x00: Minimum division value = 1 (no division). 0xFFFF_FFFF: Maximum division value = 32768. Reset value 0xFFFF_FFFF.

CLK_POSTDIV_CTRL_SD Register

The CLK_POSTDIV_CTRL_SD Register characteristics are:

Purpose

Controls the SD clock post PLL clock divider, SDDIV, division value.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the CLK_POSTDIV_CTRL_SD Register bit assignments.

Table 3-73 CLK_POSTDIV_CTRL_SD Register bit assignments

Bits	Name	Function
[31:8]	-	Reserved.
[7:0]	POSTDIV_CTRL_SD_DIV[7:0]	SD clock divider, SDDIV, division value: Division value = POSTDIV_CTRL_SD_DIV + 1. 0x00: Minimum division value = 1 (no division). 0xFF: Maximum division value = 256. Reset value 0x01, division value = 2.

CLK_POSTDIV_CTRL_TEST Register

The CLK_POSTDIV_CTRL_TEST Register characteristics are:

Purpose

Controls the TEST_CLK clock post PLL clock divider, TESTDIV, division value.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the CLK_POSTDIV_CTRL_TEST Register bit assignments.

Table 3-74 CLK_POSTDIV_CTRL_TEST Register bit assignments

Bits	Name	Function
[31:8]	-	Reserved.
[7:0]	POSTDIV_CTRL_TEST_DIV[7:0]	TEST_CLK clock divider, TESTDIV, division value: Division value = POSTDIV_CTRL_SD_DIV + 1. 0x00: Minimum division value = 1 (no division). 0xFF: Maximum division value = 256. Reset value 0x0A.

CTRL_BYPASS_DIV Register

The CTRL_BYPASS_DIV Register characteristics are:

Purpose

Controls the post PLL clock divider bypass functions.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the CTRL_BYPASS_DIV Register bit assignments.

Table 3-75 CTRL_BYPASS_DIV Register bit assignments

Bits	Name	Function
[31:7]	-	Reserved.
[6]	BYPASS_TEST_DIV_CLK	Bypass clock divider TESTDIV: 0b0: Not bypass. 0b0: Bypass. Reset value 0b0.
[5]	BYPASS_SD_DIV_CLK	Bypass clock divider SDDIV: 0b0: Not bypass. 0b0: Bypass. Reset value 0b0.
[4]	BYPASS_RTC_DIV_CLK	Bypass clock divider RTCDIV: 0b0: Not bypass. 0b0: Bypass. Reset value 0b0.
[3]	BYPASS_QSPI_DIV_CLK	Bypass clock divider QSPIDIV: 0b0: Not bypass. 0b0: Bypass. Reset value 0b0.
[2:1]	-	Reserved.
[0]	BYPASS_DIV_PLL_DIV_PREDIV_CLK	Bypass clock divider PREDIV: 0b0: Not bypass. 0b0: Bypass. Reset value 0b1.

PLL_CTRL_PLL0_CLK Register

The PLL_CTRL_PLL0_CLK Register characteristics are:

Purpose

Controls PLL0.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the PLL_CTRL_PLL0_CLK Register bit assignments.

Table 3-76 PLL_CTRL_PLL0_CLK Register bit assignment

Bits	Name	Function
[31:5]	-	Reserved.
[4]	BYPASS_PLL0	Bypass PLL0: 0b0: Not bypassed. 0b0: Bypassed. Reset value 0b0.
[3]	PD_FOUTVCOPD	Power down FOUTVCOPD: 0b0: Not powered down. 0b0: Powered down. Reset value 0b0.
[2]	PD_FOUTPOSTDIV2PD	Power down FOUTPOSTDIV2PD: 0b0: Not powered down. 0b0: Powered down. Reset value 0b0.
[1]	PD_FOUTPOSTDIV1PD	Power down FOUTPOSTDIV1PD: 0b0: Not powered down. 0b0: Powered down. Reset value 0b0.
[0]	PD_PLL0	Power down PLL0: 0b0: Not powered down. 0b0: Powered down. Reset value 0b0.

PLL_POSTDIV_CTRL_PLL0_CLK Register

The PLL_POSTDIV_CTRL_PLL0_CLK Register characteristics are:

Purpose

Controls clock post PLL clock divider, POSTDIV, division value.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the PLL_POSTDIV_CTRL_PLL0_CLK Register bit assignments.

Table 3-77 PLL_POSTDIV_CTRL_PLL0_CLK Register bit assignment

Bits	Name	Function
[31:4]	-	Reserved.
[3:0]	PLL_POSTDIV_CTRL_PLL0_CLK[3:0]	PLL clock divider, POSTDIV, division value: Divison value =PLL_POSTDIV_CTRL_PLL0_CLK+1. 0x0: Minimum division value =1 (no division). 0xF: Maximum division value =16. Reset value 0x00, division value = 1.

PLL_CTRL_MULT_PLL0_CLK Register

The PLL_CTRL_MULT_PLL0_CLK Register characteristics are:

Purpose

Controls PLL clock multiplication value by controlling the PLL feedback divider.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the PLL_CTRL_MULT_PLL0_CLK Register bit assignments.

Table 3-78 PLL_CTRL_MULT_PLL0_CLK Register bit assignment

Bits	Name	Function
[31:14]	-	Reserved.
[13:0]	PLL_CTRL_MULT_PLL0_CLK	PLL feedback divider division value: Divison value =PLL_CTRL_MULT_PLL0_CL+1. 0x00: Minimum division value =1 (no division). 0x3FFF: Maximum division value =16386. Reset value 0x1388.

CLK_CTRL_ENABLE Register

The CLK_CTRL_ENABLE Register characteristics are:

Purpose

Controls clock gate enable functions.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the CLK_CTRL_ENABLE Register bit assignments.

Table 3-79 CLK_CTRL_ENABLE Register bit assignment

Bits	Name	Function
[31:16]	-	Reserved.
[15]	CTRL_ENABLE_TESTCLK	Enable TEST_CLK clock gate: 0b0: Not enabled. 0b1: Enabled. Reset value 0b1.
[14]	-	Reserved.
[13]	CTRL_ENABLE_SDPHYCLK	Enable SD PHY clock gate: 0b0: Not enabled. 0b1: Enabled. Reset value 0b1.
[12]	CTRL_ENABLE_SCCCLK	Enable SCCCLK clock gate: 0b0: Not enabled. 0b1: Enabled. Reset value 0b1.
[11]	CTRL_ENABLE_RM38CLK	Enable RM38KCLK clock gate: 0b0: Not enabled. 0b1: Enabled. Reset value 0b1.
[10]	CTRL_ENABLE_REFCLK	Enable REFCLK clock gate: 0b0: Not enabled. 0b1: Enabled. Reset value 0b1.
[9]	CTRL_ENABLE_QSPI_PHY_CLK	Enable QSPI PHY clock gate: 0b0: Not enabled. 0b1: Enabled. Reset value 0b1.
[8]	CTRL_ENABLE_MAINCLK	Enable MAINCLK clock gate: 0b0: Not enabled. 0b1: Enabled. Reset value 0b1.
[7:6]	-	Reserved..

Table 3-79 CLK_CTRL_ENABLE Register bit assignment (continued)

Bits	Name	Function
[5]	CTRL_ENABLE_I2SCLK2	Enable IS2CLK2 SYSSYSUGCLK clock gate: 0b0: Not enabled. 0b1: Enabled. Reset value 0b1.
[4]	CTRL_ENABLE_I2SCLK1	Enable I2SCLK1 SYSSYSUGCLK clock gate: 0b0: Not enabled. 0b1: Enabled. Reset value 0b1.
[3]	CTRL_ENABLE_I2SCLK0	Enable I2SCLK0 SYSSYSUGCLK clock gate: 0b0: Not enabled. 0b1: Enabled. Reset value 0b1.
[2]	CTRL_ENABLE_GPIOHCLK	Enable GPIO SYSSYSUGCLK clock gate: 0b0: Not enabled. 0b1: Enabled. Reset value 0b1.
[1]	CTRL_ENABLE_DAPSWCLK	Enable DAPSWCLK clock gate: 0b0: Not enabled. 0b1: Enabled. Reset value 0b1.
[0]	CTRL_ENABLE_IHZ	Enable RTC clock gate: 0b0: Not enabled. 0b1: Enabled. Reset value 0b1.

CLK_STATUS Register

The CLK_STATUS Register characteristics are:

Purpose

Stores PLL status values.

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the CLK_STATUS Register bit assignments.

Table 3-80 CLK_STATUS Register bit assignment

Bits	Name	Function
[31:2]	-	Reserved.
[1]	STATUS_LOCK_SIGNAL_PLL0_CLK	PLL lock status: 0b0: Not locked. 0b1: Locked. Reset value 0b1.
[0]	STATUS_OUT_CLK_MAINCLK_READY	Main clock ready status: 0b0: Not ready. 0b1: Ready. Reset value 0b1.

RESET_CTRL Register

The RESET_CTRL Register characteristics are:

Purpose

Resets Musca-B1 test chip peripherals.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the RESET_CTRL Register bit assignments.

Table 3-81 RESET_CTRL Register bit assignment

Bits	Name	Function
[31:15]	-	Reserved.
[14]	RTC_RESET	Reset Real Time Clock: 0b0: Reset. 0b1: No effect. Reset value 0b1.
[13]	PWM2_RESET	Reset PWM2: 0b0: Reset. 0b1: No effect. Reset value 0b1.
[12]	PWM1_RESET	Reset PWM1: 0b0: Reset. 0b1: No effect. Reset value 0b1.

Table 3-81 RESET_CTRL Register bit assignment (continued)

Bits	Name	Function
[11]	PWM0_RESET	Reset PWM0: 0b0: Reset. 0b1: No effect. Reset value 0b1.
[10]	PVT_RESET	Reset PVT: 0b0: Reset. 0b1: No effect. Reset value 0b1.
[9]	GPIO_RESET	Reset GPIO: 0b0: Reset. 0b1: No effect. Reset value 0b1.
[8]	UART1_RESET	Reset UART1: 0b0: Reset. 0b1: No effect. Reset value 0b1.
[7]	UART0_RESET	Reset UART0: 0b0: Reset. 0b1: No effect. Reset value 0b1.
[6]	QSPI_RESET	Reset QSPI: 0b0: Reset. 0b1: No effect. Reset value 0b1.
[5]	SPI_RESET	Reset SPI: 0b0: Reset. 0b1: No effect. Reset value 0b1.
[4]	I2S_RESET	Reset I ² S: 0b0: Reset. 0b1: No effect. Reset value 0b1.

Table 3-81 RESET_CTRL Register bit assignment (continued)

Bits	Name	Function
[3]	I2C1_RESET	Reset I ² C1: 0b0: Reset. 0b1: No effect. Reset value 0b1.
[2]	I2C0_RESET	Reset I ² C0: 0b0: Reset. 0b1: No effect. Reset value 0b1.
[1]	GPTIMER_RESET	Reset general-purpose timer: 0b0: Reset. 0b1: No effect. Reset value 0b1.
[0]	-	Reserved.

PWR_CTRL Register

The PWR_CTRL Register characteristics are:

Purpose

Power control.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the PWR_CTRL Register bit assignments.

Table 3-82 PWR_CTRL Register bit assignment

Bits	Name	Function
[31:27]	-	Reserved.
[26]	ISOLATEN_VCORE	Isolation enable signal used with CHSEC: _MISC[7], DPA_PGEN. 0b0: Clamp. 0b1: Normal operation. Reset value 0b1.

Table 3-82 PWR_CTRL Register bit assignment (continued)

Bits	Name	Function
[25]	NPWRUP_HAMMER	Enables power gating of CryptoCell-312 Hammer chain. 0b0: Power up. 0b1: No effect. Reset value 0b0.
[24]	NPWRUP_TRICKLE	Enables power gating of CryptoCell-312 Trickle chain. 0b0: Power up. 0b1: No effect. Reset value 0b0.
[23]	DPA_PORBYPSEL	Select signal to bypass POR logic. This bit is used in conjunction with DPA_PORBYP. ^a 0b0: Not bypass. 0b1: Bypass. Reset value 0b0. Reset value 0b0.
[22]	DPA_PORBYP	POR bypass signal. This bit is used in conjunction with DPA_PORBYPSEL. 0b0: Not bypass. 0b1: Bypass. Reset value 0b0.
[21]	DPA_ERSOFF	Enables low power, 0% discharge of capacitors, mode. 0b0: Normal operation, 100% or 50% discharge, depending on state of DPA_ERSRT. 0b1: Low-power mode, 0% discharge, regardless of state of DPA_ERSRT. Reset value 0b0.
[20]	DPA_NPWRUP	Enables power down of analog Secure Frame. 0b0: Power up. 0b1: Power down. Reset value 0b0.

^a

Table 3-82 PWR_CTRL Register bit assignment (continued)

Bits	Name	Function
[19]	DPA_BYP	External supply bypasses analog Secure Frame to power digital logic directly (unsecure). 0b0: Logic-powered by analog Secure Frame. 0b1: External supply powers logic directly. Reset value 0b0.
[18]	DPS_ERSRT	Sets capacitor discharge rate to 50% or 100%, when DPA_ERSOFF is 0b0. 0b0: 100% discharge rate, most secure. 0b1: 50% discharge rate. Reset value 0b0.
[17]	DPA_SECNTL	Selects single-ended or differential mode. 0b0: Differential mode, both power and ground disconnected. 0b1: Single-ended mode, only power is disconnected. Reset value 0b1.
[16:0]	-	Reserved.

Note

Set DPA_PORBYPSEL to 0b1 before setting DPA_PORBYP to 0b1.
Clear DPA_PORBY to 0b0 before clearing DPA_PORBYPSEL to 0b0.

DBG_CTRL Register

The DBG_CTRL Register characteristics are:

Purpose

Controls debug authentication signals.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the DBG_CTRL Register bit assignments.

Table 3-83 DBG_CTRL Register bit assignment

Bits	Name	Function
[31:30]	DBG_DCU_FORCE	SSE-200 debug ports control: 0b00: Use Crypto DCU. 0b01: Use PSI_FEATURE_EN. 0x1X: Use SCC signals (Force). Reset value 0b00.
[29:9]	-	Reserved.
[8]	TODBGENSEL1	Enable or mask, bypass, Flush input from the Cross Trigger interface: 0b0: Enabled. 0b1: Mask, or bypass. Reset value 0b0.
[7]	TODBGENSEL0	Enable or mask, bypass, Trigger input from the Cross Trigger interface: 0b0: Enabled. 0b1: Mask, or bypass. Reset value 0b0.
[6:4]	-	Reserved.
[3]	SSE-200 SPNIDENIN	Secure Privilege Non-Invasive Debug Enable Input: 0b0: Not enabled. 0b1: Enabled. Reset value 0b1.
[2]	SSE-200 SPIDENIN	Secure Privilege Invasive Debug Enable Input: 0b0: Not enabled. 0b1: Enabled. Reset value 0b0.
[1]	SSE-200 NIDENIN	Non-Invasive Debug Enable Input: 0b0: Not enabled. 0b1: Enabled. Reset value 0b0.
[0]	SSE-200 DBGENIN	Debug Enable Input: 0b0: Not enabled. 0b1: Enabled. Reset value 0b0.

SRAM_CTRL Register

The SRAM_CTRL Register characteristics are:

Purpose

Controls debug authentication signals.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the SRAM_CTRL Register bit assignments.

Table 3-84 SRAM_CTRL Register bit assignment

Bits	Name	Function
[31:16]	-	Reserved.
[15]	CODE_SRAM15_PGEN	16th 128KB SRAM cell power gate enable: 0b0: Not enabled. 0b1: Enabled. Reset value 0b0.
[14]	CODE_SRAM14_PGEN	15th 128KB SRAM cell power gate enable: 0b0: Not enabled. 0b1: Enabled. Reset value 0b0.
[13]	CODE_SRAM13_PGEN	14th 128KB SRAM cell power gate enable: 0b0: Not enabled. 0b1: Enabled. Reset value 0b0.
[12]	CODE_SRAM12_PGEN	13th 128KB SRAM cell power gate enable: 0b0: Not enabled. 0b1: Enabled. Reset value 0b0.
[11]	CODE_SRAM11_PGEN	12th 128KB SRAM cell power gate enable: 0b0: Not enabled. 0b1: Enabled. Reset value 0b0.
[10]	CODE_SRAM10_PGEN	11th 128KB SRAM cell power gate enable: 0b0: Not enabled. 0b1: Enabled. Reset value 0b0.

Table 3-84 SRAM_CTRL Register bit assignment (continued)

Bits	Name	Function
[9]	CODE_SRAM9_PGEN	10th 128KB SRAM cell power gate enable: 0b0: Not enabled. 0b1: Enabled. Reset value 0b0.
[8]	CODE_SRAM8_PGEN	9th 128KB SRAM cell power gate enable: 0b0: Not enabled. 0b1: Enabled. Reset value 0b0.
[7]	CODE_SRAM7_PGEN	8th 128KB SRAM cell power gate enable: 0b0: Not enabled. 0b1: Enabled. Reset value 0b0.
[6]	CODE_SRAM6_PGEN	7th 128KB SRAM cell power gate enable: 0b0: Not enabled. 0b1: Enabled. Reset value 0b0.
[5]	CODE_SRAM5_PGEN	6th 128KB SRAM cell power gate enable: 0b0: Not enabled. 0b1: Enabled. Reset value 0b0.
[4]	CODE_SRAM4_PGEN	5th 128KB SRAM cell power gate enable: 0b0: Not enabled. 0b1: Enabled. Reset value 0b0.
[3]	CODE_SRAM3_PGEN	4th 128KB SRAM cell power gate enable: 0b0: Not enabled. 0b1: Enabled. Reset value 0b0.
[2]	CODE_SRAM2_PGEN	3rd 128KB SRAM cell power gate enable: 0b0: Not enabled. 0b1: Enabled. Reset value 0b0.

Table 3-84 SRAM_CTRL Register bit assignment (continued)

Bits	Name	Function
[1]	CODE_SRAM1_PGEN	2nd 128KB SRAM cell power gate enable: 0b0: Not enabled. 0b1: Enabled. Reset value 0b0.
[0]	CODE_SRAM0_PGEN	1st 128KB SRAM cell power gate enable: 0b0: Not enabled. 0b1: Enabled. Reset value 0b0.

INTR_CTRL Register

The INTR_CTRL Register characteristics are:

Purpose

Controls PPC and MPC interrupt signals.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the INTR_CTRL Register bit assignments.

Table 3-85 INTR_CTRL Register bit assignment

Bits	Name	Function
[31:7]	-	Reserved.
[6]	AZ_MPC_CFG_INIT_VALUE	Initial security map at startup for CryptoIsland-300 MPC: 0b0: Secure mode. 0b1: Non-secure mode. Reset value 0b0.
[5]	SRAM_MPC_CFG_INIT_VALUE	Initial security map at startup for Code SRAM MPC: 0b0: Secure mode. 0b1: Non-secure mode. Reset value 0b0.
[4]	-	Reserved.

Table 3-85 INTR_CTRL Register bit assignment (continued)

Bits	Name	Function
[3]	QSPI_MPC_CFG_INIT_VALUE	Initial security map at startup for QSPI MPC: 0b0: Secure mode. 0b1: Non-secure mode. Reset value 0b0.
[2:0]	-	Reserved.

CLK_TEST_CTRL Register

The CLK_TEST_CTRL Register characteristics are:

Purpose

Controls clock test signals.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the CLK_TEST_CTRL Register bit assignments.

Table 3-86 CLK_TEST_CTRL Register bit assignments

Bits	Name	Function
[31:7]	-	Reserved.
[6]	CLK_MAIN_FORCE_RDY	Select CLK_MAIN_RDY source: 0b0: CLK_MAIN_RDY depends on lock and MUX_SELs. 0b1: CLK_MAIN_RDY forced to 0b1 . Reset value 0b0.

Table 3-86 CLK_TEST_CTRL Register bit assignments (continued)

Bits	Name	Function
[5]	CLK_TEST_EN	Enable test clock: 0b0: Not enabled. 0b1: Enabled. Reset value 0b0.
[4:0]	CLK_TEST_SEL	Select TESTMUX input: 0b00000: No output. 0b00001: JTAG_TCK. 0b00010: PRE_MUX_CLK. 0b00011: SCCCLK. 0b00100: SSE_200_SWCLK. 0b00101: 32K. 0b00110: REF_MUX_CLK. 0b00111: I_RM38KCLK. 0b01000: FASTCLK. 0b01001: PLL0_CLK. 0b01010: PRE_MUX_CLK. 0b01011: PRE_PLL_CLK. 0b01100: SYSSYSUGCLK. 0b01101: FCLK. 0b01110: DAPSWCLK. 0b01111: MAINCLK. 0b10000: REFCLK. 0b10001: CLK1HZ. 0b10010: O_RM38KCLK. 0b10100: SDPHYCLK. 0b10101: QSPIPHYCLK. 0b10111: PVT_SENSOR_OUT. 0b11000: I2SCLK0. 0b11001: I2SCLK1. 0b11010: I2SCLK2. Undefined settings are reserved. Reset value 0b00000.

CPU0_VTOR Register

The CPU0_VTOR Register characteristics are:

Purpose

Controls reset vector for CPU0 secure mode.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the CPU0_VTOR Register bit assignments.

Table 3-87 CPU0_VTOR Register bit assignments

Bits	Name	Function
[31:7]	CPU0_VTOR_SECURE	Reset vector for CPU0 secure mode: Reset value 0x020_0000.
[6:0]	-	Reserved.

CPU1_VTOR Register

The CPU1_VTOR Register characteristics are:

Purpose

Controls reset vector for CPU1 secure mode.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the CPU1_VTOR Register bit assignments.

Table 3-88 CPU1_VTOR Register bit assignments

Bits	Name	Function
[31:7]	CPU1_VTOR_SECURE	Reset vector for CPU1 secure mode: Reset value 034_8000.
[6:0]	-	Reserved.

AZ_CPU_VTOR Register

The AZ_CPU_VTOR Register characteristics are:

Purpose

Controls reset vector for CryptoIsland-300 secure enclave.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the AZ_CPU_VTOR Register bit assignments.

Table 3-89 AZ_CPU_VTOR Register bit assignments

Bits	Name	Function
[31:24]	-	Reserved.
[23:16]	AZ_SYS_REMAP	Remap vector for CryptoIsland-300 System address space. Reset value 0xA0.
[15:8]	AZ_CODE_REMAP	Remap vector for CryptoIsland-300 Code address space. Reset value 0x38.
[7:0]	AZ_ROM_REMAP	Remap vector for CryptoIsland-300 ROM address space. Reset value 0x00.

IOMUX_MAIN_INSEL_0 Register

The IOMUX_MAIN_INSEL_0 Register characteristics are:

Purpose

Selects either MAIN_IN or ALTF1 as destination of input signals from multiplexed Musca-B1 test chip I/O PA31-PA0.

See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_MAIN_INSEL_0 Register bit assignments.

Table 3-90 IOMUX_MAIN_INSEL_0 Register bit assignments

Bits	Name	Function
[31:0]	IOMUX_MAIN_INSEL_0[31:0]	Main function input data select for Musca-B1 test chip multiplexed I/O PA31-PA0: 0b0: Select ALTF1. 0b1: Select MAIN_IN. Reset value 0xFFFF_FFFF. ————— Note ————— See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.

IOMUX_MAIN_INSEL_1 Register

The IOMUX_MAIN_INSEL_1 Register characteristics are:

Purpose

Selects either MAIN_IN or ALTF1 as destination of input signals from Musca-B1 test chip I/O PA37-PA32.

See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_MAIN_INSEL_1 Register bit assignments.

Table 3-91 IOMUX_MAIN_INSEL_1 Register bit assignments

Bits	Name	Function
[31:6]	-	Reserved.
[5:0]	IOMUX_MAIN_INSEL_1[5:0]	<p>Main function input data select for Musca-B1 test chip multiplexed I/O PA37-PA32:</p> <p>0b0: Select ALTF1.</p> <p>0b1: Select MAIN_IN.</p> <p>Reset value 0x3F.</p> <p>————— Note —————</p> <p>See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.</p>

IOMUX_MAIN_OUTSEL_0 Register

The IOMUX_MAIN_OUTSEL_0 Register characteristics are:

Purpose

Selects either MAIN_OUT or ALTF1 as output data for Musca-B1 test chip I/O PA31-PA0.

See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_MAIN_OUTSEL_0 bit assignments.

Table 3-92 IOMUX_MAIN_OUTSEL_0 Register bit assignments

Bits	Name	Function
[31:0]	IOMUX_MAIN_OUTSEL_0[31:0]	<p>Main function output data select for Musca-B1 test chip multiplexed I/O PA31-PA0:</p> <p>0b0: Select ALTF1.</p> <p>0b1: Select MAIN_OUT.</p> <p>Reset value 0xFFFF_FFFF.</p> <p style="text-align: center;">————— Note —————</p> <p>See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.</p>

IOMUX_MAIN_OUTSEL_1 Register

The IOMUX_MAIN_OUTSEL_1 Register characteristics are:

Purpose

Selects either MAIN_OUT or ALTF1 as output data for Musca-B1 test chip I/O PA37-PA32. See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_MAIN_OUTSEL_1 Register bit assignments.

Table 3-93 IOMUX_MAIN_OUTSEL_1 Register bit assignments

Bits	Name	Function
[31:6]	-	Reserved.
[5:0]	IOMUX_MAIN_OUTSEL_1[5:0]	<p>Main function output data select for Musca-B1 test chip multiplexed I/O PA37-PA32:</p> <p>0b0: Select ALTF1.</p> <p>0b1: Select MAIN_OUT.</p> <p>Reset value 0x3F.</p> <p style="text-align: center;">————— Note —————</p> <p>See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.</p>

IOMUX_MAIN_OENSEL_0 Register

The IOMUX_MAIN_OENSEL_0 Register characteristics are:

Purpose

Selects either MAIN_OE or ALTF1 as output enable signal for Musca-B1 test chip I/O PA31-PA0.

See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_MAIN_OENSEL_0 Register bit assignments.

Table 3-94 IOMUX_MAIN_OENSEL_0 Register bit assignments

Bits	Name	Function
[31:0]	IOMUX_MAIN_OENSEL_0[31:0]	<p>I/O main function output enable select for Musca-B1 test chip multiplexed I/O PA31-PA0:</p> <p>0b0: Select ALTF1.</p> <p>0b1: Select MAIN_OE.</p> <p>Reset value 0xFFFF_FFFF.</p> <p>————— Note —————</p> <p>See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.</p>

IOMUX_MAIN_OENSEL_1 Register

The IOMUX_MAIN_OENSEL_1 Register characteristics are:

Purpose

Selects either MAIN_OE or ALTF1 as output enable signal for Musca-B1 test chip I/O PA37-PA32.

See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_MAIN_OENSEL_1 Register bit assignments.

Table 3-95 IOMUX_MAIN_OENSEL_1 Register bit assignments

Bits	Name	Function
[31:6]	-	Reserved.
[5:0]	IOMUX_MAIN_OENSEL_1[5:0]	<p>I/O main function output enable select for Musca-B1 test chip multiplexed I/O PA37-PA32:</p> <p>0b0: Select ALTF1.</p> <p>0b1: Select MAIN_OE.</p> <p>Reset value 0x3F.</p> <p>————— Note —————</p> <p>See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.</p> <p>—————</p>

IOMUX_MAIN_DEFAULT_IN_0 Register

The IOMUX_MAIN_DEFAULT_IN_0 Register characteristics are:

Purpose

Musca-B1 test chip I/O PA31-PA0: Drives unselected outputs of MAIN input multiplexers to defined logic levels to prevent floating nodes.

See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_MAIN_DEFAULT_IN_0 Register bit assignments.

Table 3-96 IOMUX_MAIN_DEFAULT_IN_0 Register bit assignments

Bits	Name	Function
[31:0]	IOMUX_MAIN_DEFAULT_IN_0[31:0]	<p>Defines value of unselected outputs of ALTF1 input multiplexers for Musca-B1 test chip multiplexed I/O PA31-PA0:</p> <p>0b0: Default to 0b0.</p> <p>0b1: Default to 0b1.</p> <p>Reset value 0x0000_0000.</p> <p>————— Note —————</p> <p>See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.</p> <p>—————</p>

IOMUX_MAIN_DEFAULT_IN_1 Register

The IOMUX_MAIN_DEFAULT_IN_1 Register characteristics are:

Purpose

Test chip I/O PA37-PA32: Drives unselected outputs of MAIN input multiplexers to defined logic levels to prevent floating nodes.

See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_MAIN_DEFAULT_IN_1 Register bit assignments.

Table 3-97 IOMUX_MAIN_DEFAULT_IN_1 Register bit assignments

Bits	Name	Function
[31:6]	-	Reserved.
[5:0]	IOMUX_MAIN_DEFAULT_IN_1[31:0]	<p>Defines value of unselected outputs of MAIN input multiplexers for Musca-B1 test chip multiplexed I/O PA37-PA32:</p> <p>0b0: Default to 0b0.</p> <p>0b1: Default to 0b1.</p> <p>Reset value 0x00.</p> <p>————— Note —————</p> <p>See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.</p>

IOMUX_ALTF1_INSEL_0 Register

The IOMUX_ALTF1_INSEL_0 Register characteristics are:

Purpose

Selects either ALTF1 or ALTF2 as destination of input signals from MAIN input multiplexer for Musca-B1 test chip I/O PA31-PA0.

See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_ALTF1_INSEL_0 Register bit assignments.

Table 3-98 IOMUX_ALTF1_INSEL_0 Register bit assignments

Bits	Name	Function
[31:0]	IOMUX_ALTF1_INSEL_0[31:0]	<p>Selects either ALTF1 or ALTF2 as destination of MAIN input multiplexer for Musca-B1 test chip multiplexed I/O PA31-PA0:</p> <p>0b0: Select ALTF1_IN.</p> <p>0b1: Select ALTF2.</p> <p>Reset value 0x0000_0000.</p> <p style="text-align: center;">————— Note —————</p> <p>See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.</p>

IOMUX_ALTF1_INSEL_1 Register

The IOMUX_ALTF1_INSEL_1 Register characteristics are:

Purpose

Selects either ALTF1 or ALTF2 as destination of input signals from MAIN input multiplexer for Musca-B1 test chip I/O PA37-PA32.

See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_ALTF1_INSEL_1 Register bit assignments.

Table 3-99 IOMUX_ALTF1_INSEL_1 Register bit assignments

Bits	Name	Function
[31:6]	-	Reserved.
[5:0]	IOMUX_ALTF1_INSEL_1[5:0]	<p>Selects either ALTF1 or ALTF2 as destination of MAIN input multiplexer for Musca-B1 test chip multiplexed I/O PA37-PA32:</p> <p>0b0: Select ALTF1_IN.</p> <p>0b1: Select ALTF2.</p> <p>Reset value 0x00.</p> <p style="text-align: center;">————— Note —————</p> <p>See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.</p>

IOMUX_ALTF1_OUTSEL_0 Register

The IOMUX_ALTF1_OUTSEL_0 Register characteristics are:

Purpose

Selects either ALTF1_OUT or ALTF2 as output data for Musca-B1 test chip I/O PA31-PA0.
See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_ALTF1_OUTSEL_0 Register bit assignments.

Table 3-100 IOMUX_ALTF1_OUTSEL_0 Register bit assignments

Bits	Name	Function
[31:0]	IOMUX_ALTF1_OUTSEL_0[31:0]	<p>Main function output data select for Musca-B1 test chip multiplexed I/O PA31-PA0:</p> <p>0b0: Select ALTF2.</p> <p>0b1: Select ALTF1_OUT.</p> <p>Reset value 0xFFFF_FFFF.</p> <p>————— Note —————</p> <p>See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.</p>

IOMUX_ALTF1_OUTSEL_1 Register

The IOMUX_ALTF1_OUTSEL_1 Register characteristics are:

Purpose

Selects either ALTF1_OUT or ALTF2 as output data for Musca-B1 test chip I/O PA37-PA32.
See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_ALTF1_OUTSEL_1 Register bit assignments.

Table 3-101 IOMUX_ALTF1_OUTSEL_1 Register bit assignments

Bits	Name	Function
[31:6]	-	Reserved.
[5:0]	IOMUX_ALTF1_OUTSEL_1[5:0]	<p>Main function output data select for Musca-B1 test chip multiplexed I/O PA37-PA32:</p> <p>0b0: Select ALTF1.</p> <p>0b1: Select MAIN_OUT.</p> <p>Reset value 0x3F.</p> <p>————— Note —————</p> <p>See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.</p> <p>—————</p>

IOMUX_ALTF1_OENSEL_0 Register

The IOMUX_ALTF1_OENSEL_0 Register characteristics are:

Purpose

Selects either ALTF1_OE or ALTF2 as output enable signal for Musca-B1 test chip I/O PA31-PA0.

See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_ALTF1_OENSEL_0 Register bit assignments.

Table 3-102 IOMUX_ALTF1_OENSEL_0 Register bit assignments

Bits	Name	Function
[31:0]	IOMUX_ALTF1_OENSEL_0[31:0]	<p>I/O main function output enable select for Musca-B1 test chip multiplexed I/O PA31-PA0:</p> <p>0b0: Select ALTF2.</p> <p>0b1: Select ALTF1_OE.</p> <p>Reset value 0xFFFF_FFFF.</p> <p>————— Note —————</p> <p>See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.</p> <p>—————</p>

IOMUX_ALTF1_OENSEL_1 Register

The IOMUX_ALTF1_OENSEL_1 Register characteristics are:

Purpose

Selects either ALTF1_OE or ALTF2 as output enable signal for Musca-B1 test chip I/O PA37-PA32.

See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_ALTF1_OENSEL_1 Register bit assignments.

Table 3-103 IOMUX_ALTF1_OENSEL_1 Register bit assignments

Bits	Name	Function
[31:6]	-	Reserved.
[5:0]	IOMUX_ALTF1_OENSEL_1[5:0]	<p>I/O main function output enable select for Musca-B1 test chip multiplexed I/O PA37-PA32:</p> <p>0b0: Select ALTF2.</p> <p>0b1: Select ALTF1_OE.</p> <p>Reset value 0x3F.</p> <p>Note</p> <p>See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.</p>

IOMUX_ALTF1_DEFAULT_IN_0 Register

The IOMUX_ALTF1_DEFAULT_IN_0 Register characteristics are:

Purpose

Test chip I/O PA31-PA0: Drives unselected outputs of ALTF1 input multiplexers to defined logic levels to prevent floating nodes.

See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_ALTF1_DEFAULT_IN_0 Register bit assignments.

Table 3-104 IOMUX_ALTF1_DEFAULT_IN_0 Register bit assignments

Bits	Name	Function
[31:0]	IOMUX_ALTF1_DEFAULT_IN_0[31:0]	<p>Defines value of unselected outputs of ALTF1 input multiplexers for Musca-B1 test chip multiplexed I/O PA31-PA0:</p> <p>0b0: Default to 0b0.</p> <p>0b1: Default to 0b1.</p> <p>Reset value 0x0000_0000.</p> <p>————— Note —————</p> <p>See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.</p>

IOMUX_ALTF1_DEFAULT_IN_1 Register

The IOMUX_ALTF1_DEFAULT_IN_1 Register characteristics are:

Purpose

Test chip I/O PA37-PA32: Drives unselected outputs of ALTF1 input multiplexers to defined logic levels to prevent floating nodes.

See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_ALTF1_DEFAULT_IN_1 Register bit assignments.

Table 3-105 IOMUX_ALTF1_DEFAULT_IN_1 Register bit assignments

Bits	Name	Function
[31:6]	-	Reserved.
[5:0]	IOMUX_ALTF1_DEFAULT_IN_1[31:0]	<p>Defines value of unselected outputs of ALTF1 input multiplexers for Musca-B1 test chip multiplexed I/O PA37-PA32:</p> <p>0b0: Default to 0b0.</p> <p>0b1: Default to 0b1.</p> <p>Reset value 0x00.</p> <p>————— Note —————</p> <p>See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.</p>

IOMUX_ALTF2_INSEL_0 Register

The IOMUX_ALTF2_INSEL_0 Register characteristics are:

Purpose

Selects either ALTF2_IN or ALTF3_IN as destination of input signals from ALTF1 input multiplexer for Musca-B1 test chip I/O PA31-PA0.

See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_ALTF2_INSEL_0 Register bit assignments.

Table 3-106 IOMUX_ALTF2_INSEL_0 Register bit assignments

Bits	Name	Function
[31:0]	IOMUX_ALTF2_INSEL_0[31:0]	<p>Selects either ALTF2_IN or ALTF3_IN as destination of ALTF1 input multiplexer for Musca-B1 test chip multiplexed I/O PA31-PA0:</p> <p>0b0: Select ALTF3_IN.</p> <p>0b1: Select ALTF2_IN.</p> <p>Reset value 0x0000_0000.</p> <p>————— Note —————</p> <p>See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.</p>

IOMUX_ALTF2_INSEL_1 Register

The IOMUX_ALTF2_INSEL_1 Register characteristics are:

Purpose

Selects either ALTF2_IN or ALTF3_IN as destination of input signals from ALTF1 input multiplexer for Musca-B1 test chip I/O PA37-PA32.

See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_ALTF2_INSEL_1 Register bit assignments.

Table 3-107 IOMUX_ALTF2_INSEL_1 Register bit assignments

Bits	Name	Function
[31:6]	-	Reserved.
[5:0]	IOMUX_ALTF2_INSEL_1[31:0]	<p>Selects either ALTF2_IN or ALTF3_IN as destination of ALTF1 input multiplexer for Musca-B1 test chip multiplexed I/O PA37-PA32:</p> <p>0b0: Select ALTF3_IN.</p> <p>0b1: Select ALTF2_IN.</p> <p>Reset value 0x00.</p> <p>————— Note —————</p> <p>See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.</p> <p>—————</p>

IOMUX_ALTF2_OUTSEL_0 Register

The IOMUX_ALTF2_OUTSEL_0 Register characteristics are:

Purpose

Selects either ALTF2_OUT or ALTF3_OUT as output data for Musca-B1 test chip I/O PA31-PA0.
See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_ALTF2_OUTSEL_0 Register bit assignments.

Table 3-108 IOMUX_ALTF2_OUTSEL_0 Register bit assignments

Bits	Name	Function
[31:0]	IOMUX_ALTF2_OUTSEL_0[31:0]	<p>Main function output data select for Musca-B1 test chip multiplexed I/O PA31-PA0:</p> <p>0b0: Select ALTF3_OUT.</p> <p>0b1: Select ALTF2_OUT.</p> <p>Reset value 0xFFFF_FFFF.</p> <p>————— Note —————</p> <p>See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.</p> <p>—————</p>

IOMUX_ALTF2_OUTSEL_1 Register

The IOMUX_ALTF2_OUTSEL_1 Register characteristics are:

Purpose

Selects either ALTF2_OUT or ALTF3_OUT as output data for Musca-B1 test chip I/O PA37-PA32.

See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_ALTF2_OUTSEL_1 Register bit assignments.

Table 3-109 IOMUX_ALTF2_OUTSEL_1 Register bit assignments

Bits	Name	Function
[31:6]	-	Reserved.
[5:0]	IOMUX_ALTF2_OUTSEL_1[5:0]	<p>Main function output data select for Musca-B1 test chip multiplexed I/O PA37-PA32:</p> <p>0b0: Select ALTF3_OUT.</p> <p>0b1: Select ALTF2_OUT.</p> <p>Reset value 0x3F.</p> <p>————— Note —————</p> <p>See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.</p>

IOMUX_ALTF2_OENSEL_0 Register

The IOMUX_ALTF2_OENSEL_0 Register characteristics are:

Purpose

Selects either ALTF2_OE or ALTF3 as output enable signal for Musca-B1 test chip I/O PA31-PA0.

See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_ALTF2_OENSEL_0 Register bit assignments.

Table 3-110 IOMUX_ALTF2_OENSEL_0 Register bit assignments

Bits	Name	Function
[31:0]	IOMUX_ALTF2_OENSEL_0[31:0]	<p>I/O main function output enable select for Musca-B1 test chip multiplexed I/O PA31-PA0:</p> <p>0b0: Select ALTF3.</p> <p>0b1: Select ALTF2_OE.</p> <p>Reset value 0xFFFF_FFFF.</p> <p>————— Note —————</p> <p>See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.</p>

IOMUX_ALTF2_OENSEL_1 Register

The IOMUX_ALTF2_OENSEL_1 Register characteristics are:

Purpose

Selects either ALTF2_OE or ALTF3_OE as output enable signal for Musca-B1 test chip I/O PA37-PA32.

See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_ALTF2_OENSEL_1 Register bit assignments.

Table 3-111 IOMUX_ALTF2_OENSEL_1 Register bit assignments

Bits	Name	Function
[31:6]	-	Reserved.
[5:0]	IOMUX_ALTF2_OENSEL_1[5:0]	<p>I/O main function output enable select for Musca-B1 test chip multiplexed I/O PA37-PA32:</p> <p>0b0: Select ALTF3_OE.</p> <p>0b1: Select ALTF2_OE.</p> <p>Reset value 0x3F.</p> <p>————— Note —————</p> <p>See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.</p>

IOMUX_ALTF2_DEFAULT_IN_0 Register

The IOMUX_ALTF2_DEFAULT_IN_0 Register characteristics are:

Purpose

Test chip I/O PA31-PA0: Drives unselected outputs of ALTF1 input multiplexers to defined logic levels to prevent floating nodes.

See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_ALTF2_DEFAULT_IN_0 Register bit assignments.

Table 3-112 IOMUX_ALTF2_DEFAULT_IN_0 Register bit assignments

Bits	Name	Function
[31:0]	IOMUX_ALTF2_DEFAULT_IN_0[31:0]	<p>Defines value of unselected outputs of ALTF2 input multiplexers for Musca-B1 test chip multiplexed I/O PA31-PA0:</p> <p>0b0: Default to 0b0.</p> <p>0b1: Default to 0b1.</p> <p>Reset value 0x0000_0000.</p> <p>————— Note —————</p> <p>See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.</p>

IOMUX_ALTF2_DEFAULT_IN_1 Register

The IOMUX_ALTF2_DEFAULT_IN_1 Register characteristics are:

Purpose

Test chip I/O PA37-PA32: Drives unselected outputs of ALTF2 input multiplexers to defined logic levels to prevent floating nodes.

See [3.12.1 IOMUX registers on page 3-126](#) for information on the Musca-B1 test chip I/O multiplexer.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the IOMUX_ALTF2_DEFAULT_IN_1 Register bit assignments.

Table 3-113 IOMUX_ALTF2_DEFAULT_IN_1 Register bit assignments

Bits	Name	Function
[31:6]	-	Reserved.
[5:0]	IOMUX_ALTF2_DEFAULT_IN_1[31:0]	<p>Defines value of unselected outputs of ALTF1 input multiplexers for Musca-B1 test chip multiplexed I/O PA37-PA32:</p> <p>0b0: Default to 0b0.</p> <p>0b1: Default to 0b1.</p> <p>Reset value 0x00.</p> <p>————— Note —————</p> <p>See 2.2.2 Test chip multiplexed I/O on page 2-23 for the functions that are available on the multiplexed Musca-B1 test chip I/O.</p> <p>—————</p>

IOPAD_DS0_0 and IOPAD_DS1_0 Registers

The IOPAD_DS0_0 and IOPAD_DS1_0 Register characteristics are:

Purpose

The corresponding bits of the two registers combine to form two-bit values that define the corresponding drive strengths of Musca-B1 test chip I/O PA31-PA0. The following table shows how the bits of the IOPAD_DS0_0 and IOPAD_DS1_0 Registers define the drive strengths.

Table 3-114 Test chip I/O drive strengths

IOPAD_DS1_0/DS0_0	Drive strength (mA)
0b00	2
0b01	8, default for PA31-PA20
0b10	4, default for PA19-PA0
0b11	12

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following tables show the IOPAD_DS0_0 and IOPAD_DS1_0 Register bit assignments.

Table 3-115 IOPAD_DS0_0 Register bit assignments

Bits	Name	Function
[31:0]	DRIVE_STRENGTH0	<p>Least significant bits of the two-bit values that define drive strengths of Musca-B1 test chip I/O PA31-PA0.</p> <p>Reset value 0xFFFF0_0000.</p>

Table 3-116 IOPAD_DS1_0 Register bit assignments

Bits	Name	Function
[31:0]	DRIVE_STRENGTH1	Most significant bits of the two-bit values that define drive strengths of Musca-B1 test chip I/O PA31-PA0. Reset value 0x000F_FFFF.

IOPAD_DS0_1 and IOPAD_DS1_1 Registers

The IOPAD_DS0_1 and IOPAD_DS1_1 Register characteristics are:

Purpose

The corresponding bits of the two registers combine to form two-bit values that define the corresponding drive strengths of Musca-B1 test chip I/O PA37-PA32. The following table shows how the bits of the IOPAD_DS0_1 and IOPAD_DS1_1 Registers define the drive strengths.

Table 3-117 Test chip I/O drive strengths

IOPAD_DS1_1/DS0_1	Drive strength (mA)
0b00	2
0b01	8
0b10	4, default
0b11	12

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following tables show the IOPAD_DS0_1 and IOPAD_DS1_1 Register bit assignments.

Table 3-118 IOPAD_DS0_1 Register bit assignments

Bits	Name	Function
[31:6]	-	Reserved.
[5:0]	DRIVE_STRENGTH_0	Least significant bits of the two-bit values that define drive strengths of Musca-B1 test chip I/O PA37-PA32. Reset value 0x00.

Table 3-119 IOPAD_DS1_1 Register bit assignments

Bits	Name	Function
[31:6]	-	Reserved.
[5:0]	DRIVE_STRENGTH_1	Most significant bits of the two-bit values that define drive strengths of Musca-B1 test chip I/O PA37-PA32. Reset value 0x3F.

IOPAD_PE_0 and IOPAD_PE_1 Registers

The IOPAD_PE_0 and IOPAD_PE_1 Register characteristics are:

Purpose

- Register IOPAD_PE_0 enables pull resistors onMusca-B1 test chip I/O PA31-PA0.
- Register IOPAD_PE_1 enables pull resistors onMusca-B1 test chip I/O PA37-PA32.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following tables show the IOPAD_PE_0 and IOPAD_PE_1 Register bit assignments.

Table 3-120 IOPAD_PE_0 Register bit assignments

Bits	Name	Function
[31:0]	PULL_ENABLE	Enable pull resistors ofMusca-B1 test chip I/O PA31-PA0. 0b0: Not enabled. 0b1: Enabled. Reset value 0xFFFF_FFFF.

Table 3-121 IOPAD_PE_1 Register bit assignments

Bits	Name	Function
[31:6]	-	Reserved.
[5:0]	PULL_ENABLE	Enable pull resistors ofMusca-B1 test chip I/O PA37-PA32. 0b0: Not enabled. 0b1: Enabled. Reset value 0x3F.

IOPAD_PS_0 and IOPAD_PS_1 Registers

The IOPAD_PS_0 and IOPAD_PS_1 Register characteristics are:

Purpose

- Register IOPAD_PS_0 controls the pull resistor modes onMusca-B1 test chip I/O PA31-PA0.
- Register IOPAD_PS_1 controls the pull resistor modes onMusca-B1 test chip I/O PA37-PA32.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following tables show the IOPAD_PS_0 and IOPAD_PS_1 Register bit assignments.

Table 3-122 IOPAD_PS_0 Register bit assignments

Bits	Name	Function
[31:0]	PULL_SELECT	Selects pull mode of pull resistors onMusca-B1 test chip I/O PA31-PA0. 0b0: Pull down. 0b1: Pull up. Reset value 0xFFFF_FFFF.

Table 3-123 IOPAD_PS_1 Register bit assignments

Bits	Name	Function
[31:6]	-	Reserved.
[5:0]	PULL_SELECT	Selects pull mode of pull resistors onMusca-B1 test chip I/O PA37-PA32. 0b0: Pull down. 0b1: Pull up. Reset value 0x3F.

IOPAD_SR_0 and IOPAD_SR_1 Registers

The IOPAD_SR_0 and IOPAD_SR_1 Register characteristics are:

Purpose

- Register IOPAD_SR_0 controls the slew rates ofMusca-B1 test chip I/O PA31-PA0.
- Register IOPAD_SR_1 controls the slew rates ofMusca-B1 test chip I/O PA37-PA32.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following tables show the IOPAD_SR_0 and IOPAD_SR_1 Register bit assignments.

Table 3-124 IOPAD_SR_0 Register bit assignments

Bits	Name	Function
[31:0]	SLEW_RATE	Selects the slew rate ofMusca-B1 test chip I/O I/O PA31-PA0. 0b0: Fast. 0b1: Slow. Reset value 0xFFFF_FFFF.

Table 3-125 IOPAD_SR_1 Register bit assignments

Bits	Name	Function
[31:6]	-	Reserved.
[5:0]	SLEW_RATE	Selects the slew rate of Musca-B1 test chip I/O PA37-PA32. 0b0: Fast. 0b1: Slow. Reset value 0x3F.

IOPAD_IS_0 and IOPAD_IS_1 Registers

The IOPAD_IS_0 and IOPAD_IS_1 Register characteristics are:

Purpose

- Register IOPAD_IS_0 controls the input modes on Musca-B1 test chip I/O PA31-PA0.
- Register IOPAD_IS_1 controls the input modes on Musca-B1 test chip I/O PA37-PA32.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following tables show the IOPAD_IS_0 and IOPAD_IS_1 Register bit assignments.

Table 3-126 IOPAD_IS_0 Register bit assignments

Bits	Name	Function
[31:0]	INPUT_SELECT	Selects input mode on Musca-B1 test chip I/O PA31-PA0. 0b0: CMOS. 0b1: Schmitt. Reset value 0xFFFF_FFFF.

Table 3-127 IOPAD_IS_1 Register bit assignments

Bits	Name	Function
[31:6]	-	Reserved.
[5:0]	INPUT_SELECT	Selects input mode on Musca-B1 test chip I/O PA37-PA32. 0b0: CMOS. 0b1: Schmitt. Reset value 0x3F.

PVT_CTRL Register

The PVT_CTRL Register characteristics are:

Purpose

Selects which PVT sensor is the active sensor to write to and read from.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the PVT_CTRL Register bit assignments.

Table 3-128 PVT_CTRL Register bit assignments

Bits	Name	Function
[31:5]	-	Reserved.
[4:0]	TSTSENUM	<p>Select PVT sensor to write to and read from:</p> <p>0b00000: Sensor 0.</p> <p>0b00001: Sensor 1.</p> <p>0b00010: Sensor 2.</p> <p>0b00011: Sensor 3.</p> <p>0b00100: Sensor 4.</p> <p>0b00011: Sensor 5.</p> <p>0b00000: Sensor 6.</p> <p>0b00111: Sensor 7.</p> <p>0b01000: Sensor 8.</p> <p>Undefined settings are reserved.</p> <p>Reset value 0b00000.</p>

SPARE0 Register

The SPARE0 Register characteristics are:

Purpose

Spare read/write register for use by software.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the SPARE0 Register bit assignments.

Table 3-129 SPARE0 Register bit assignments

Bits	Name	Function
[31:0]	SPARE0[31:0]	<p>Spare read/write register for software.</p> <p>Software assigns the bit meanings.</p> <p>Reset value 0x0000_0000.</p>

STATIC_CONF_SIG1 Register

The STATIC_CONF_SIG1 Register characteristics are:

Purpose

Static configuration control register.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the STATIC_CONF_SIG1 Register bit assignments.

Table 3-130 STATIC_CONF_SIG1 Register bit assignments

Bits	Name	Function
[31:28]	-	Reserved.
[27:24]	TODBGENSEL	DBGEN mask on CTITRIGOUT : 0b0 : Mask trigger output of associated Cross Trigger Interface output when DBGEN is LOW. 0b1 : Not mask trigger output of associated Cross Trigger Interface output. Reset value 0b0000 .
[23:16]	TINIDENSEL	NIDEN mask on CTITRIGINT : 0b0 : Mask trigger input of associated Cross Trigger Interface output when NIDEN is LOW. 0b1 : Not mask trigger output of associated Cross Trigger Interface output. Reset value 0x00 .
[15:12]	TIHSBYPASS	Cross Trigger Interface handshake bypass on CTITRIGOUT . Disables the SPIDEN selector logic and forces SPIDEN to use SPIDENIN : 0b0 : Not disable. 0b1 : Disable. Reset value 0b0000 .

Table 3-130 STATIC_CONF_SIG1 Register bit assignments (continued)

Bits	Name	Function
[11:8]	TISBYPASSACK	<p>Cross Trigger Interface synchronous bypass on CTITRIGOUTACK.</p> <p>Set HIGH to bypass the synchronization logic if the CTITRIGOUTACK input is synchronous with DBGSYSCLK and is driven from the same clock domain:</p> <p>0b0: Not bypass. 0b1: Bypass.</p> <p>Reset value 0b0000.</p>
[7:0]	TISBYPASSIN	<p>Cross Trigger Interface synchronous bypass on CTITRIGIN.</p> <p>Set HIGH to bypass the synchronization logic if the CTITRIGIN input is synchronous with DBGSYSCLK and is driven from the same clock domain:</p> <p>0b0: Not bypass. 0b1: Bypass.</p> <p>Reset value 0x00.</p>

FLASH_DIN_0 Register

The FLASH_DIN_0 Register characteristics are:

Purpose

eFlash 0 and eFlash 1 memory data input[31:0].

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the FLASH_DIN_0 Register bit assignments.

Table 3-131 FLASH_DIN_0 Register bit assignments

Bits	Name	Function
[31:0]	SCC_FLASH_DIN0	<p>eFlash 0 and eFlash 1 data input[31:0].</p> <p>Reset value 0x0000_0000.</p>

FLASH_DIN_1 Register

The FLASH_DIN_1 Register characteristics are:

Purpose

eFlash 0 and eFlash 1 memory data input[63:32].

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the FLASH_DIN_1 Register bit assignments.

Table 3-132 FLASH_DIN_1 Register bit assignments

Bits	Name	Function
[31:0]	SCC_FLASH_DIN1	eFlash 0 and eFlash 1 data input[63:32]. Reset value 0x0000_0000.

FLASH_DIN_2 Register

The FLASH_DIN_2 Register characteristics are:

Purpose

eFlash 0 and eFlash 1 memory data input[95:64].

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the FLASH_DIN_2 Register bit assignments.

Table 3-133 FLASH_DIN_2 Register bit assignments

Bits	Name	Function
[31:0]	SCC_FLASH_DIN2	eFlash 0 and eFlash 1 data input[95:64]. Reset value 0x0000_0000.

FLASH_DIN_3 Register

The FLASH_DIN_3 Register characteristics are:

Purpose

eFlash 0 and eFlash 1 memory data input[127:96].

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the FLASH_DIN_3 Register bit assignments.

Table 3-134 FLASH_DIN_3 Register bit assignments

Bits	Name	Function
[31:0]	SCC_FLASH_DIN3	eFlash 0 and eFlash 1 data input[127:96]. Reset value 0x0000_0000.

FLASH0_DOUT_0 Register

The FLASH0_DOUT_0 Register characteristics are:

Purpose

eFlash 0 memory data output[31:0].

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the FLASH0_DOUT_0 Register bit assignments.

Table 3-135 FLASH0_DOUT_0 Register bit assignments

Bits	Name	Function
[31:0]	SCC_FLASH0_DOUT0	eFlash 0 data output[31:0]. Reset value 0xFFFF_FFFF.

FLASH0_DOUT_1 Register

The FLASH0_DOUT_1 Register characteristics are:

Purpose

eFlash 0 memory data output[63:32].

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the FLASH0_DOUT_1 Register bit assignments.

Table 3-136 FLASH0_DOUT_1 Register bit assignments

Bits	Name	Function
[31:0]	SCC_FLASH0_DOUT1	eFlash 0 data output[63:32]. Reset value 0xFFFF_FFFF.

FLASH0_DOUT_2 Register

The FLASH0_DOUT_2 Register characteristics are:

Purpose

eFlash 0 memory data output[95:64].

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the FLASH0_DOUT_2 Register bit assignments.

Table 3-137 FLASH0_DOUT_2 Register bit assignments

Bits	Name	Function
[31:0]	SCC_FLASH0_DOUT2	eFlash 0 data output[95:64]. Reset value 0xFFFF_FFFF.

FLASH0_DOUT_3 Register

The FLASH0_DOUT_3 Register characteristics are:

Purpose

eFlash 0 memory data output[127:96].

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the FLASH0_DOUT_3 Register bit assignments.

Table 3-138 FLASH0_DOUT_3 Register bit assignments

Bits	Name	Function
[31:0]	SCC_FLASH0_DOUT3	eFlash 0 data output[127:96]. Reset value 0xFFFF_FFFF.

FLASH1_DOUT_0 Register

The FLASH1_DOUT_0 Register characteristics are:

Purpose

eFlash 1 memory data output[31:0].

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the FLASH1_DOUT_0 Register bit assignments.

Table 3-139 FLASH1_DOUT_0 Register bit assignments

Bits	Name	Function
[31:0]	SCC_FLASH1_DOUT0	eFlash 1 data output[31:0]. Reset value 0xFFFF_FFFF.

FLASH1_DOUT_1 Register

The FLASH1_DOUT_1 Register characteristics are:

Purpose

eFlash 1 memory data output[63:32].

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the FLASH1_DOUT_1 Register bit assignments.

Table 3-140 FLASH1_DOUT_1 Register bit assignments

Bits	Name	Function
[31:0]	SCC_FLASH1_DOUT1	eFlash 1 data output[63:32]. Reset value 0xFFFF_FFFF.

FLASH1_DOUT_2 Register

The FLASH1_DOUT_2 Register characteristics are:

Purpose

eFlash 1 memory data output[95:64].

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the FLASH1_DOUT_2 Register bit assignments.

Table 3-141 FLASH1_DOUT_2 Register bit assignments

Bits	Name	Function
[31:0]	SCC_FLASH1_DOUT2	eFlash 1 data output[95:64]. Reset value 0xFFFF_FFFF.

FLASH1_DOUT_3 Register

The FLASH1_DOUT_3 Register characteristics are:

Purpose

eFlash 1 memory data output[127:96].

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the FLASH1_DOUT_3 Register bit assignments.

Table 3-142 FLASH1_DOUT_3 Register bit assignments

Bits	Name	Function
[31:0]	SCC_FLASH1_DOUT3	eFlash 1 data output[127:96]. Reset value 0xFFFF_FFFF.

SELECTION_CONTROL_REG Register

The SELECTION_CONTROL_REG Register characteristics are:

Purpose

Controls clock phase shift control signals.

Usage constraints

There are no usage register read or write constraints.

Note

Arm recommends that you do not alter the default values during normal operation.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the SELECTION_CONTROL_REG Register bit assignments.

Table 3-143 SELECTION_CONTROL_REG Register bit assignments

Bits	Name	Function
[31:10]	-	Reserved.
[9:8]	SDIO_MASK_DELAY	SDIO mask delay: 0b00: Mask one clock cycle. 0b01: Mask two clock cycles. 0b10: Mask three clock cycles. 0b11: Mask four clock cycles. Reset value 0b10.
[7:3]	-	Reserved.
[2]	CLOCK_PHASE_SHIFTER_BYPASS	QSPI input clock phase shift control: 0b0: Clock phase shift activated. 0b1: Clock phase shift is bypassed and clock delayed is selected from the pad SCLK_OUT. Reset value 0b0.
[1:0]	CLOCK_PHASE_SHIFTER_SELECT	QSPI input clock phase shift control: 0b00: No phase shift. 0b01: 90° phase shift. 0b10: 180° phase shift. 0b11: 270° phase shift. Reset value 0b00.

AZ_ROM_REMAP_MASK Register

The AZ_ROM_REMAP_MASK Register characteristics are:

Purpose

CryptoIsland-300 ROM remap mask.

See [3.11 CryptoIsland-300 remap at Musca-B1 test chip level](#) on page 3-124 and [2.7 CryptoCell-312 and CryptoIsland-300 subsystems](#) on page 2-36.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the AZ_ROM_REMAP_MASK Register bit assignments.

Table 3-144 AZ_ROM_REMAP_MASK Register bit assignments

Bits	Name	Function
[31:0]	AZ_ROM_REMAP_MASK	CryptoIsland-300 ROM remap mask. Reset value 0x0001_FFFF.

Related information

[3.11 CryptoIsland-300 remap at Musca-B1 test chip level on page 3-124](#)

AZ_ROM_REMAP_OFFSET Register

The AZ_ROM_REMAP_OFFSET Register characteristics are:

Purpose

CryptoIsland-300 ROM remap offset.

See [3.11 CryptoIsland-300 remap at Musca-B1 test chip level on page 3-124](#) and [2.7 CryptoCell-312 and CryptoIsland-300 subsystems on page 2-36](#).

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the AZ_ROM_REMAP_OFFSET Register bit assignments.

Table 3-145 AZ_ROM_REMAP_OFFSET Register bit assignments

Bits	Name	Function
[31:0]	AZ_ROM_REMAP_OFFSET	CryptoIsland-300 ROM remap offset. Reset value 0x1A20_0000.

Related information

[3.11 CryptoIsland-300 remap at Musca-B1 test chip level on page 3-124](#)

AZ_CODE_REMAP_MASK Register

The AZ_CODE_REMAP_MASK Register characteristics are:

Purpose

CryptoIsland-300 code remap mask.

See [3.11 CryptoIsland-300 remap at Musca-B1 test chip level on page 3-124](#) and [2.7 CryptoCell-312 and CryptoIsland-300 subsystems on page 2-36](#).

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the AZ_ROM_REMAP_MASK bit assignments.

Table 3-146 AZ_CODE_REMAP_MASK Register bit assignments

Bits	Name	Function
[31:0]	AZ_CODE_REMAP_MASK	CryptoIsland-300 code remap mask. Reset value 0x00FF_FFFF.

Related information

[3.11 CryptoIsland-300 remap at Musca-B1 test chip level on page 3-124](#)

AZ_CODE_REMAP_OFFSET Register

The AZ_CODE_REMAP_OFFSET Register characteristics are:

Purpose

CryptoIsland-300 code remap offset.

See [3.11 CryptoIsland-300 remap at Musca-B1 test chip level on page 3-124](#) and [2.7 CryptoCell-312 and CryptoIsland-300 subsystems on page 2-36](#).

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the AZ_CODE_REMAP_OFFSET Register bit assignments.

Table 3-147 AZ_CODE_REMAP_OFFSET Register bit assignments

Bits	Name	Function
[31:0]	AZ_CODE_REMAP_OFFSET	CryptoIsland-300 code remap offset. Reset value 0x0000_0000.

Related information

[3.11 CryptoIsland-300 remap at Musca-B1 test chip level on page 3-124](#)

AZ_SYS_REMAP_MASK Register

The AZ_SYS_REMAP_MASK Register characteristics are:

Purpose

CryptoIsland-300 system remap mask.

See [3.11 CryptoIsland-300 remap at Musca-B1 test chip level on page 3-124](#) and [2.7 CryptoCell-312 and CryptoIsland-300 subsystems on page 2-36](#).

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the AZ_SYS_REMAP_MASK Register bit assignments.

Table 3-148 AZ_SYS_REMAP_MASK Register bit assignments

Bits	Name	Function
[31:0]	AZ_SYS_REMAP_MASK	CryptoIsland-300 system remap mask. Reset value 0x0003_FFFF.

Related information

[3.11 CryptoIsland-300 remap at Musca-B1 test chip level on page 3-124](#)

AZ_SYS_REMAP_OFFSET Register

The AZ_SYS_REMAP_OFFSET Register characteristics are:

Purpose

CryptoIsland-300 system remap offset.

See [3.11 CryptoIsland-300 remap at Musca-B1 test chip level on page 3-124](#) and [2.7 CryptoCell-312 and CryptoIsland-300 subsystems on page 2-36](#).

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the AZ_SYS_REMAP_OFFSET Register bit assignments.

Table 3-149 AZ_SYS_REMAP_OFFSET Register bit assignments

Bits	Name	Function
[31:0]	AZ_SYS_REMAP_OFFSET	CryptoIsland-300 system remap offset. Reset value 0x4001_0000.

Related information

[3.11 CryptoIsland-300 remap at Musca-B1 test chip level on page 3-124](#)

AZ_CTRL Register

The AZ_CTRL Register characteristics are:

Purpose

CryptoIsland-300 control register.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the AZ_CTRL Register bit assignments.

Table 3-150 AZ_CTRL Register bit assignments

Bits	Name	Function
[31:12]	-	Reserved.
[11]	SCC_PSI_FEATURE_EN_SEL	Select PSI_FEATURE_EN source: 0b0: Select PSI_FEATURE_EN value from SCC. 0b1: Select PSI_FEATURE_EN[18] value from CryptoIsland-300. Reset value 0b0.

Table 3-150 AZ_CTRL Register bit assignments (continued)

Bits	Name	Function
[10]	SCC_PSI_FEATURE_EN	Value of SCC_PSI_FEATURE_EN from SCC. Reset value 0b1.
[9]	SCC_nPORESETAON_nPORESET_SEL	CryptoIsland-300 reset control: 0b0: CryptoIsland-300 resets, HOST0HRESETn , HOST1HRESETn , PORESETn , are set to nPORESET . 0b1: CryptoIsland-300 resets, HOST0HRESETn , HOST1HRESETn , PORESETn , are set to nPORESETAON . Reset value 0b1.
[8]	HRESETn	CryptoIsland-300 reset HRESETn : 0b0: Reset. 0b1: Not reset. Reset value 0b0.
[7]	DBGRESETn	CryptoIsland-300 reset DBGRESETn : 0b0: Reset. 0b1: Not reset. Reset value 0b0.
[6:4]	-	Reserved.
[3]	REMOVE_GHASH_ENGINE	CryptoIsland-300 CryptoCell remove Ghash engine: 0b0: Not remove Ghash engine. 0b1: Remove Ghash engine. Reset value 0b0.
[2]	REMOVE_CHACHA_ENGINE	CryptoIsland-300 CryptoCell remove CHACHA engine: 0b0: Not remove Ghash engine. 0b1: Remove Ghash engine. Reset value 0b0.

Table 3-150 AZ_CTRL Register bit assignments (continued)

Bits	Name	Function
[1]	CPUWAIT	CryptoIsland-300 CPU wait at boot: 0b0: Not wait at boot. 0b1: Wait at boot. Reset value 0b0.
[0]	AZ_BOOT_REMAP	CryptoIsland-300 remap at boot: 0b0: No remap, boot from internal CryptoIsland-300 ROM. 0b1: Remap. External boot. Boot location set in SCC remap registers. Reset value 0b0.

SSE200_OTP_RD_DATA Register

The SSE200_OTP_RD_DATA Register characteristics are:

Purpose

SSE-200 OTP read data.

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the SSE200_OTP_RD_DATA Register bit assignments.

Table 3-151 SSE200_OTP_RD_DATA Register bit assignments

Bits	Name	Function
[31:0]	SSE_OTP_RD_DATA	SSE-200 OTP read data. Reset value 0x0000_0000.

AZ_OTP_RD_DATA Register

The AZ_OTP_RD_DATA Register characteristics are:

Purpose

CryptoIsland-300 OTP read data.

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.12.2 SCC registers summary on page 3-130](#).

The following table shows the AZ_OTP_RD_DATA Register bit assignments.

Table 3-152 AZ_OTP_RD_DATA Register bit assignments

Bits	Name	Function
[31:0]	AZ_OTP_RD_DATA	CryptoIsland-300 OTP read data. Reset value 0x0000_0000.

SPARE_CTRL0 Register

The SPARE_CTRL0 Register characteristics are:

Purpose

Spare control register.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the SPARE_CTRL0 Register bit assignments.

Table 3-153 SPARE_CTRL0 Register bit assignments

Bits	Name	Function
[31:0]	SPARE_CTRL0	Spare control register. Software assigns the bit meanings. Reset value 0x0000_0000.

SPARE_CTRL1 Register

The SPARE_CTRL1 Register characteristics are:

Purpose

Spare control register.

Usage constraints

There are no usage constraints.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the SPARE_CTRL1 Register bit assignments.

Table 3-154 SPARE_CTRL1 Register bit assignments

Bits	Name	Function
[31:0]	SPARE_CTRL1	Spare control register. Software assigns the bit meanings. Reset value 0x0000_0000.

CHIP_ID Register

The CHIP_ID Register characteristics are:

Purpose

Stores component identification information.

Usage constraints

This register is read-only.

Memory offset and full register reset value

See [3.12.2 SCC registers summary](#) on page 3-130.

The following table shows the CHIP_ID Register bit assignments.

Table 3-155 CHIP_ID Register bit assignments

Bits	Name	Function
[31:0]	CHIP_ID	Component ID information. The value in the Musca-B1 test chip is 0x07D0_0477.

3.13 UART control registers

The Musca-B1 test chip contains registers that control the two UARTs, UART0 and UART1.

The base memory addresses of UART0 are:

- 0x4010_5000 in the Non-secure region.
- 0x5010_5000 in the Secure region.

The base memory addresses of UART1 are:

- 0x4010_6000 in the Non-secure region.
- 0x5010_6000 in the Secure region.

See the *PrimeCell UART (PL011) Technical Reference Manual*.

Note

The UART on the Musca-B1 test chip does not support hardware flow control.

The following table shows the UART0 and UART1 control registers in address offset order from the base memory address. Undefined registers are reserved. Software must not attempt to access these registers.

Table 3-156 UART control registers summary

Offset	Name	Type	Reset value	Width	Function
0x0000	UART0DR	RW	-	32	Data Register.
0x0004	UART0RSR/UART0ECR	RW	0x0000_0000	32	Receive Status Register/Error Clear Register.
0x0018	UART0FR	RO	0x0000_0012	32	Flag Register.
0x0020	UART0ILPR	RW	0x0000_0000	32	IrDA Low-Power Counter Register.
0x0024	UART0IBRD	RW	0x0000_0000	32	Integer Baud Rate Register.
0x0028	UART0FBRD	RW	0x0000_0000	32	Fractional Baud Rate Register.
0x002C	UART0LCR_H	RW	0x0000_0000	32	Line Control Register.
0x0030	UART0CR	RW	0x0000_0300	32	Control Register.
0x0034	UART0IFLS	RW	0x0000_0012	32	Interrupt FIFO Level Select Register.
0x0038	UART0IMSC	RW	0x0000_0000	32	Interrupt Mask Set/Clear Register.
0x003C	UART0RIS	RO	0x0000_0000	32	Raw Interrupt Status Register.
0x0040	UART0MIS	RO	0x0000_0000	32	Masked Interrupt Status Register.
0x0044	UART0ICR	WO	-	32	Interrupt Clear Register.
0x0048	UART0DMACR	RW	0x0000_0000	32	DMA Control Register.
0x0FE0	UART0PeriphID0	RO	0x0000_0011	32	UART0 peripheral ID Register 0.
0x0FE4	UART0PeriphID1	RO	0x0000_0010	32	UART0 peripheral ID Register 1.
0x0FE8	UART0PeriphID2	RO	0x0000_0004	32	UART0 peripheral ID Register 2.

Table 3-156 UART control registers summary (continued)

Offset	Name	Type	Reset value	Width	Function
0x0FEC	UART0PeriphID3	RO	0x0000_0000	32	UART0 peripheral ID Register 3.
0x0FF0	UART0PCellID0	RO	0x0000_000D	32	UART0 component ID Register 0.
0x0FF4	UART0PCellID1	RO	0x0000_00F0	32	UART0 component ID Register 1.
0x0FF8	UART0PCellID2	RO	0x0000_0005	32	UART0 component ID Register 2.
0x0FFC	UART0PCellID3	RO	0x0000_00B1	32	UART0 component ID Register 3.
0x1000	UART1DR	RW	-	32	Data Register.
0x1004	UART1RSR/UART1ECR	RW	0x0000_0000	32	Receive Status Register/Error Clear Register.
0x1018	UART1FR	RO	0x0000_0012	32	Flag Register.
0x1020	UART1ILPR	RW	0x0000_0000	32	IrDA Low Power Counter Register.
0x1024	UART1IBRD	RW	0x0000_0000	32	Integer Baud Rate Register.
0x1028	UART1FBRD	RW	0x0000_0000	32	Fractional Baud Rate Register.
0x102C	UART1LCR_H	RW	0x0000_0000	32	Line Control Register.
0x1030	UART1CR	RW	0x0000_0300	32	Control Register.
0x1034	UART1IFLS	RW	0x0000_0012	32	Interrupt FIFO Level Select Register.
0x1038	UART1IMSC	RW	0x0000_0000	32	Interrupt Mask Set/Clear Register.
0x103C	UART1IRIS	RO	0x0000_0000	32	Raw Interrupt Status Register.
0x1040	UART1MIS	RO	0x0000_0000	32	Masked Interrupt Status Register.
0x1044	UART1ICR	WO	-	32	Interrupt Clear Register.
0x1048	UART1DMACR	RW	0x0000_0000	32	DMA Control Register.
0x1FE0	UART1PeriphID0	RO	0x0000_0011	32	UART1 peripheral ID Register 0.
0x1FE4	UART1PeriphID1	RO	0x0000_0010	32	UART1 peripheral ID Register 1.
0x1FE8	UART1PeriphID2	RO	0x0000_0004	32	UART1 peripheral ID Register 2.
0x1FEC	UART1PeriphID3	RO	0x0000_0000	32	UART1 peripheral ID Register 3.
0x1FF0	UART1PCellID0	RO	0x0000_000D	32	UART1 component ID Register 0.
0x1FF4	UART1PCellID1	RO	0x0000_00F0	32	UART1 component ID Register 1.
0x1FF8	UART1PCellID2	RO	0x0000_0005	32	UART1 component ID Register 2.
0x1FFC	UART1PCellID3	RO	0x0000_00B1	32	UART1 component ID Register 3.

3.14 GPIO control registers

The Musca-B1 test chip implements GPIO registers which control the GPIO interface.

Bits [15:0] control the Musca-B1 test chip I/O to the Arduino Expansion Shield interface. Bits [31:16] are reserved.

The base memory addresses of the GPIO control registers is:

- 0x5100_0000 in the Secure region.

Note

GPIO can only be accessed by Secure Privileged access. Non-secure privileged access is not possible.

See the *Arm® Cortex®-M System Design Kit Technical Reference Manual*.

The following table shows the GPIO control registers in the Musca-B1 test chip in address offset order from the base memory address. Undefined registers are reserved. Software must not attempt to access these registers.

Table 3-157 GPIO control registers summary

Offset	Name	Type	Reset	Width	Function
0x0000	GPIODATA	RW	0x0000_0000	32	Data value. Bits [31:16] are reserved.
0x0004	GPIODATAOUT	RW	0x0000_0000	32	Data output value. Bits [31:16] are reserved.
0x0010	GPIOUTENSET	RW	0x0000_0000	32	Output enable set. Bits [31:16] are reserved.
0x0014	GPIOUTENCLR	RW	0x0000_0000	32	Output enable clear. Bits [31:16] are reserved.
0x0020	GPIOINTENSET	RW	0x0000_0000	32	Interrupt enable set. Bits [31:16] are reserved.
0x0024	GPIOINTENCLR	RW	0x0000_0000	32	Interrupt enable clear. Bits [31:16] are reserved.
0x0028	GPIOINTTYPESET	RW	0x0000_0000	32	Interrupt type set. Bits [31:16] are reserved.
0x002C	GPIOINTTYPECLR	RW	0x0000_0000	32	Interrupt type clear. Bits [31:16] are reserved.
0x0030	GPIOINTPOLSET	RW	0x0000_0000	32	Polarity-level, edge IRQ configuration. Set interrupt polarity bit. Bits [31:16] are reserved.
0x0034	GPIOINTPOLCLR	RW	0x0000_0000	32	Polarity-level, edge IRQ configuration. Clear interrupt polarity bit. Bits [31:16] are reserved.

Table 3-157 GPIO control registers summary (continued)

Offset	Name	Type	Reset	Width	Function
0x0038	GPIOINTSTATUS INTCLEAR	RW	0x0000_0000	32	Clear interrupt request. Bits [31:16] are reserved.
0x0FD0	GPIOPID4	RW	0x0000_0000	32	Peripheral ID Register 4. Bits [31:8] are reserved.
0x0FE0	GPIOPID0	RW	0x0000_0000	32	Peripheral ID Register 0. Bits [31:8] are reserved.
0x0FE4	GPIOPID1	RW	0x0000_0000	32	Peripheral ID Register 1. Bits [31:8] are reserved.
0x0FE8	GPIOPID2	RW	0x0000_0000	32	Peripheral ID Register 2. Bits [31:8] are reserved.
0x0FEC	GPIOPID3	RW	0x0000_0000	32	Peripheral ID Register 3. Bits [31:8] are reserved.
0x0FF0	GPIOCID0	RW	0x0000_0000	32	Component ID Register 0. Bits [31:8] are reserved.
0x0FF4	GPIOCID1	RW	0x0000_0000	32	Component ID Register 1. Bits [31:8] are reserved.
0x0FF8	GPIOCID2	RW	0x0000_0000	32	Component ID Register 2. Bits [31:8] are reserved.
0x0FFC	GPIOCID3	RW	0x0000_0000	32	Component ID Register 3. Bits [31:8] are reserved.

3.15 Third-party IP

The Musca-B1 test chip implements third-party IP, including control registers.

The Musca-B1 test chip implements the following Cadence IP:

- QSPI controller (IP6514E), no DMA support:
 - Base memory address 0x4280_0000 in the Non-secure region.
 - Base memory address 0x5280_0000 in the Secure region.
- I²C interface (IP6510), master only:
 - I2C0: Base memory address 0x4010_8000 in the Non-secure region.
 - I2C0: Base memory address 0x5010_8000 in the Secure region.
 - I2C1: Base memory address 0x4010_9000 in the Non-secure region.
 - I2C1: Base memory address 0x5010_9000 in the Secure region.
- I²S-MT/MR controller (IP6718E), three channels, master only:
 - Base memory address 0x4010_4000 in the Non-secure region.
 - Base memory address 0x5010_4000 in the Secure region.
- Pulse Width Modulator IP (IP6512):
 - PWM0: Base memory address 0x4010_1000 in the Non-secure region.
 - PWM0: Base memory address 0x5010_1000 in the Secure region.
 - PWM1: Base memory address 0x4010_2000 in the Non-secure region.
 - PWM1: Base memory address 0x5010_2000 in the Secure region.
 - PWM2: Base memory address 0x4010_3000 in the Non-secure region.
 - PWM2: Base memory address 0x5010_3000 in the Secure region.
- SPI master interface (IP6524), master only:
 - Base memory address 0x4010_A000 in the Non-secure region.
 - Base memory address 0x5010_A000 in the Secure region.
- SDIO interface (IP6040), no DMA support:
 - Base memory address 0x4010_F000 in the Non-secure region.
 - Base memory address 0x5010_F000 in the Secure region.

Contact your local Cadence representative for information about the QSPI, I2C, I2S, PWM, SPI, and SDIO blocks.

Appendix A

Signal descriptions

This appendix describes the signals that are present at the board interface connectors.

It contains the following sections:

- [*A.1 Arduino Expansion Shield connectors on page Appx-A-200.*](#)
- [*A.2 Debug connector on page Appx-A-203.*](#)
- [*A.3 USB connector on page Appx-A-204.*](#)

A.1 Arduino Expansion Shield connectors

Connectors on the Musca-B1 board provide one Shield expansion interface. The interface provides 16 digital I/O and six analog I/O. The digital and analog I/O operating voltage is 3V3.

Arduino Shield interface

The following figure shows the Arduino Shield interface connectors.

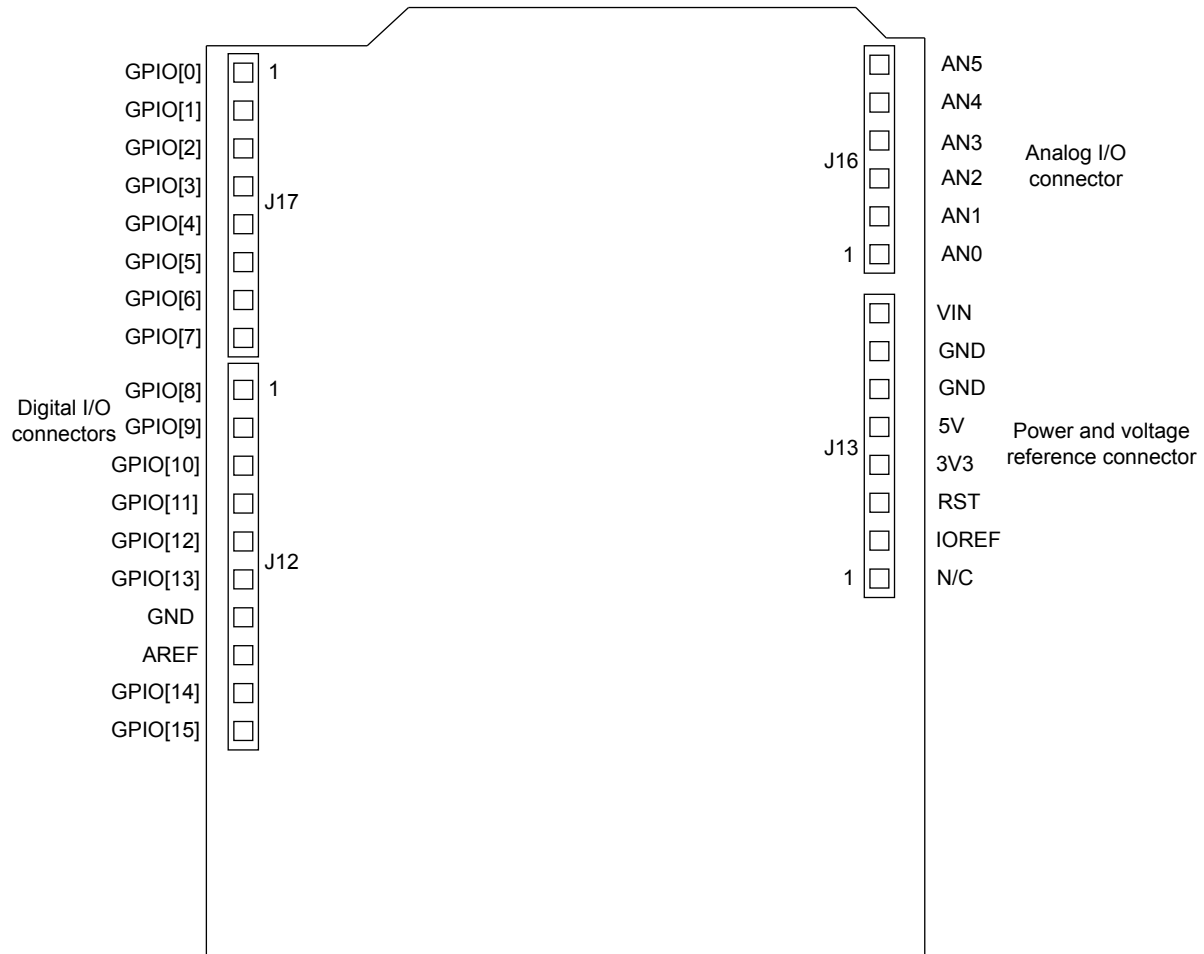


Figure A-1 Arduino Shield interface connectors

Digital I/O connectors, J12, J17

Connector J12 provides Shield digital I/O GPIO[15:8], and connector J17 provides Shield digital I/O GPIO[7:0]. Connector J12 also provides the analog I/O reference voltage.

The IOMUX registers select one of the Shield interface GPIO pin functions sets, ALTF1, ALTF2, or ALTF3. The IOMUX registers are part of the *Serial Configuration Control* (SCC) registers. See [3.12.1 IOMUX registers on page 3-126](#) and [2.2.2 Test chip multiplexed I/O on page 2-23](#).

The following table shows the pin mappings for connector J12.

Table A-1 Shield digital I/O connector J12 signal list

Pin	Primary reset or powerup	ALTF1	ALTF2	ALTF3
1	GPIO[8]	MT_I2S_WS1	Reserved	Reserved
2	GPIO[9]	MT_I2S_SCK		
3	GPIO[10]	SPI0 nSS0		
4	GPIO[11]	SPI0 MOSI		
5	GPIO[12]	SPI0 MISO		
6	GPIO[13]	SPI0 SCK	TEST_CLK	
7	GND	GND	Reserved	
8	N/C	N/C		
9	GPIO[14]	I2C0 Data (SDA)		
10	GPIO[15]	I2C0 Clock (SCL)		

The following table shows the pin mappings for connector J17.

Table A-2 Shield digital I/O connector J17 signal list

Pin	Primary reset or powerup	ALTF1	ALTF2	ALTF3
1	GPIO[0]	UART0 RxD	Reserved	Reserved
2	GPIO[1]	UART0 TxD		
3	GPIO[2]	MR_I2S_SD	PWM0	
4	GPIO[3]	MR_I2S_WS	PWM1	
5	GPIO[4]	MR_I2S_SCK	PWM2	
6	GPIO[5]	MT_I2S_SD0	Reserved	
7	GPIO[6]	MT_I2S_WS0		
8	GPIO[7]	MT_I2S_SD1		

Shield analog I/O connector J16

Connector J16 provides six analog I/O for the Arduino Expansion Shield.

The following table shows the pin mapping for connector J16.

Table A-3 Analog I/O connector J16 signal list

Pin	Signal
1	AN[0]
2	AN[1]
3	AN[2]
4	AN[3]

Table A-3 Analog I/O connector J16 signal list (continued)

Pin	Signal
5	AN[4]
6	AN[5]

Shield power and voltage reference connector J13.

Connector J13 provides power and voltage references for the Arduino Expansion Shield.

The following table shows the pin mapping for connector J13.

Table A-4 Shield power and voltage reference connector J13 signal list

Pin	Signal
1	N/C
2	IOREF
3	CB_nRST
4	3V3
5	5V
6	GND
7	GND
8	VIN

Related information

1.3 Location of components on page 1-14

2.12 Arduino Expansion Shield interface on page 2-42

A.2 Debug connector

The Musca-B1 board provides one 3V3 20-pin debug connector. The connector supports P-JTAG processor debug to enable connection of DSTREAM or a compatible third-party debugger. The connector also supports *Serial Wire Debug* (SWD) and 4-bit trace.

The following figure shows the 20-pin debug connector, J8.

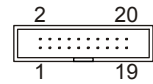


Figure A-2 Debug connector

The following table shows the pin mapping for the P-JTAG, SWD, and 4-bit trace signals on the debug connector.

Table A-5 Debug connector, J8, pin mapping

Pin	Signal	Pin	Signal
1	3V3	2	SWDIOTMS
3	GND	4	SWDCLKTCK
5	GND	6	SWOTDOEXTa
7	N/C	8	NC/TDIEXTb
9	GNDDETECT	10	nSRST
11	N/C	12	TRACECLK
13	N/C	14	TRACEDATA[0]
15	GND	16	TRACEDATA[1]
17	GND	18	TRACEDATA[2]
19	GND	20	TRACEDATA[3]

Note

- Pins 2, 4, 6, 8, 9, and 10 have pullup resistors to 3V3.
- The trace signals are on multiplexedMusca-B1 test chip I/O pins. The I/O multiplexer must select the correct signals for this function to be available on the debug connector. See [2.2.2 Test chip multiplexed I/O on page 2-23](#) and [3.12.1 IOMUX registers on page 3-126](#) for information on how to select the required functions at the Musca-B1 test chip I/O pins.

Related information

[1.3 Location of components on page 1-14](#)

[2.15 Debug on page 2-46](#)

A.3 USB connector

The Musca-B1 board provides one mini-B USB connector that enables access to the CoreSight block in the Musca-B1 test chip. The connector also enables external 5V power to the board.

The following figure shows the USB connector.

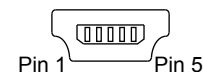


Figure A-3 Mini-B USB connector

The following table shows the pin mapping of the mini-B USB connector.

Table A-6 Mini-B USB connector, J11

Pin	Signal	Pin	Signal
1	5V	2	DATA-
3	DATA+	4	ID
5	GND	6	GND_EARTH

Note

The **GND_EARTH** connection is the casing of the mini-B connector.

Related information

[1.3 Location of components on page 1-14](#)

[2.9 Power on page 2-38](#)

Appendix B

Specifications

This appendix contains electrical specifications of the Musca-B1 board.

It contains the following section:

- [*B.1 Electrical specifications on page Appx-B-206.*](#)

B.1 Electrical specifications

The electrical specifications of the Musca-B1 board are as follows:

See [2.9 Power on page 2-38](#) for information on the Musca-B1 board power supply rails and maximum current loads.

Appendix C

Revisions

This appendix describes the technical changes between released issues of this book.

It contains the following section:

- [C.1 Revisions](#) on page Appx-C-208.

C.1 Revisions

The following table lists the technical changes between released issues of this book.

Table C-1 Issue 101312_0000_00

Change	Location	Affects
No changes, first release.	-	-

Table C-2 Differences between issue 101312_0000_00 and issue 101312_0000_01

Change	Location	Affects
Removed some Secure Privilege Control Block registers.	3.4.6 Secure Privilege Control Block on page 3-70	All board versions
Added SCC register PWR_CTRL.	PWR_CTRL Register on page 3-148	All board versions
Updated SCC register AZ_CTRL, marked bits [5:4] as reserved.	AZ_CTRL Register on page 3-189	All board versions
Added caution to <i>Nested Vector Interrupt Controller</i> (NVIC) section.	3.3.5 Interrupts on page 3-60	All board versions
Corrected CPU0 and CPU1 maximum operating frequencies.	2.2.1 Overview of the Musca-B1 test chip on page 2-20 2.6 Clocks on page 2-32 3.3 Processor elements on page 3-58	All board versions
Added CryptoIsland RAM size.	2.2.1 Overview of the Musca-B1 test chip on page 2-20 2.7 CryptoCell-312 and CryptoIsland-300 subsystems on page 2-36	All board versions
Added information on how to update DAPLink firmware from a Linux/Mac OS.	2.3 Software, firmware, board, and tools setup on page 2-27	All board versions